

IMX91CEC

i.MX 91 Application Processors Data Sheet for Commercial Products

Rev. 2 — 12 November 2024

Preliminary Data Sheet

- This document provides electrical specifications for i.MX91.
- For functional characteristics and the programming model, see i.MX91 Applications Processor Reference Manual (IMX91RM).
- This datasheet contains information on a preproduction product. Specifications and information herein are subject to change without notice.



1 i.MX 91 introduction

NXP’s New Secure, Energy-Efficient i.MX 91 Family Expands Linux® Capabilities for Thousands of Edge Applications.

The i.MX 91 applications processor features an Arm® Cortex®-A55 running at up to 1.4 GHz and support for modern LPDDR4 memory to enable platform longevity and reliability; dual Gigabit Ethernet for gateway or multi-network segment support; dual USB ports; and the essential I/O for products in smart factory, smart home, smart office, medical device, metering, and cost-optimized system-on-module platforms.

The i.MX 91 may be used in applications such as:

- EV Charging
- Matter-enabled IoT Platforms
- Smart Home, Office, and City
- Building Automation and Monitoring
- Industrial Monitoring and HMI
- Portable or small form-factor Medical and Healthcare devices
- Audio and Entertainment IoT

Table 1. Features

Subsystem	Features
Cortex®-A55 platform	One Cortex®-A55 processor operating at up to 1.4 GHz <ul style="list-style-type: none"> • 32 KB L1 Instruction Cache • 32 KB L1 Data Cache • 256 KB L2 cache • Media Processing Engine (MPE) with Arm® Neon™ technology supporting the Advanced Single Instruction Multiple Data architecture • Floating Point Unit (FPU) with support of the Arm® VFPv4-D16 architecture
	Supports of 64-bit Arm® v8.2-A architecture
	Parity/ECC protection on L1 cache, L2 cache, and TLB RAMs
Image Sensor Interface (ISI)	<ul style="list-style-type: none"> • Standard pixel formats commonly used in many camera input protocols • Programmable resolutions up to 2K • Image processing for: <ul style="list-style-type: none"> — Supports one source of up to 2K horizontal resolution — Supports pixel rate up to 200 Mpixel/s • Image down scaling via decimation and bi-phase filtering • Color space conversion • Interlaced to progressive conversions
On-chip memory	Boot ROM (256 KB) for Cortex®-A55
	On-chip RAM (384 KB)

Table continues on the next page...

Table 1. Features...continued

Subsystem	Features
External memory interface	16-bit DRAM interface support at up to : <ul style="list-style-type: none"> • LPDDR4 with inline ECC
	Three Ultra Secure Digital Host Controller (uSDHC) interfaces: <ul style="list-style-type: none"> • One eMMC 5.1 (8-bit) compliance with HS400 DDR signaling to support up to 400 MB/sec • One SDXC (4-bit, no eMMC 5.1, with extended capacity) • One SDIO (4-bit, SD/SDIO 3.01 compliance with 200 MHz SDR signaling and up to 100 MB/sec)
	FlexSPI Flash with support for XIP (for Cortex [®] -A55 in low-power mode) and support for either one Octal SPI or Quad SPI FLASH device. It also supports both Serial NOR and Serial NAND flash using the FlexSPI.
GPIO and input/output multiplexing	General-purpose input/output (GPIO) modules with interrupt capability
	Input/output multiplexing controller (IOMUXC) to provide centralized pad control
Power management	Temperature sensor with programmable trip points
	Flexible power domain partitioning with internal power switches to support efficient power management
Security	Trusted Resource Domain Controller (TRDC) <ul style="list-style-type: none"> • Supports 16 domains
	Arm [®] TrustZone [®] (TZ) architecture, including both TrustZone-A
	On-chip RAM (OCRAM) secure region protection using OCRAM controller
	EdgeLock [®] secure enclave
	Battery Backed Security Module (BBSM) <ul style="list-style-type: none"> • Secure Non-Volatile Storage (SNVS) • Secure real-time clock (RTC)
System debug	Arm [®] CoreSight [™] debug and trace technology
	Embedded Trace FIFO (ETF) with 4 KB internal storage to provide trace buffering
	Unified trace capability for single core Cortex [®] -A55
	Cross Triggering Interface (CTI)
	Support for 4-pin (JTAG) debug interface and SWD

1.1 Ordering information

Table 2 provides examples of orderable part numbers covered by this Data Sheet.

Table 2. Ordering information

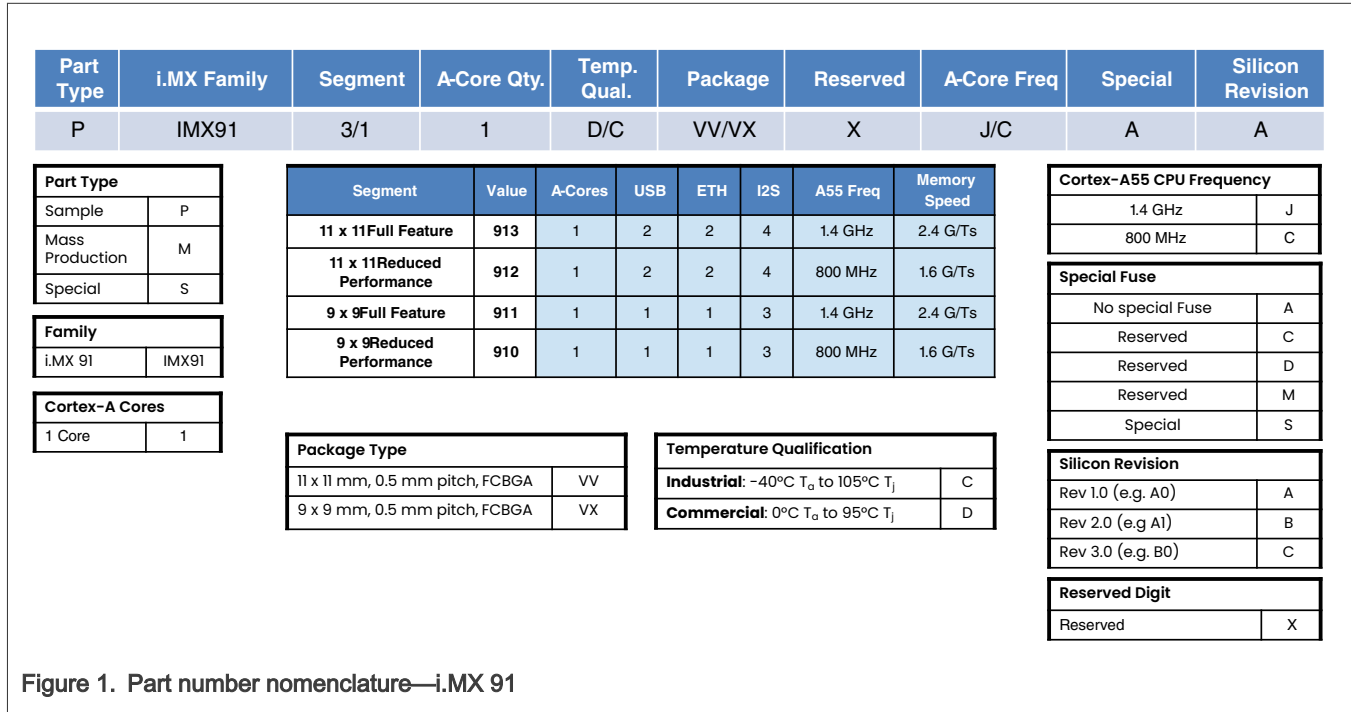
Part number	Sub-Family	Cortex® - A55 CPU speed grade	Memory speed	Qualification type	Temperature Tj ¹	USB	ETH	I2S	Package
MIMX9131DVVX JAA	3	1.4 GHz	2.4 G/Ts	Commercial	0 to 95 °C	2	2	4	11 x 11 mm, 0.5 mm pitch, FCBGA
MIMX9121DVVX CAA ²	2	800 MHz	1.6 G/Ts	Commercial	0 to 95 °C	2	2	4	11 x 11 mm, 0.5 mm pitch, FCBGA
MIMX9111DVXX JAA	1	1.4 GHz	2.4 G/Ts	Commercial	0 to 95 °C	1	1	3	9 x 9 mm, 0.5 mm pitch, FCBGA
MIMX9101DVXX CAA ²	0	800 MHz	1.6 G/Ts	Commercial	0 to 95 °C	1	1	3	9 x 9 mm, 0.5 mm pitch, FCBGA

1. Tj minimum temperature supported at startup and standby tests where Tj = Ta
2. Only support Low Drive mode, up to 800 MHz

Figure 1 describes the part number nomenclature so that characteristics of a specific part number can be identified (for example, cores, frequency, temperature grade, fuse options, and silicon revision). The primary characteristic which describes which data sheet applies to a specific part is the temperature grade (junction) field.

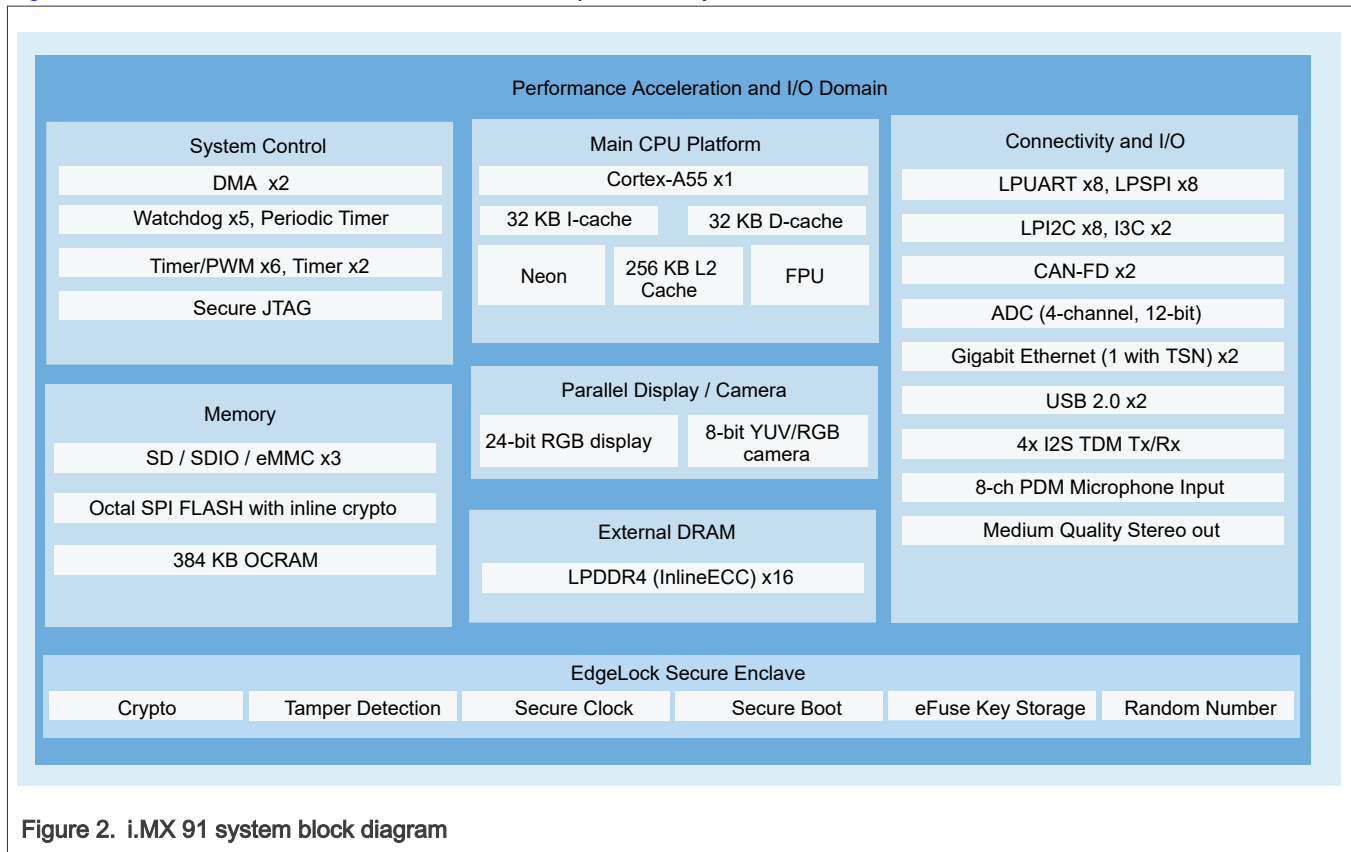
- The i.MX 91 Processors for Commercial Products Data Sheet (IMX91CEC) covers parts listed with a "D (Commercial temp)"
- The i.MX 91 Processors for Industrial Products Data Sheet (IMX91IEC) covers parts listed with a "C (Industrial temp)"

Ensure to have the proper data sheet for specific part by verifying the temperature grade (junction) field and matching it to the proper data sheet. If there are any questions, visit the web page nxp.com/IMX or contact an NXP representative for details.



2 System block diagram

Figure 2 shows the functional modules in the i.MX 91 processor system



NOTE

Some modules shown in this block diagram are not offered on all derivatives. This block diagram may also show less modules than available in some derivatives. See [Table 2](#) for details.

3 Special signal considerations

[Table 3](#) lists special signal considerations for the i.MX 91 processors. The signal names are listed in alphabetical order.

The package contact assignments can be found in [Package information and contact assignments](#). Signal descriptions are provided in the *i.MX 91 Reference Manual* (IMX91RM).

Table 3. Special signal considerations

Signal Name	Remarks
CLKIN1/CLKIN2	CLKIN1 and CLKIN2 are input pins without internal pull-up and pull-down. An external 10K pull-down resistor is recommended if they are not used.
NC	These signals are No Connect (NC) and should be unconnected in the application.
ONOFF	A brief connection to GND in the OFF mode causes the internal power management state machine to change the state to ON. In the ON mode, a brief connection to GND generates an interrupt (intended to be a software-controllable power-down). Approximately five seconds (or more) to GND causes a forced OFF.
POR_B	POR_B has no internal pull-up/down resistor, and requires external pull-up resistor to NVCC_BBSM_1P8. It is recommended that POR_B is properly handled during power up/down. Please refer to the EVK design for details.
RTC_XTALI/RTC_XTALO	To hit the exact oscillation frequency, the board capacitors must be reduced to account for the board and chip parasitics. The integrated oscillation amplifier is self-biasing, but relatively weak. Care must be taken to limit the parasitic leakage from RTC_XTALI and RTC_XTALO to either the power or the ground (> 100 MΩ). This de-biases the amplifier and reduces the start-up margin. If you want to feed an external low-frequency clock into RTC_XTALI, the RTC_XTALO pin must remain unconnected or driven by a complementary signal. The logic level of this forcing clock must not exceed the NVCC_BBSM_1P8 level and the frequency shall be < 50 kHz under the typical conditions.
XTALI_24M/XTALO_24M	The system requires 24 MHz on XTALI/XTALO. The crystal cannot be eliminated by the external 24 MHz oscillator. The logic level of this forcing clock must not exceed the VDD_ANA0_1P8 level. If this clock is used as a reference for USB, then there are strict frequency tolerance and jitter requirements. See On-chip oscillators and relevant interface specifications chapters for details.

3.1 Unused input and output guidance

If a function of the i.MX 91 is not used, the I/Os and power rails of that function can be terminated to reduce overall board power. [Table 4](#) is recommended connectivities for digital I/Os. [Table 5](#) is recommended connectivities for USB.

Table 4. Unused function strapping recommendations

Function	Ball name	Recommendations if unused
ADC	ADC_IN0, ADC_IN1, ADC_IN2, ADC_IN3	Tie to ground
TAMPER	TAMPER0, TAMPER1	Tie to ground
Digital I/O supplies	NVCC_GPIO, NVCC_WAKEUP, NVCC_AON, NVCC_SD2	Tie to ground through 10 KΩ resistors if entire bank is not used

Table 5. USB strapping recommendations

Function	Ball name	Recommendations
USB1 used	VDD_USB_3P3, VDD_USB_1P8, VDD_USB_0P8	Supply
	USB2_VBUS, USB2_D_P, USB2_D_N, USB2_ID, USB2_TXRTUNE	Not connected
USB2 used	VDD_USB_3P3, VDD_USB_1P8, VDD_USB_0P8	Supply
	USB1_VBUS, USB1_D_P, USB1_D_N, USB1_ID, USB1_TXRTUNE	Not connected
Neither USB1 nor USB2 used	VDD_USB_3P3, VDD_USB_1P8, VDD_USB_0P8	Tie to ground
	USB1_VBUS, USB1_D_P, USB1_D_N, USB1_ID, USB1_TXRTUNE	Not connected
	USB2_VBUS, USB2_D_P, USB2_D_N, USB2_ID, USB2_TXRTUNE	Not connected

4 Electrical characteristics

This section provides the device and module-level electrical characteristics for the i.MX 91 family of processors.

4.1 Chip-level conditions

This section provides the device-level electrical characteristics for the IC. See [Chip-level conditions](#) for a quick reference to the individual tables and sections.

Table 6. i.MX 91 chip-level conditions

For these characteristics, ...	Topic appears ...
Absolute maximum ratings	See Absolute maximum ratings
Thermal resistance	See Thermal resistance
Operating ranges	See Operating ranges
External clock sources	See External clock sources
Maximum supply currents	See Maximum supply currents

Table continues on the next page...

Table 6. i.MX 91 chip-level conditions...continued

For these characteristics, ...	Topic appears ...
Power modes	See Power modes
Power supplies requirements and restrictions	See Power supplies requirements and restrictions

4.1.1 Absolute maximum ratings

CAUTION

Stresses beyond those listed in the following table may reduce the operating lifetime or cause immediate permanent damage to the device. The table below does not imply functional operation beyond those indicated in the operating ranges and parameters table.

Table 7. Absolute maximum ratings

Parameter description	Symbol	Min	Max	Unit	Notes
Core supplies input voltages	VDD_SOC	-0.3	1.15	V	—
GPIO supply voltage	NVCC_GPIO, NVCC_WAKEUP, NVCC_AON	-0.3	3.8	V	—
IO supply for SD2	NVCC_SD2	-0.3	3.8	V	—
DDR PHY supply voltage	VDD2_DDR	-0.3	1.575	V	—
IO supply and IO Pre-driver supply for BBSM bank	NVCC_BBSM_1P8	-0.3	2.15	V	—
BBSM supply voltage	NVCC_BBSM_0P8	-0.3	1.15	V	—
USB VBUS input detected	USB1_VBUS,USB2_VUBS	-0.3	3.95	V	—
Power for USB OTG PHY	VDD_USB_0P8	-0.3	1.15	V	—
	VDD_USB_1P8	-0.3	2.15	V	—
	VDD_USB_3P3	-0.3	3.95	V	—
Analog core supply voltage	VDD_ANAx_0P8	-0.3	1.15	V	¹
	VDD_ANAx_1P8	-0.3	2.15	V	²
Input/output voltage range	V _{in} /V _{out}	-0.3	OVDD ³ + 0.3	V	—
Storage temperature range	T _{STORAGE}	-55	150	°C	—

- VDD_ANAx_0P8 refers to VDD_ANA_0P8 on 11 x 11 mm package, whereas VDD_ANA0_0P8 and VDD_ANA1_0P8 on 9 x 9 mm package.
- VDD_ANAx_1P8 refers to VDD_ANA0_1P8, VDD_ANA1_1P8, and VDD_ANAVDET_1P8.
- OVDD is the I/O supply voltage.

Table 8. Electrostatic discharge and latch-up ratings

Parameter description		Rating	Reference	Comment
Electrostatic Discharge (ESD)	Human Body Model (HBM)	±1000 V	JS-001-2017	—
	Charged Device Model (CDM)	±250 V	JS-002-2018	—
Latch-up (LU)	Immunity level: <ul style="list-style-type: none"> • Class I @ 25 °C ambient temperature • Class II @ 95 °C ambient temperature 	A A	JESD78E	—

4.1.2 Thermal resistance

4.1.2.1 11 x 11 mm FCBGA package thermal characteristics

Table 9 lists the 11 x 11 mm FCBGA package thermal resistance data.

Table 9. 11 x 11 mm FCBGA thermal resistance data ¹

Rating	Board Type ²	Symbol	Values	Unit
Junction to Ambient Thermal Resistance ³	JESD51-9, 2s2p	R _{θJA}	22.2	°C/W
Junction-to-Top of Package Thermal Characterization parameter ³	JESD51-9, 2s2p	Ψ _{JT}	0.4	°C/W
Junction to Case Thermal Resistance ⁴	N/A	R _{θJC}	8.5	°C/W

1. Power dissipation: Total power 1.24 W
2. Thermal test board meets JEDEC specification for this package (JESD51-9).
3. Determined in accordance to JEDEC JESD51-2A natural convection environment. Thermal resistance data in this report is solely for a thermal performance comparison of one package to another in a standardized specified environment. It is not meant to predict the performance of a package in an application-specific environment.
4. Junction-to-Case thermal resistance determined using an isothermal cold plate.

4.1.2.2 9 x 9 mm FCBGA package thermal characteristics

Table 10 lists the 9 x 9 mm FCBGA package thermal resistance data.

Table 10. 9 x 9 mm FCBGA thermal resistance data ¹

Rating	Board Type ²	Symbol	Values	Unit
Junction to Ambient Thermal Resistance ³	JESD51-9, 2s2p	R _{θJA}	28.7	°C/W
Junction-to-Top of Package Thermal Characterization parameter ³	JESD51-9, 2s2p	Ψ _{JT}	0.7	°C/W
Junction to Case Thermal Resistance ⁴	N/A	R _{θJC}	8.5	°C/W

1. Power dissipation: Total power 1.24 W

2. Thermal test board meets JEDEC specification for this package (JESD51-9).
3. Determined in accordance to JEDEC JESD51-2A natural convection environment. Thermal resistance data in this report is solely for a thermal performance comparison of one package to another in a standardized specified environment. It is not meant to predict the performance of a package in an application-specific environment.
4. Junction-to-Case thermal resistance determined using an isothermal cold plate.

4.1.3 Power architecture

The power architecture of i.MX 91 is defined based on the assumption that systems are constructed for the case where the PMIC is used to supply all the power rails to the processor. The SoC may be powered from discrete parts rather than a PMIC, but a discrete-based solution is not necessarily BOM cost-optimized.

NVCC_BBSM_1P8 must be powered first and stay until the last.

The digital logic inside chip will be supplied with VDD_SOC.

The DRAM controller and PHY have multiple external power supplies: VDD_SOC supplies SoC synthesized DRAM controller digital logic, VDD_ANAx_0P8 for PLL and PHY digital logic, VDD_ANAx_1P8 for DRAM PLL and PHY analog circuitry, and VDD2_DDR for 1.1 V DRAM PHY I/O supply.

For all the integrated analog modules, their 1.8 V analog power will be supplied externally through power pads. These supplies are separated with other power pads (NVCC_XXX) on the package to keep them clean. External filters on these supplies may be needed on the board to isolate the analog 1.8 V supplies from the noisy I/O NVCC_XXX supplies.

For the integrated USB PHY, its 3.3 V (where supported), 1.8 V, and their digital power will be supplied externally through power pads. The powers to those PHYs are separated with other power pads on the package to keep them clean. External filters may be needed to isolate the PHY supplies to keep them clean.

For BBSM/RTC, the 1.8 V I/O pre-driver supply and 1.8 V I/O pad supply will also be supplied externally. The BBSM_LP core digital domain logic is supplied by an internal LDO.

[Figure 3](#) is the power architecture diagram for the whole chip. Note that it only shows power supplies, and does not show capacitors that may be required for internal LDO regulators.

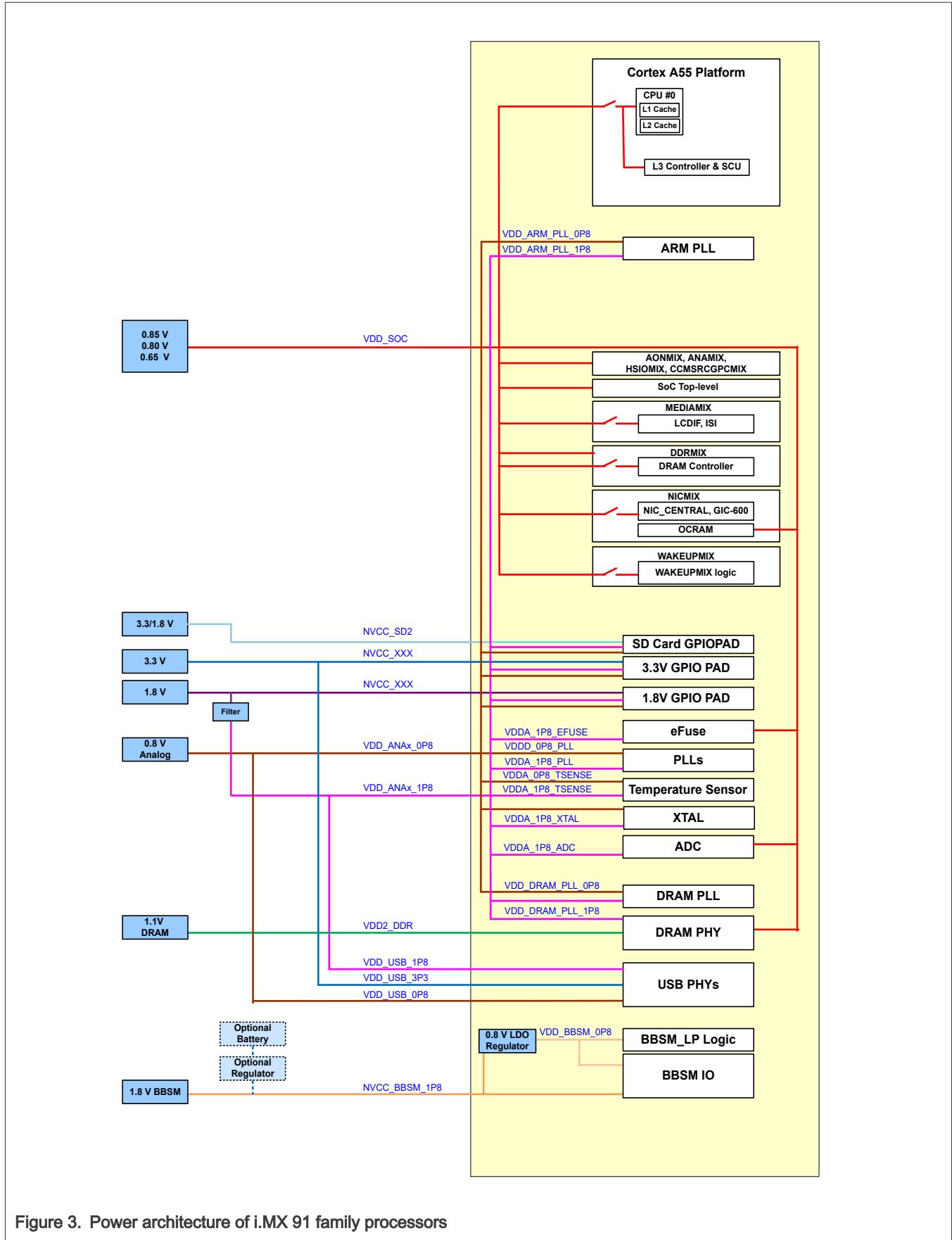


Figure 3. Power architecture of i.MX 91 family processors

4.1.4 Operating ranges

Table 11 provides the operating ranges of the i.MX 91 processors. For details on the chip's power structure, see the "Power Management Unit (PMU)" chapter of the *i.MX 91 Reference Manual* (IMX91RM).

Table 11. Operating ranges

Parameter Description	Symbol	Min	Typ	Max ¹	Unit	Comment
Power supply for all digital logics	VDD_SOC	0.80	0.85	0.90	V	Power supply for SoC, nominal mode, 1.4 GHz
Power supply for all digital logics	VDD_SOC	0.76	0.80	0.84	V	Power supply for SoC, low drive mode, 900 MHz ²
Power supply for all digital logics	VDD_SOC	0.61	0.65	0.69	V	Power supply for SoC, suspend mode
Power supply for PLLs, I/Os, USB PHY, Temp Sense	VDD_ANAx_0P8 ³ VDD_USB_0P8	0.76	0.80/0.85	0.90	V	Digital supply for PLLs, Temperature sensor, LVCMOS I/O and USB PHYs
1.8 V supply for PLLs, eFuse, Temperature sensor, LVCMOS voltage detect reference, ADC, 24 MHz XTAL, and USB PHY	VDD_ANAx_1P8	1.71	1.80	1.89	V	4
	VDD_USB_1P8					
3.3 V supply for USB PHY	VDD_USB_3P3	3.069	3.30	3.45	V	—
Voltage supply for DRAM PHY	VDD2_DDR	1.06	1.10	1.14	V	LPDDR4
I/O supply and I/O pre-driver supply for GPIO in BBSM bank	NVCC_BBBSM_1P8	1.65	1.80	1.95	V	—
Power supply for GPIO	NVCC_AON	1.65	1.80	1.95	V	1.8 V mode
	NVCC_SD2 NVCC_GPIO NVCC_WAKEUP	3.00	3.30	3.45	V	3.3 V mode
Temperature Ranges						
Junction temperature —Commercial	T _j ⁵	0	—	95	°C	See the application note, i.MX 91 Product Lifetime Usage Estimates for information on product lifetime (power-on hours) for this processor.
Ambient temperature —Commercial	T _a	0	—	—		

1. Applying the maximum voltage results in maximum power consumption and heat generation. NXP recommends a voltage set point = (V_{min} + the supply tolerance). This result in an optimized power/speed ratio.
2. Reduced performance parts are only support Low Drive mode, up to 800 MHz.

3. VDD_ANAx_0P8 refers to VDD_ANA_0P8 on 11 x 11 mm package, whereas VDD_ANA0_0P8 and VDD_ANA1_0P8 on 9 x 9 mm package.
4. VDD_ANAx_1P8 refers to VDD_ANA0_1P8, VDD_ANA1_1P8, and VDD_ANAVDET_1P8.
5. Tj minimum temperature supported at startup where Tj = Ta

4.1.5 Maximum frequency of modules

Table 12 provides the maximum frequency of modules in the i.MX 91 of processors.

Table 12. Maximum frequency of modules

Main modules	Frequency (Low Drive mode)	Frequency (Nominal mode)
EdgeLock Secure Encalve	133 MHz	200 MHz
Cortex A55 core	900 MHz ¹	1.4 GHz
DRAM	800 MHz	1.2 GHz

1. Reduced performance parts are only support Low Drive mode, up to 800 MHz.

4.1.6 Clock sources

This section introduces on-chip oscillator and external clock sources.

4.1.6.1 External clock sources

The i.MX 91 processor is designed to function with quartz crystals to generate the frequencies necessary for operation. 24 MHz for the main clock source and 32.768 kHz for the real time clock. External clock can be injected into RTC_XTALI if the frequency precision and jitter precision are sufficient.

The XTALI input is used to synthesize all of the clocks in the system with the RTC_XTALI input contributing to time keeping and low frequency operations.

Table 13 shows the interface frequency requirements.

Table 13. External input clock frequency

Parameter Description	Symbol	Min	Typ	Max	Unit
RTC_XTALI Oscillator ¹	f _{ckil}	—	32.768 ²	—	kHz

1. External oscillator or a crystal with internal oscillator amplifier.
2. Recommended nominal frequency is 32.768 kHz.

Table 14 shows the external input clock for RTC_XTALI oscillator.

Table 14. RTC_OSC

Description	Symbol	Min	Typ	Max	Unit
Frequency	f	—	32.768	—	kHz
RTC_XTALI	V _{IH}	0.9 x NVCC_BBSM_1P8	—	NVCC_BBSM_1P8	V
	V _{IL}	0	—	0.1 x NVCC_BBSM_1P8	V
	Duty cycle	45	—	55	%

4.1.6.2 On-chip oscillators

An external 24 MHz crystal is used in conjunction with the integrated amplifier to form a crystal oscillator that is used as the reference clock for all frequency synthesis on the processor.

Table 15. 24M quartz specifications¹

Symbol	Parameter Description	Min	Typ	Max	Unit
fXTAL	Frequency	—	24	—	MHz
CLOAD	Cload	—	12	—	pF
DL	Drive level	—	—	100	μW
ESR	ESR	—	—	120	Ω

1. An external 24 MHz crystal is used in conjunction with the integrated amplifier to form a crystal oscillator that is used as the reference clock for all frequency synthesis on the processor.

Table 16 shows 32K oscillator specifications.

Table 16. 32.768 kHz quartz specifications

Symbol	Parameter Description	Min	Typ	Max	Unit
fXTAL	Frequency (crystal mode) ¹	—	32.768	—	kHz
CLOAD	Cload	—	12.5	—	pF
ESR	ESR	—	—	90	KΩ

1. Actual working drive level is dependent on real design. Please contact crystal vendor for selecting drive level of crystal.

4.1.7 Maximum supply currents

Power consumption is highly dependent on the application. Estimating the maximum supply currents required for power supply design is difficult because the use cases that requires maximum supply current is not a realistic use cases.

To help illustrate the effect of the application on power consumption, data was collected while running commercial standard benchmarks that are designed to be compute and graphic intensive. The results provided are intended to be used as guidelines for power supply design.

Table 17. Maximum supply currents

Power rail	Max current	Unit
VDD_SOC	1500	mA
VDD_ANAx_1P8 ¹	150	mA
VDD_ANAx_0P8 ²	50	mA
VDD_USB_0P8	22.2	mA
NVCC_BBSM_1P8	2	mA
VDD2_DDR	400	mA

Table continues on the next page...

Table 17. Maximum supply currents ...continued

Power rail	Max current	Unit
NVCC_<XXX>	$I_{max} = N \times C \times V \times (0.5 \times F)$ Where: N—Number of IO pins supplied by the power line C—Equivalent external capacitive load V—IO voltage (0.5 x F)—Data change rate. Up to 0.5 of the clock rate (F). In this equation, I_{max} is in Amps, C in Farads, V in Volts, and F in Hertz.	
VDD_USB_3P3 (for USB 2.0 PHY)	25.2	mA
VDD_USB_1P8 (for USB 2.0 PHY)	36.2	mA

- VDD_ANAx_1P8 refers to VDD_ANA0_1P8, VDD_ANA1_1P8, and VDD_ANAVDET_1P8.
- VDD_ANAx_0P8 refers to VDD_ANA_0P8 on 11 x 11 mm package, whereas VDD_ANA0_0P8 and VDD_ANA1_0P8 on 9 x 9 mm package.

4.2 Power modes

This section introduces the power modes used in the i.MX 91 processors.

4.2.1 Power mode definition

The i.MX 91 supports the following power modes:

- RUN Mode:** All external power rails are on, the Cortex-A55 is active and running; other internal modules can be on/off based on application.
- IDLE Mode:** This mode is defined as a mode, which the Cortex-A55 can automatically enter when there is no thread running and all high-speed devices are not active. The Cortex-A55 can be put into power gated state, DRAM and the bus clock are reduced. Most of the internal logic is clock gated, but still remains powered. Compared with RUN mode, all the power rails from the power management remains the same and most of the modules still remain in their state, so the interrupt response in this mode is very small.
- SUSPEND Mode:** This mode is defined as the most power saving mode where all the clocks are off, all the unnecessary power supplies are off and all power gateable portions of the SoC are power gated. The Cortex-A55 CPU are fully power gated, all internal digital logic and analog circuit that can be powered down will be off, and all PHYs are power gated. DRAM is set at self-refresh/retention mode. VDD_SOC (and related digital supply) voltage is reduced to the "Suspend mode" voltage. The exit time from this mode will be much longer than IDLE, but the power consumption will also be much lower.
- BBSM Mode:** This mode is also called RTC mode. Only the power for the BBSM domain remains on to keep RTC and BBSM logic alive.
- OFF Mode:** All power rails are off.

NOTE

Beyond the modes defined here, additional options can be configured in software, such as to adjust clock frequencies or gate clocks through the CCM programming model, or to adjust on-die power-gating through the SRC or GPC programming model, or to adjust the voltage supplied to the VDD_SOC and VDD_ARM supplies as per [Table 11](#) in the Data Sheet.

Table 18 summarizes the external power supply states in all the power modes.

Table 18. Power supply states

Power rail	OFF	BBSM	SUSPEND	IDLE	RUN
NVCC_BBSM_1P8	OFF	ON	ON	ON	ON
VDD_SOC	OFF	OFF	ON	ON	ON
VDD2_DDR	OFF	OFF	ON	ON	ON
NVCC_<XXX>	OFF	OFF	ON	ON	ON
VDD_ANAx_0P8 VDD_USB_0P8	OFF	OFF	ON	ON	ON
VDD_ANAx_1P8 VDD_USB_1P8 VDD_USB_3P3	OFF	OFF	ON	ON	ON

4.2.2 Low power modes

The state of each module in the IDLE, SUSPEND, and BBSM mode are defined in the Table 19.

Table 19. Low power mode definition

	IDLE	SUSPEND	BBSM
CCM LPM mode	WAIT	STOP	N/A
Arm Cortex-A55 CPU0	OFF	OFF	OFF
MEDIA	OFF	OFF	OFF
DRAM controller and PHY	ON	OFF	OFF
WAKEUPMIX	ON	ON	OFF
NICMIX	ON	OFF	OFF
ARM_PLL	OFF	OFF	OFF
DRAM_PLL	OFF	OFF	OFF
SYSTEM_PLL1	ON	OFF	OFF
XTAL	ON	ON	OFF
RTC	ON	ON	ON
External DRAM device	Self-Refresh ¹	Self-Refresh ²	OFF

Table continues on the next page...

Table 19. Low power mode definition ...continued

	IDLE	SUSPEND	BBSM
USB PHY	In Low Power State	OFF	OFF
DRAM clock	200 MHz	OFF	OFF
AXI clock	133 MHz	OFF	OFF
Module clocks	ON as needed	OFF	OFF
EdgeLock Secure Enclave	ON	ON	OFF
GPIO Wakeup	Yes	Yes	OFF
RTC Wakeup	Yes	Yes	Yes
USB remote wakeup	Yes	No ^{3,4}	No
Other wakeup source ⁵	Yes	No	No

1. Automatic enter self-refresh when there is no DRAM access.
2. Put into self-refresh mode by software before entering low power mode.
3. Turn off externally by PMIC when PMIC_STBY_REQ signal is asserted.
4. USB remote wakeup can be "Yes" if required.
5. Remote wakeup can be supported if the USB PHY power is on in this mode.

4.3 Power supplies requirements and restrictions

The system design must comply with power-up sequence, power-down sequence, and steady state guide-lines as described in this section to guarantee the reliable operation of the device. Any deviation from these sequences may result in the following situations:

- Excessive current during power-up phase
- Prevention of the device from booting
- Irreversible damage to the processor (worst-case scenario)

Figure 4 illustrates the power-up and power-down sequence of i.MX 91 processors.

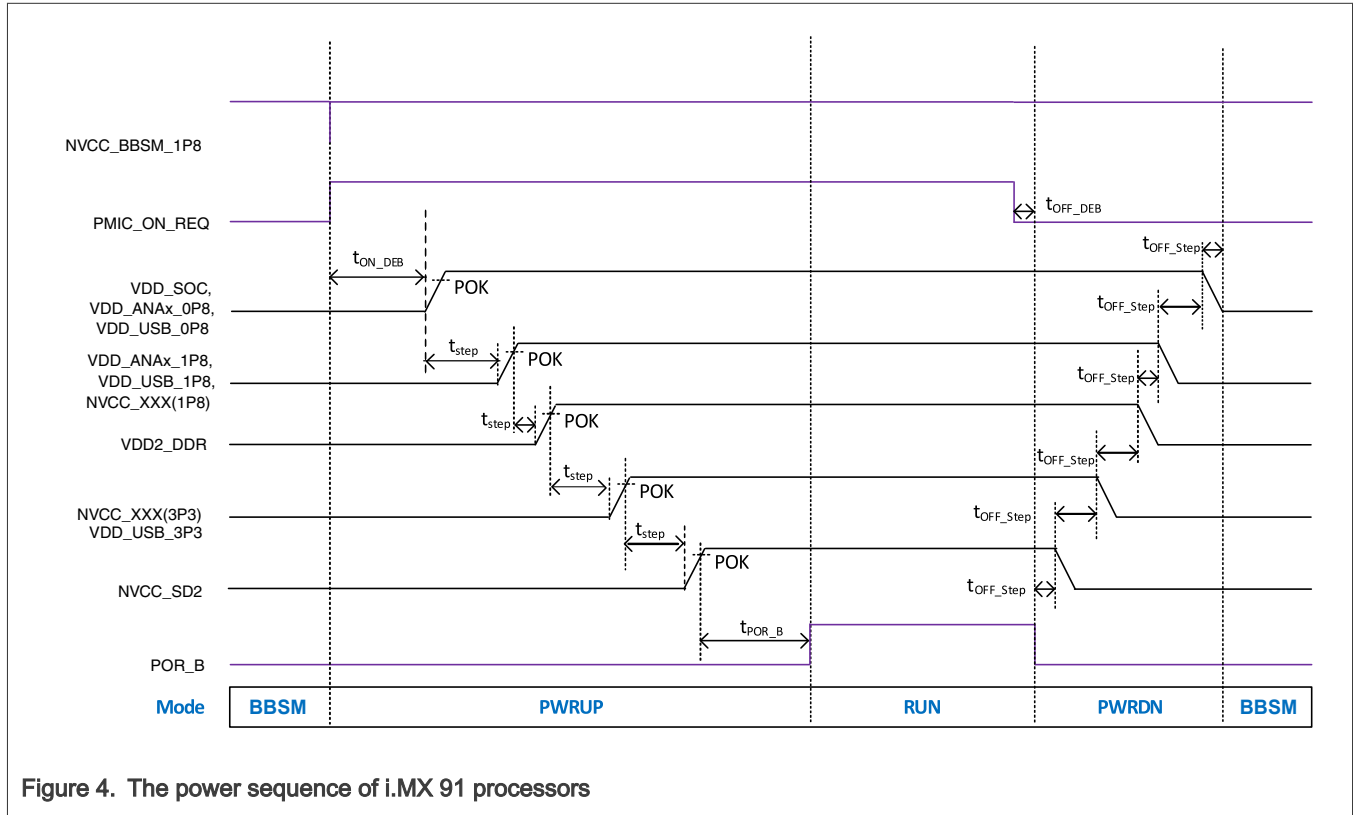


Figure 4. The power sequence of i.MX 91 processors

NOTE

POR_B must be asserted whenever VDD_SOC is powered down, but NVCC_BBSM_1P8 is powered up (when the processor is in BBSM mode).

4.3.1 Power-up sequence

The power-up sequence of i.MX 91 is defined as follows:

1. Turn on NVCC_BBSM_1P8
2. The SoC assert PMIC_ON_REQ at this point in time.
3. Turn on VDD_SOC and VDD_*_0P8 (includes all analog, PHY, PLL supplies) digital voltage supplies.
4. Turn on all remaining 1.8 V supplies. This includes VDD_*_1P8 analog, PHY and PLL supplies, and any 1.8 V NVCC_XXX I/O supplies.
5. Turn on DDR I/O supplies.
6. Turn on any 3.3 V supplies. This includes any 3.3 V NVCC_XXX I/O supplies and VDD_USB_3P3 (This 3.3 V supply step may be simultaneous with either the 1.8 V or the DDR supplies if desired).
7. POR_B release (asserting during the entire power-up sequence).

4.3.2 Power-down sequence

The power-down sequence of i.MX 91 is defined as follows:

- Turn off VDD_SOC after the other (non-BBSM) power rails or at the same time as other (non-BBSM) rails.
- No sequence for other power rails during power down.

4.4 PLL electrical characteristics

Table 20 shows the PLL electrical parameters.

Table 20. PLL electrical parameters

PLL type	Parameter	Value
AUDIO_PLL1	Clock output range	Up to 650 MHz
	Reference clock	24 MHz
	Lock time	50 μ s
	Jitter	\pm 1% of output period, \geq 50 ps
VIDEO_PLL1	Clock output range	Up to 594 MHz
	Reference clock	24 MHz
	Lock time	50 μ s
SYS_PLL1	Clock output range	312.5 MHz — 1 GHz
	Reference clock	24 MHz
	Lock time	70 μ s
ARM_PLL	Clock output range	800 MHz — 1400 MHz
	Reference clock	24 MHz
	Lock time	70 μ s
DRAM_PLL1	Clock output range	400 MHz — 1000 MHz
	Reference clock	24 MHz
	Lock time	50 μ s

4.5 I/O DC parameters

This section includes the DC parameters of the following I/O types:

- General Purpose I/O (GPIO)
- Double Data Rate I/O (DDR) for LPDDR4 modes

4.5.1 General purpose I/O (GPIO) DC parameters

Table 21 shows DC parameters for GPIO pads. The parameters Table 21 are guaranteed per the operating ranges in Table 11, unless otherwise noted.

Table 21. GPIO DC parameters

Parameter	Symbol	Test Conditions	Min	Typ	Max	Unit
High-level output voltage	$V_{OH(1.8V)}$	DS =1, IOH = 1.1 mA DS=6, IOH = 6.6 mA	0.8 x NVCC_xxx	—	NVCC_xxx	V
	$V_{OH(3.3V)}$	DS =1, IOH = 2 mA DS=6, IOH = 12 mA	0.8 x NVCC_xxx	—	NVCC_xxx	V
Low-level output voltage	$V_{OL(1.8V)}$	DS =1, IOL = 1.1 mA DS=6, IOL = 6.6 mA	0	—	0.2 x NVCC_xxx	V
	$V_{OL(3.3V)}$	DS =1, IOL = 2 mA DS=6, IOL = 12 mA	0	—	0.2 x NVCC_xxx	V
Low-level input voltage	V_{IL}	NVCC_xxx = 1.65 - 3.465 V; Temp = -40 to 125°C	0	—	0.3 x NVCC_xxx	V
High-level input voltage	V_{IH}	NVCC_xxx = 1.65 - 3.465 V; Temp = -40 to 125°C	0.7 x NVCC_xxx	—	NVCC_xxx	V
Pull-down resistor	Rpd3.3v	NVCC_xxx = 3.0 - 3.465 V; Temp = -40 to 125°C	24	43	87	KΩ
Pull-up resistor	Rpu3.3v		18	37	72	KΩ
Pull-down resistor	Rpd1.8v	NVCC_xxx = 1.65 - 1.95 V; Temp = -40 to 125°C	13	23	48	KΩ
Pull-up resistor	Rpu1.8v		12	22	49	KΩ

NOTE

For GPIO pads, when the supplies are ramp-up or/and below operating level, the pad state values are undefined.

NOTE

For PHY pads, the PAD state values are undefined before POR_B is asserted.

Table 22. Additional leakage parameters

Parameter	Symbol	Condition	Min	Max	Unit
Leakage high	I _{IH}	Non-PHY I/O, 1.65 V - 3.465 V, Temp = -40°C to 125°C pad = VDDIO ¹	-5	5	μA
Leakage low	I _{IL}	Non-PHY I/O, 1.65 V - 3.465 V, Temp = -40°C to 125°C pad = VSS ¹	-5	5	

1. This specification does not apply to PHY, ANALOG, TAMPER0, TAMPER1 I/Os, PMIC_ON_REQ, and PMIC_STBY_REQ.

4.5.2 DDR I/O DC electrical characteristics

The DDR I/O pads support LPDDR4 operational modes. The Double Data Rate Controller (DDRC) is compliant with JEDEC-compliant SDRAMs.

DDRC operation is contingent upon the board’s DDR design adherence to the DDR design and layout requirements stated in the hardware development guide for the i.MX 91 application processors.

4.6 I/O AC parameters

This section includes the AC parameters of the following I/O types:

- General Purpose I/O (GPIO)

The GPIO load circuit and output transition time waveforms are shown in [Figure 5](#) and [Figure 6](#).

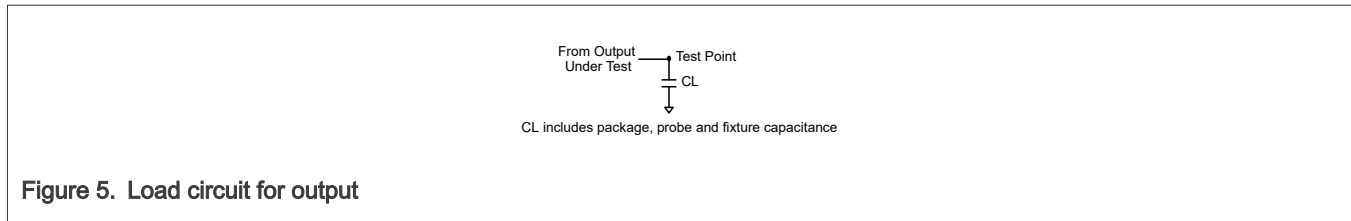


Figure 5. Load circuit for output

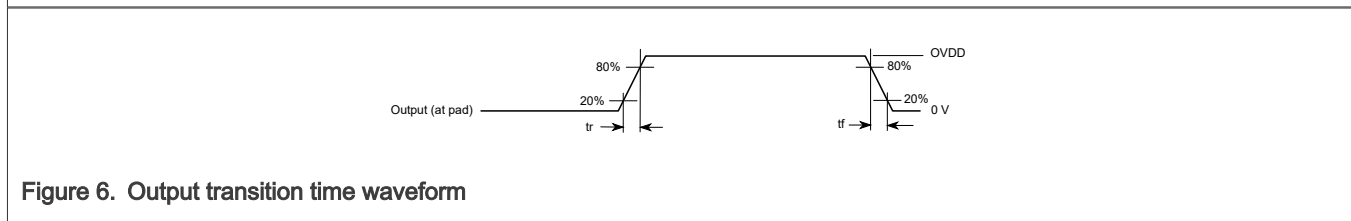


Figure 6. Output transition time waveform

4.6.1 DDR I/O AC electrical characteristics

The DDR I/O pads support LPDDR4 operational modes. The DDRC is compliant with JEDEC-compliant SDRAMs.

DDRC operation is contingent upon the board’s DDR design adherence to the DDR design and layout requirements stated in the hardware development guide for the i.MX 91 application processor.

4.7 Differential I/O output buffer impedance

The Differential CCM interface is designed to be compatible with TIA/EIA 644-A standard. See, TIA/EIA STANDARD 644-A, *Electrical Characteristics of Low Voltage Differential Signaling (LVDS) Interface Circuits* (2001) for details.

4.7.1 DDR I/O output buffer impedance

DDR output driver and ODT impedances are controlled across PVT using ZQ calibration procedure with a 120 ohm ±1% resistor to ground. Programmable drive strength and ODT impedance targets available in the NXP DDR tool are detailed in the device IBIS model. Impedance deviation (calibration accuracy) is ±10% (Maximum/Minimum impedance) across PVT.

4.8 System modules timing

This section contains the timing and electrical parameters for the modules in each i.MX 91 processor.

4.8.1 Reset timing parameters

[Figure 7](#) shows the reset timing and [Table 23](#) lists the timing parameters.

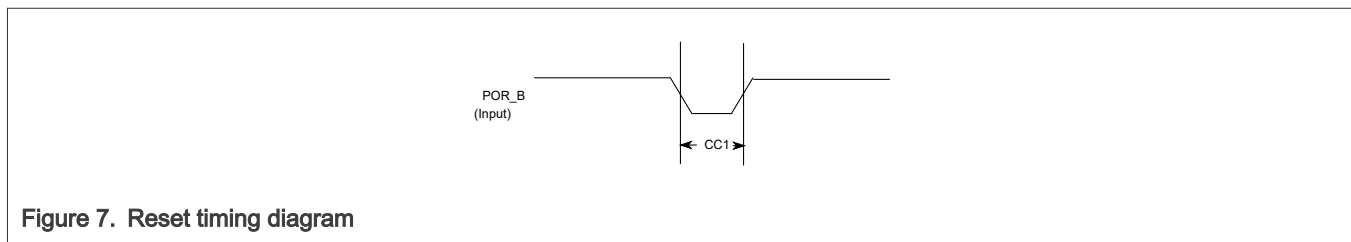


Figure 7. Reset timing diagram

Table 23. Reset timing parameters

ID	Parameter	Min	Max	Unit
CC1	Duration of POR_B to be qualified as valid. Note: POR_B rise/fall times must be 5 ns or less.	1	—	RTC_XTALI cycle

4.8.2 WDOG Reset timing parameters

Figure 8 shows the WDOG reset timing and Table 24 lists the timing parameters.

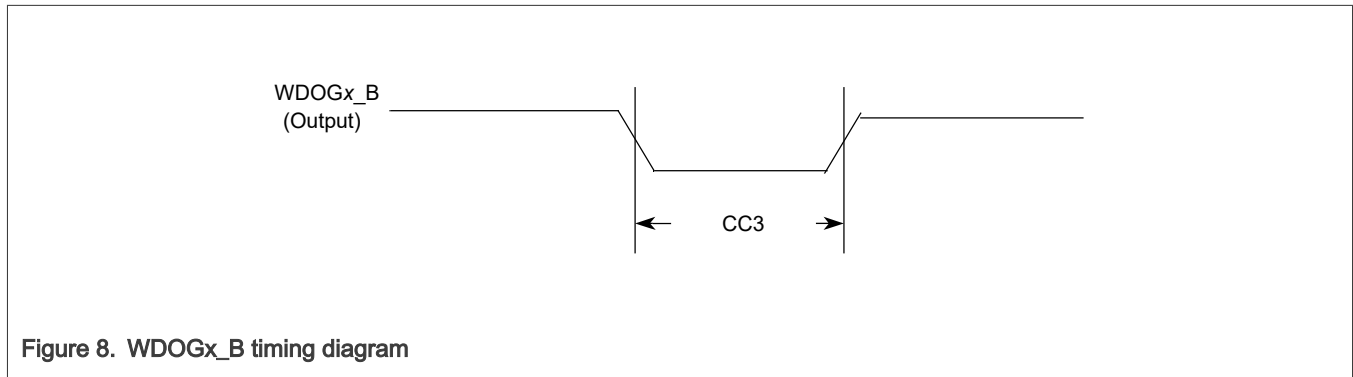


Figure 8. WDOGx_B timing diagram

Table 24. WDOGx_B timing parameters

ID	Parameter	Min	Max	Unit
CC3	Duration of WDOGx_B Assertion	1	—	RTC_XTALI cycle

NOTE

RTC_XTALI is approximately 32 kHz. RTC_XTALI cycle is one period or approximately 30 μs.

NOTE

WDOGx_B output signals (for each one of the Watchdog modules) do not have dedicated pins, but are muxed out through the IOMUX. See the IOMUXC chapter of the *i.MX 91 Applications Processor Reference Manual* (IMX91RM) for detailed information.

4.8.3 JTAG timing parameters

Figure 9 depicts the JTAG test clock input timing. Figure 10 depicts the JTAG boundary scan timing. Figure 11 depicts the JTAG test access port. Signal parameters are listed in Table 25.

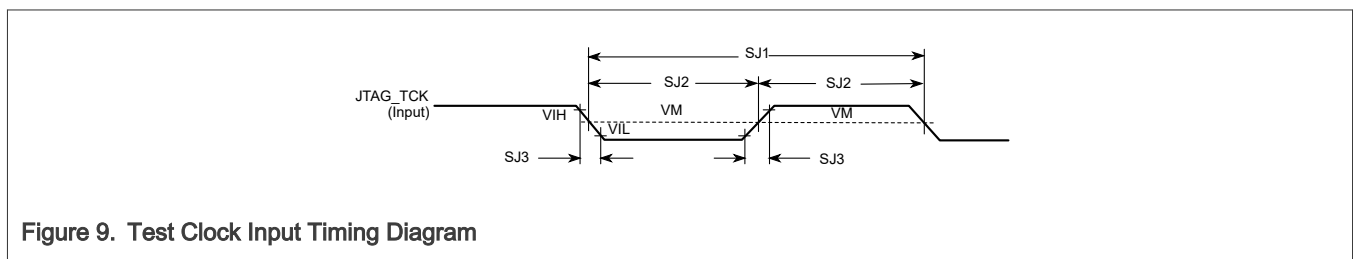


Figure 9. Test Clock Input Timing Diagram

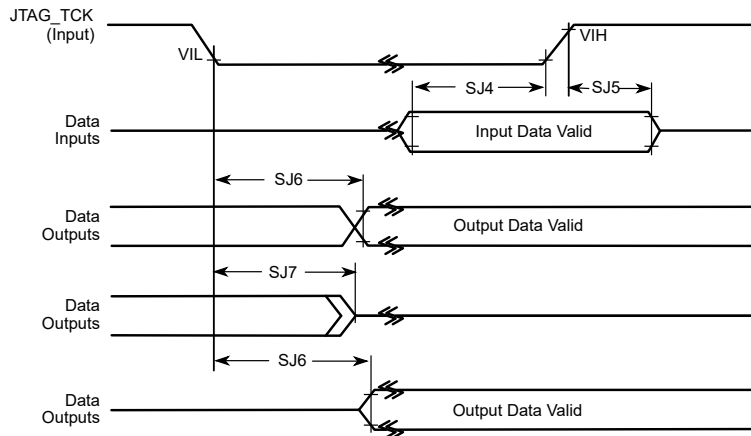


Figure 10. Boundary system (JTAG) timing diagram

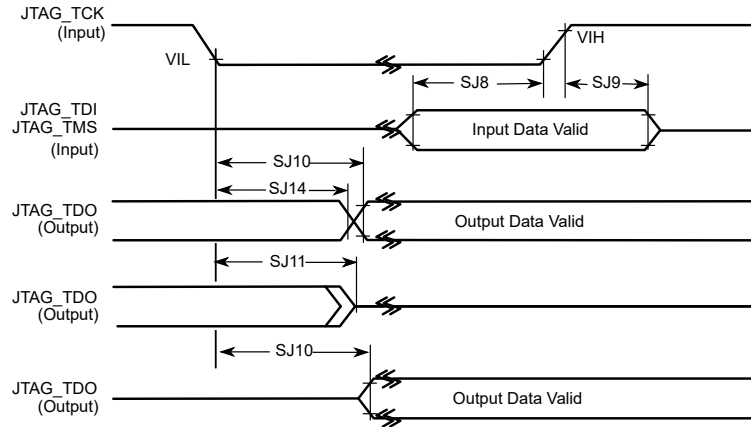


Figure 11. Test Access Port Timing Diagram

Table 25. JTAG Timing^{1,2}

ID	Parameter	All Frequencies		Unit
		Min	Max	
SJ0	JTAG_TCK frequency of operation $1/(3 \times T_{DC})^{3,4}$	—	50	MHz
SJ1	JTAG_TCK cycle time in crystal mode	20	—	ns
SJ2	JTAG_TCK clock pulse width measured at V_M^5	10	—	ns
SJ3	JTAG_TCK rise and fall times	—	3	ns
SJ4	Boundary scan input data set-up time	15	—	ns
SJ5	Boundary scan input data hold time	15	—	ns

Table continues on the next page...

Table 25. JTAG Timing^{1,2} ...continued

ID	Parameter	All Frequencies		Unit
		Min	Max	
SJ6	JTAG_TCK low to output data valid	—	600	ns
SJ7	JTAG_TCK low to output high impedance	—	600	ns
SJ8	JTAG_TMS, JTAG_TDI data set-up time	5	—	ns
SJ9	JTAG_TMS, JTAG_TDI data hold time	5	—	ns
SJ10	JTAG_TCK low to JTAG_TDO data valid	—	14	ns
SJ11	JTAG_TCK low to JTAG_TDO high impedance	—	14	ns
SJ14	JTAG_TCK low to JTAG_TDO data invalid	1	—	ns

1. Input timing assumes an input signal slew rate of 3 ns (20%/80%).
2. Output timing valid for maximum external load CL = 25 pF, which is assumed to be a 10 pF load at the end of a 50 Ω, unterminated, 5-inch microstrip trace on standard FR4 (3.3 pF/inch), (25 pF total with margin). For best signal integrity, the series resistance of the transmission line can be equal to the selected RDSON of the I/O pad output driver.
3. T_{DC} = target frequency of JTAG
4. 50 MHz frequency is for the JTAG debug interface. For boundary scan, the maximum TCK frequency is 10 MHz.
5. V_M = mid-point voltage

4.8.4 SWD timing parameters

The DSE[5:0] = 001111 and FSEL1[1:0] = 11 are required drive settings to meet the timing.

Figure 12 depicts the SWD timing.

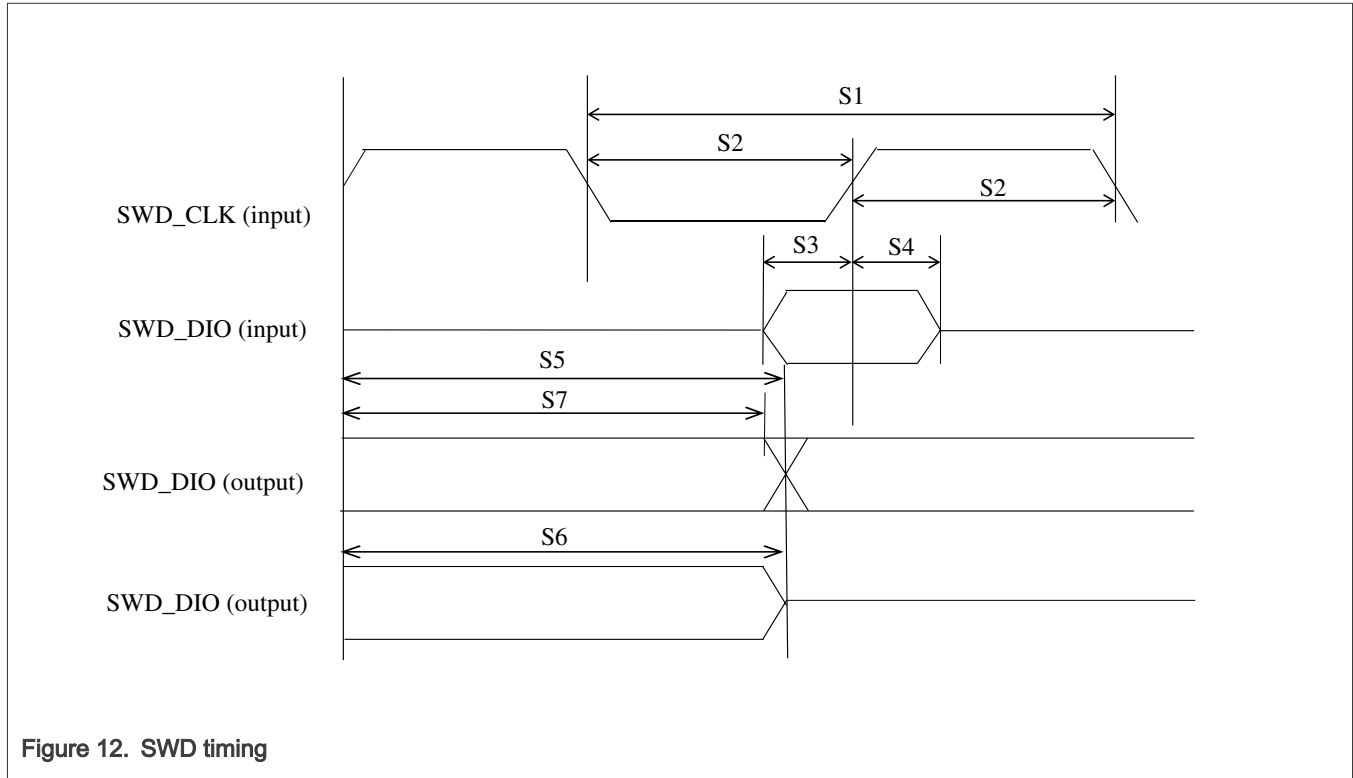


Figure 12. SWD timing

Table 26 shows SWD timing parameters.

Table 26. SWD timing parameters^{1,2}

Symbol	Description	Min	Max	Unit
S0	SWD_CLK frequency	—	50	MHz
S1	SWD_CLK cycle time	20	—	ns
S2	SWD_CLK pulse width	10	—	ns
S3	Input data setup time	5	—	ns
S4	Input data hold time	5	—	ns
S5	Output data valid time	—	14	ns
S6	Output high impedance time	—	14	ns
S7	Output data invalid time	0	—	ns

1. Input timing assumes an input signal slew rate of 3 ns (20%/80%).
2. Timing valid for maximum external load CL = 25 pF, which is assumed to be a 10 pF load at the end of a 50 Ω, unterminated, 5-inch microstrip trace on standard FR4 (3.3 pF/inch), (25 pF total with margin). For best signal integrity, the series resistance in the transmission line can be equal to the selected RDSON of the I/O pad output.

4.8.5 DDR SDRAM-specific parameters (LPDDR4)

The i.MX 91 Family of processors have been designed and tested to work with JEDEC JESD209-4 —compliant LPDDR4 memory. Timing diagrams and tolerances required to work with these memories are specified in the respective documents and are not reprinted here.

Meeting the necessary timing requirements for a DDR memory system is highly dependent on the components chosen and the design layout of the system as a whole. NXP cannot cover in this document all the requirements needed to achieve a design that meets full system performance over temperature, voltage, and part variation; PCB trace routing, PCB dielectric material, number of routing layers used, placement of bulk/decoupling capacitors on critical power rails, VIA placement, GND and Supply planes layout, and DDR controller/PHY register settings all are factors affecting the performance of the memory system. Consult the hardware user guide for this device and NXP validated design layouts for information on how to properly design a PCB for best DDR performance. NXP strongly recommends duplicating an NXP validated design as much as possible in the design of critical power rails, placement of bulk/decoupling capacitors and DDR trace routing between the processor and the selected DDR memory. All supporting material is readily available on the device web page on <https://www.nxp.com/products/processors-and-microcontrollers/arm-processors/i-mx-applications-processors/i-mx-9-processors:IMX9-PROCESSORS>.

Processors that demonstrate full DDR performance on NXP validated designs, but do not function on customer designs, are not considered marginal parts. Customers bear the responsibility of properly designing the Printed Circuit Board, correctly simulating and modeling the designed DDR system, and validating the system under all expected operating conditions (temperatures, voltages) prior to releasing their product to market.

Table 27. i.MX 91 DRAM controller supported SDRAM configurations

Parameter	LPDDR4
Number of Controllers	1
Number of Channels	1
Number of Chip Selects	2
Bus Width	16-bit
Maximum supported data rate	
• Low drive mode	1600 MT/s
• Nominal drive mode	2400 MT/s

4.9 Display

This section provides information about display subsystem.

4.9.1 LCD Controller (LCDIF) timing parameters

The DSE[5:0] = 001111 and FSEL1[1:0] = 11 are required drive settings to meet the timing.

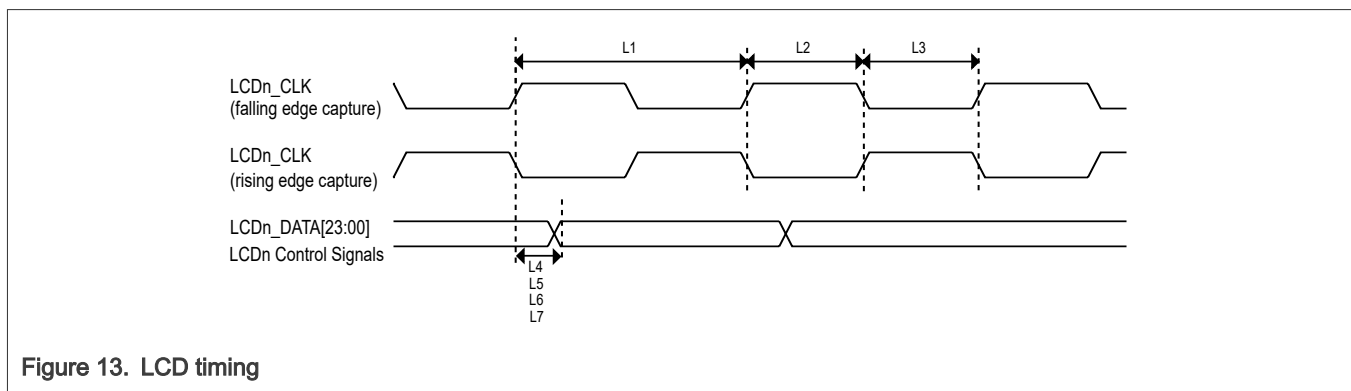


Figure 13. LCD timing

Table 28. LCD timing parameters^{1,2}

Num	Characteristic	Symbol	Min	Max	Unit
L1	LCD pixel clock frequency	tCLK(LCD)	—	80	MHz
L2	LCD pixel clock high (falling edge capture)	tCLKH(LCD)	5	—	ns
L3	LCD pixel clock low (rise edge capture)	tCLKL(LCD)	5	—	ns
L4	LCD pixel clock high to data valid (falling edge capture)	td(CLKH-DV)	-1.5	1.5	ns
L5	LCD pixel clock low to data valid (rise edge capture)	td(CLKL-DV)	-1.5	1.5	ns
L6	LCD pixel clock high to control signal valid (falling edge capture)	td(CLKH-CTRLV)	-1.5	1.5	ns
S7	LCD pixel clock low to control signal valid (rise edge capture)	td(CLKL-CTRLV)	-1.5	1.5	ns

1. Input timing assumes an input signal slew rate of 3 ns (20%/80%).
2. Output timing valid for maximum external load CL = 25 pF, which is assumed to be a 10 pF load at the end of a 50 ohm. Underterminated, 5-inch microstrip trace on standard FR4 (3.3 pF/inch), (25 pF total with margin). For best signal integrity, the series resistance in the transmission line should be equal to the selected RDSON of the I/O pad output driver.

4.10 Audio

This section provides information about audio subsystem.

4.10.1 SAI switching specifications

This section provides the AC timings for the SAI in Controller (clocks driven) and Target (clocks input) modes. All timings are given for non inverted serial clock polarity (SAI_TCR2[BCP] = 0, SAI_RCR2[BCP] = 0) and non inverted frame sync (SAI_TCR4[FSP] = 0, SAI_RCR4[FSP] = 0). If the polarity of the clock and/or the frame sync have been inverted, all the timings remain valid by inverting the clock signal (SAI_BCLK) and/or the frame sync (SAI_FS) shown in the figures below.

The DSE[5:0] = 001111 and FSEL1[1:0] = 11 are required drive settings to meet the timing.

For the 50 MHz BCLK operation, the BCLK and SYNC must always be in the same direction as the data (source synchronous):

- SAI transmitter must be in asynchronous mode with BCLK and SYNC configuration as outputs
- SAI receiver must be:
 - In asynchronous mode with BCLK and SYNC configuration as inputs
 - In synchronous mode with SAI_RCR2[BCI] = 1

Table 29. Controller mode SAI timing (50 MHz)^{1,2,3}

Num	Characteristic	Min	Max	Unit
S1	SAI_MCLK cycle time	20	—	ns
S2	SAI_MCLK pulse width high/low	40%	60%	MCLK period
S3	SAI_BCLK cycle time	20	—	ns

Table continues on the next page...

Table 29. Controller mode SAI timing (50 MHz)^{1,2,3}...continued

Num	Characteristic	Min	Max	Unit
S4	SAI_BCLK pulse width high/low	40%	60%	BCLK period
S5	SAI_BCLK to SAI_FS output valid	—	3	ns
S6	SAI_BCLK to SAI_FS output invalid	-2	—	ns
S7	SAI_BCLK to SAI_TXD valid	—	3	ns
S8	SAI_BCLK to SAI_TXD invalid	-2	—	ns
S9	SAI_RXD/SAI_FS input setup before SAI_BCLK	3	—	ns
S10	SAI_RXD/SAI_FS input hold after SAI_BCLK	2	—	ns

1. To achieve 50 MHz for BCLK operation, clock must be set in feedback mode.
2. Input timing assumes an input signal slew rate of 3 ns (20%/80%).
3. Output timing valid for maximum external load CL = 25 pF, which is assumed to be a 10 pF load at the end of a 50 ohm. Underterminated, 5-inch microstrip trace on standard FR4 (3.3 pF/inch), (25 pF total with margin). For best signal integrity, the series resistance in the transmission line should be equal to the selected RDSON of the I/O pad output driver.

Table 30. Controller mode SAI timing (25 MHz)^{1,2}

Num	Characteristic	Min	Max	Unit
S1	SAI_MCLK cycle time	40	—	ns
S2	SAI_MCLK pulse width high/low	40%	60%	MCLK period
S3	SAI_BCLK cycle time	40	—	ns
S4	SAI_BCLK pulse width high/low	40%	60%	BCLK period
S5	SAI_BCLK to SAI_FS output valid	—	3	ns
S6	SAI_BCLK to SAI_FS output invalid	-2	—	ns
S7	SAI_BCLK to SAI_TXD valid	—	3	ns
S8	SAI_BCLK to SAI_TXD invalid	-2	—	ns
S9	SAI_RXD/SAI_FS input setup before SAI_BCLK	8	—	ns
S10	SAI_RXD/SAI_FS input hold after SAI_BCLK	0	—	ns

1. Input timing assumes an input signal slew rate of 3 ns (20%/80%).
2. Output timing valid for maximum external load CL = 25 pF, which is assumed to be a 10 pF load at the end of a 50 ohm. Underterminated, 5-inch microstrip trace on standard FR4 (3.3 pF/inch), (25 pF total with margin). For best signal integrity, the series resistance in the transmission line should be equal to the selected RDSON of the I/O pad output driver.

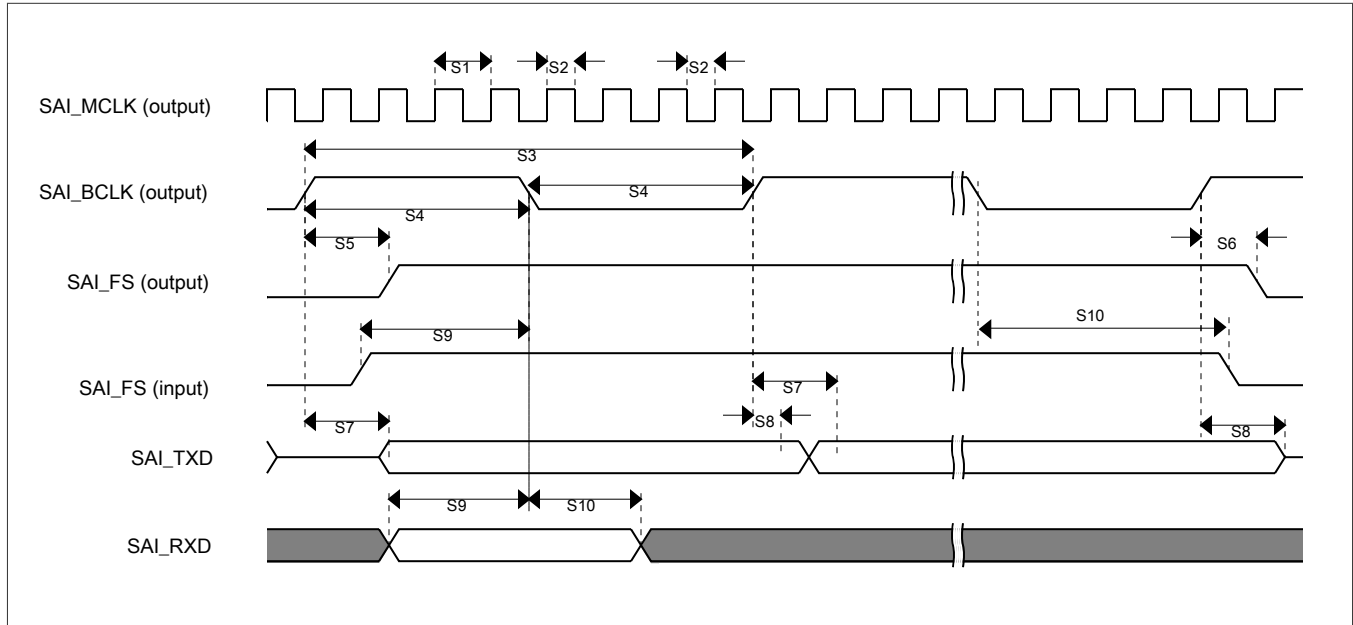


Figure 14. SAI timing—Controller mode

Table 31. Target mode SAI timing (25 MHz)^{1,2}

Num	Characteristic	Min	Max	Unit
S11	SAI_BCLK cycle time (input)	40	—	ns
S12	SAI_BCLK pulse width high/low (input)	40%	60%	BCLK period
S13	SAI_FS input setup before SAI_BCLK	3	—	ns
S14	SAI_FS input hold after SAI_BCLK	2	—	ns
S15	SAI_BCLK to SAI_TXD/SAI_FS output valid	—	9	ns
S16	SAI_BCLK to SAI_TXD/SAI_FS output invalid	0	—	ns
S17	SAI_RXD setup before SAI_BCLK	3	—	ns
S18	SAI_RXD hold after SAI_BCLK	2	—	ns
S19	SAI_FS input assertion to SAI_TXD output valid ³	—	25	ns

1. Input timing assumes an input signal slew rate of 3 ns (20%/80%).
2. Output timing valid for maximum external load CL = 25 pF, which is assumed to be a 10 pF load at the end of a 50 ohm. Unterminated, 5-inch microstrip trace on standard FR4 (3.3 pF/inch), (25 pF total with margin). For best signal integrity, the series resistance in the transmission line should be equal to the selected RDSON of the I/O pad output driver.
3. Applies to first bit in each frame and only if the TCR4[FSE] bit is clear.

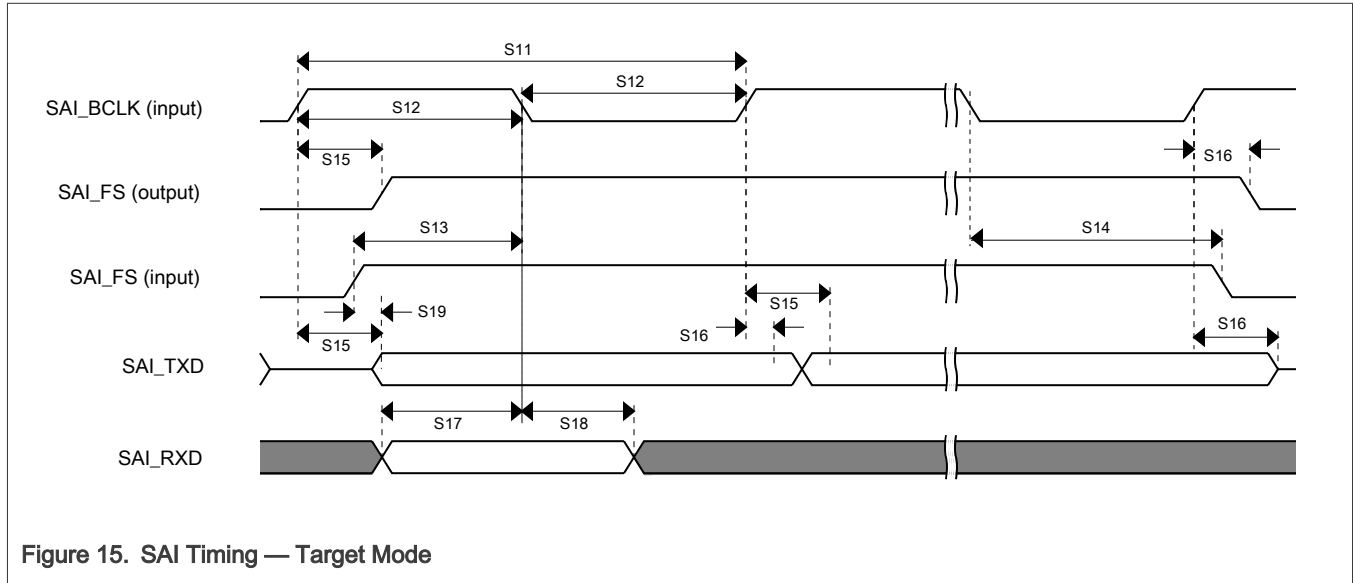


Figure 15. SAI Timing — Target Mode

4.10.2 SPDIF timing parameters

The Sony/Philips Digital Interconnect Format (SPDIF) data is sent using the bi-phase marking code. When encoding, the SPDIF data signal is modulated by a clock that is twice the bit rate of the data signal.

Table 32, Figure 16 and Figure 17 show SPDIF timing parameters for the Sony/Philips Digital Interconnect Format (SPDIF), including the timing of the modulating Rx clock (SPDIF_SR_CLK) for SPDIF in Rx mode and the timing of the modulating Tx clock (SPDIF_ST_CLK) for SPDIF in Tx mode.

The DSE[5:0] = 001111 and FSEL1[1:0] = 11 are required drive settings to meet the timing.

Table 32. SPDIF timing parameters

Parameter	Symbol	Timing Parameter Range		Unit
		Min	Max	
SPDIF_IN Skew: asynchronous inputs, no specs apply	—	—	0.7	ns
SPDIF_OUT output (Load = 50 pf)	—	—	1.5	ns
• Skew	—	—	24.2	
• Transition rising	—	—	31.3	
• Transition falling	—	—		
SPDIF_OUT output (Load = 30 pf)	—	—	1.5	ns
• Skew	—	—	13.6	
• Transition rising	—	—	18.0	
• Transition falling	—	—		
Modulating Rx clock (SPDIF_SR_CLK) period	srckp	40.0	—	ns
SPDIF_SR_CLK high period	srckph	16.0	—	ns

Table continues on the next page...

Table 32. SPDIF timing parameters ...continued

Parameter	Symbol	Timing Parameter Range		Unit
		Min	Max	
SPDIF_SR_CLK low period	srckpl	16.0	—	ns
Modulating Tx clock (SPDIF_ST_CLK) period	stclkp	40.0	—	ns
SPDIF_ST_CLK high period	stclkph	16.0	—	ns
SPDIF_ST_CLK low period	stckpl	16.0	—	ns

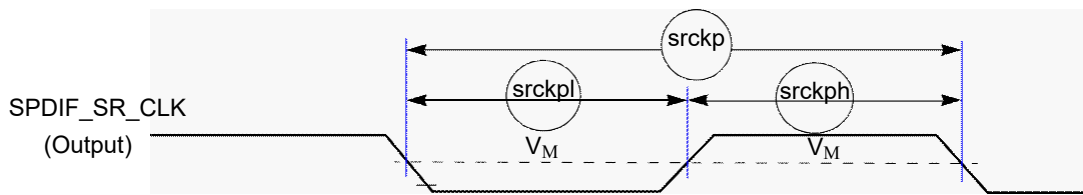


Figure 16. SPDIF_SR_CLK timing diagram

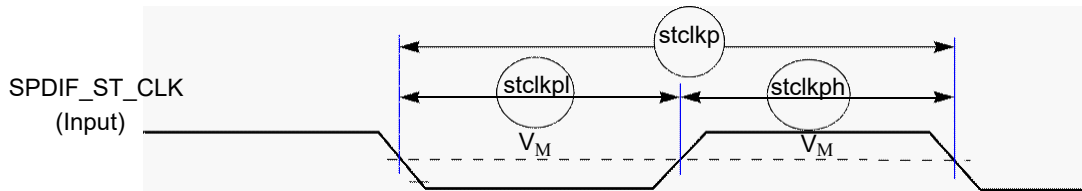


Figure 17. SPDIF_ST_CLK timing diagram

4.10.3 PDM Microphone interface timing parameters

NOTE

These timing requirements apply only if the clock divider is enabled (PDM_CTRL2[CLKDIV] = 0), otherwise there are no special timing requirements.

The PDM microphones must meet the setup and hold timing requirements shown in the following table. The "k" factor value in Table 33 depends on the selected quality mode as shown in Table 34.

Table 33. PDM timing parameters

Parameter	Value
trs, tfs	$\leq \frac{\text{floor}(K \times \text{CLKDIV}) - 1}{@(\text{moduleName})_CLK_ROOTRate}$ <p>1</p>
trh, tfh	≥ 0

1. @moduleName = PDM. Depending on K value, user must make sure floor (K x CLKDIV) > 1 to avoid timing problems.

Table 34. K factor value

Quality factor	K factor
High Quality	1/2
Medium Quality, Very Low Quality 0	1
Low Quality, Very Low Quality 1	2
Very Low Quality 2	4

Figure 18 illustrates the timing requirements for the PDM.

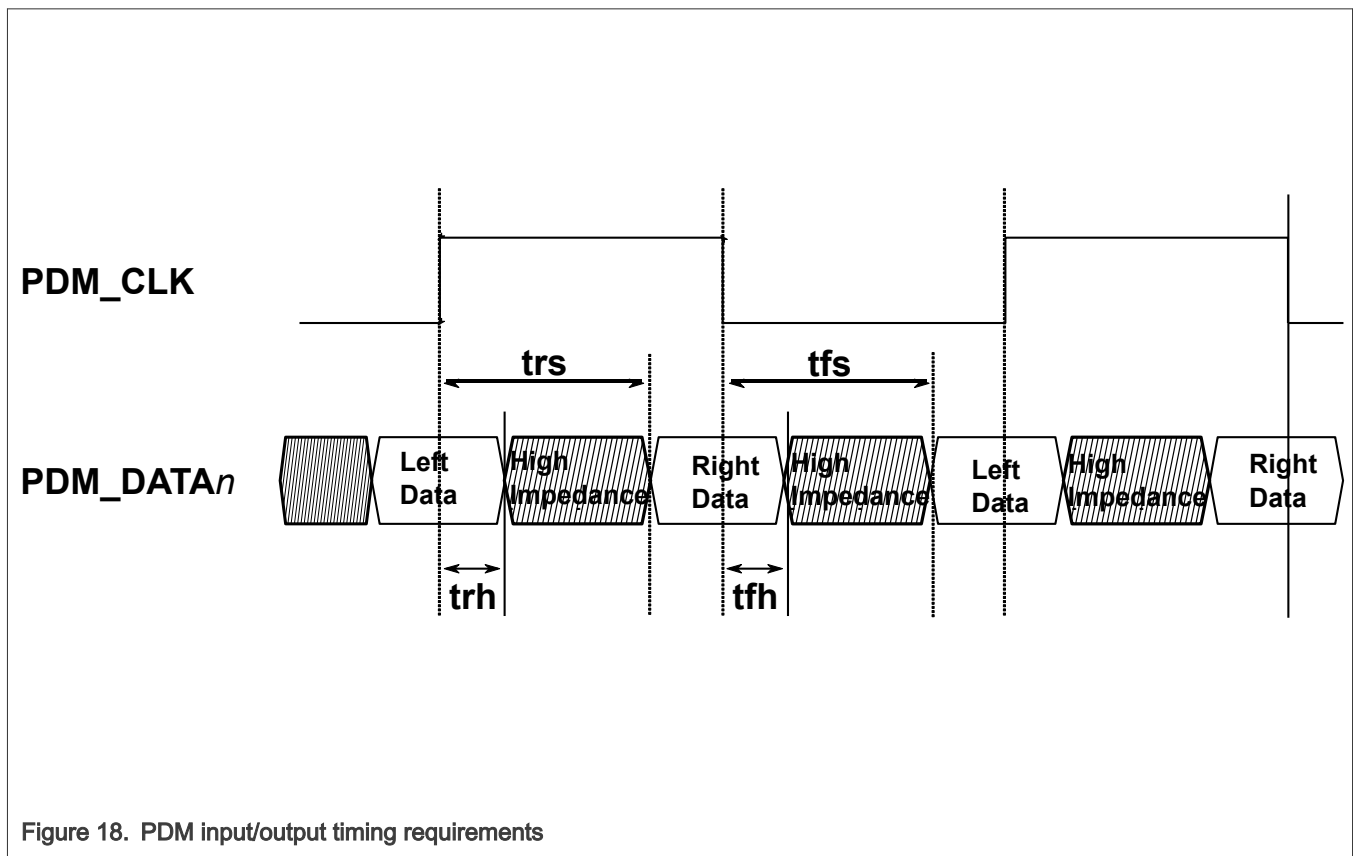


Figure 18. PDM input/output timing requirements

4.10.4 Medium Quality Sound (MQS) electrical specifications

Medium quality sound (MQS) is used to generate medium quality audio via a standard GPIO in the pinmux, allowing the user to connect stereo speakers or headphones to a power amplifier without an additional DAC chip. Two outputs are asynchronous PWM pulses and their maximum frequency is $1/32 \times \text{mclk_frequency}$.

Table 35. MQS specifications

Symbol	Description	Min	Typ	Max	Unit
f_{mclk} ¹	Bit clock is used to generate the mclk.	—	24.576	66.5	MHz

1. Frequency of mclk depends on software settings.

4.11 Analog

The following sections provide information about analog interfaces.

4.11.1 12-bit ADC electrical specifications

All ADC channels meet the 12-bit single-ended accuracy specifications.

4.11.1.1 ADC electrical specifications

Table 36. ADC electrical specifications

Symbol	Description	Min	Typ	Max	Unit
VADIN	Input voltage ¹	V_{GND}	—	V_{DDA}	V
$f_{\text{AD_CK}}$	ADC clock frequency	20	—	80	MHz
f_{ADCK}	ADC conversion clock frequency	20	—	66	MHz
C_{sample}	Sample cycles	5.5	—	—	ns
C_{compare}	Fixed compare cycles	—	58	131.5	ns
$C_{\text{conversion}}$	Conversion cycles	$C_{\text{conversion}} = C_{\text{sample}} + C_{\text{compare}}$			ns
$C_{\text{AD_INPUT}}$	ADC input capacitance ²	—	—	7	pF
$R_{\text{AD_INPUT}}$	ADC input series resistance	—	—	1.25	K Ω
DNL	ADC differential nonlinearity	—	± 2	—	LSB
INL	ADC integral nonlinearity ³	—	± 6	—	LSB
R_{AS}	Analog source resistance	—	—	5	K Ω
Bandgap	Output voltage ready time for bandgap ⁴	—	1	—	μs

1. On or off channels
2. ADC component plus pad capacitance (~ 2 pF)
3. After calibration
4. Based on simulation test

Table 37. ADC electrical specifications (VREFH = VDDA_ANAx_1P8¹ and VADIN_{max} ≤ VREFH)²

Symbol	Description	Min	Typ	Max	Unit
V _{ADIN}	Input voltage	V _{GND}	—	V _{DDA}	V
C _{ADIN}	Input capacitance	—	4.5	—	pF
R _{ADIN}	Input resistance	—	500	—	Ω
R _{AS}	Analog source resistance ³	—	—	5	KΩ
f _{ADCK}	ADC conversion clock frequency	8	—	66	MHz
C _{sample}	Sample cycles ⁴	3.5	—	131.5	Cycles
C _{compare}	Fixed compare cycles	—	17.5	—	Cycles
C _{conversion}	Conversion cycles	C _{conversion} = C _{sample} + C _{compare}			Cycles
DNL	Differential nonlinearity	—	±2	—	LSB
INL	Integral nonlinearity	—	±6	—	LSB
ENOB	Effective number of bits: Single-ended mode ^{5, 6, 7, 8, 9}	—	9	—	
SINAD	Signal to noise plus distortion	SINAD = 6.02 x ENOB + 1.76			dB

1. The range is from 1.71 V to 1.89 V.
2. Values in this table are based on test with limited matrix samples in lab environment.
3. This resistance is external to the SoC. To achieve the best results, the analog source resistance must be kept as low as possible. The results in this data sheet were derived from a system that had < 15 Ω analog source resistance.
4. See [Figure 19](#)
5. Noise on the ADC reference voltage (VDD_ANA_1P8) will result in performance loss of the ADC proportional to the noise present.
6. Input data used for test is 1 kHz sine wave.
7. Measured at VREFH = 1.8 V and pwrsel = 2.
8. ENOB can be lower than shown, if an ADC channel corrupts other ADC channels through capacitive coupling. This coupling may be dominated by board parasitics. Care must be taken not to corrupt the desired channel being measured. This coupling becomes worse at higher analog frequencies and with switching waveforms due to the harmonic content.
9. ENOB can be lower than shown if excessive noise is present on VDD_ANAx_1P8, including ripple from DC/DC converter.

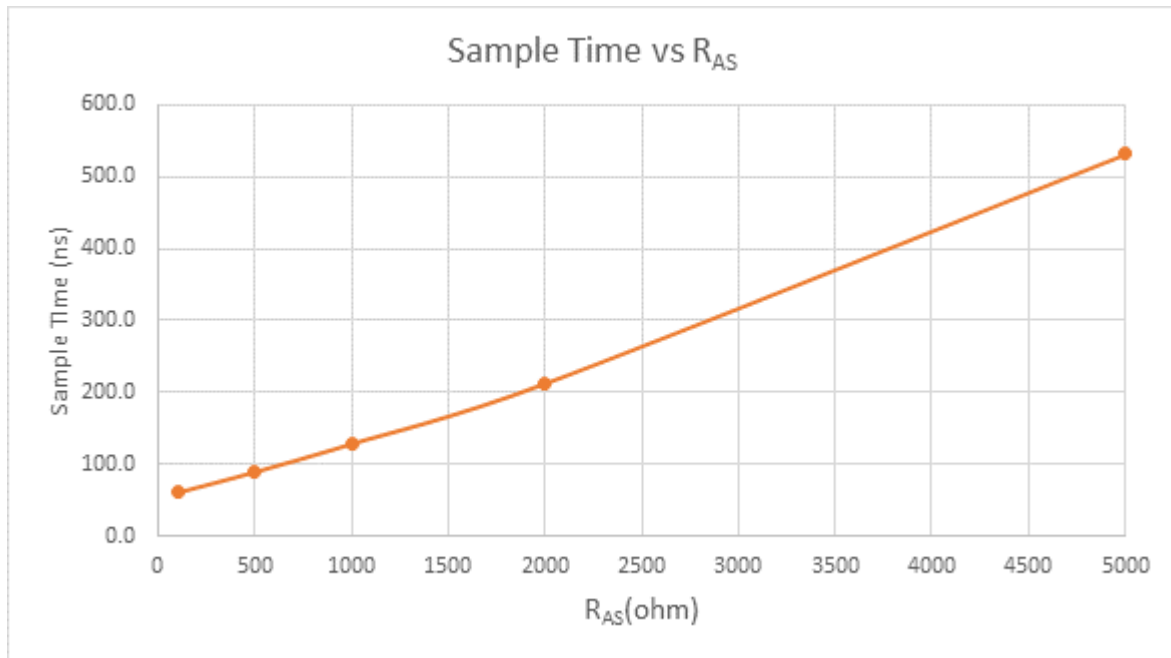


Figure 19. Sample time vs R_{AS}

4.11.1.2 12-bit ADC input impedance equivalent circuit diagram

There is an additional R_{IOMUX} of 350 Ω (from 295 Ω to 405 Ω) resistance if an input goes through the MUX inside the IO and CP of 2.5 pF as shown in Figure 20.

To calculate the sample request time, using the following equation where R_{ADCtotal} = R_{ADIN} + R_{IOMUX}, R_{IOMUX} = 350 Ω, C_P = 2.5 pF and B = 11 for 1/4 LSB settling.

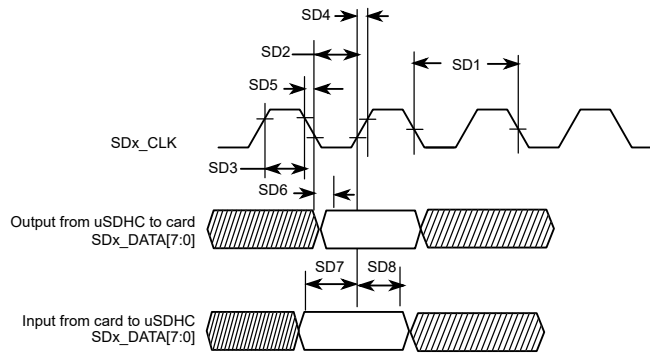


Figure 21. SD3.0/eMMC5.1 (SDR) timing

Table 38. SD3.0/eMMC5.1 (SDR) interface timing specification^{1,2}

ID	Parameter	Symbols	Min	Max	Unit
Card Input Clock					
SD1	Clock Frequency (Low Speed)	f_{PP}^3	0	400	kHz
	Clock Frequency (SD/SDIO Full Speed/High Speed)	f_{PP}^4	0	25/50	MHz
	Clock Frequency (MMC Full Speed/High Speed)	f_{PP}^5	0	20/52	MHz
	Clock Frequency (Identification Mode)	f_{OD}	100	400	kHz
SD2	Clock Low Time	t_{WL}	7	—	ns
SD3	Clock High Time	t_{WH}	7	—	ns
SD4	Clock Rise Time	t_{TLH}	—	3	ns
SD5	Clock Fall Time	t_{THL}	—	3	ns
uSDHC Output/Card Inputs SD_CMD, SDx_DATAx (Reference to CLK)					
SD6	uSDHC Output Delay	t_{OD}	-6.6	3.6	ns
uSDHC Input/Card Outputs SD_CMD, SDx_DATAx (Reference to CLK)					
SD7	uSDHC Input Setup Time	t_{ISU}	2.5	—	ns
SD8	uSDHC Input Hold Time ⁶	t_{IH}	1.5	—	ns

- Input timing assumes an input signal slew rate of 3 ns (20%/80%).
- Output timing valid for maximum external load CL = 25 pF, which is assumed to be a 10 pF load at the end of a 50 ohm, unterminated, 5-inch microstrip trace on standard FR4 (3.3 pF/inch), (25 pF total with margin). For best signal integrity, the series resistance in the transmission line should be equal to the selected RDSON of the I/O pad output driver.
- In Low-Speed mode, card clock must be lower than 400 kHz, voltage ranges from 2.7 to 3.6 V.
- In Normal (Full) -Speed mode for SD/SDIO card, clock frequency can be any value between 0 – 25 MHz. In High-speed mode, clock frequency can be any value between 0 – 50 MHz.
- In Normal (Full) -Speed mode for MMC card, clock frequency can be any value between 0 – 20 MHz. In High-speed mode, clock frequency can be any value between 0 – 52 MHz.
- To satisfy hold timing, the delay difference between clock input and cmd/data input must not exceed 2 ns.

4.12.1.2 SD3.0/eMMC5.1 (dual data rate) AC timing

Figure 22 depicts the timing of SD3.0/eMMC5.1 (DDR). Table 39 lists the SD3.0/eMMC5.1 (DDR) timing characteristics. Be aware that only DATA is sampled on both edges of the clock (not applicable to CMD).

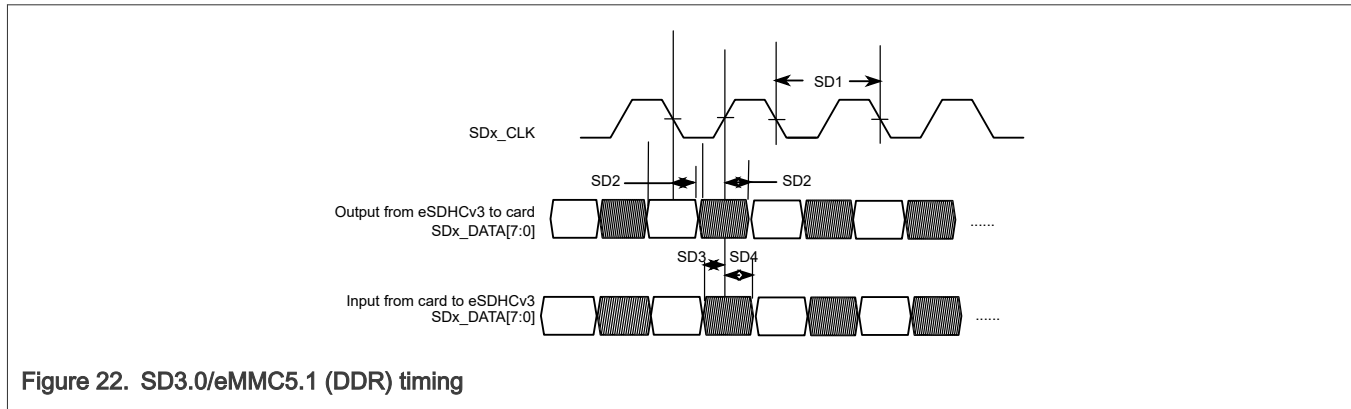


Figure 22. SD3.0/eMMC5.1 (DDR) timing

Table 39. SD3.0/eMMC5.1 (DDR) interface timing specification^{1,2}

ID	Parameter	Symbols	Min	Max	Unit
Card Input Clock					
SD1	Clock Frequency (eMMC5.1 DDR)	f_{PP}	0	52	MHz
SD1	Clock Frequency (SD3.0 DDR)	f_{PP}	0	50	MHz
uSDHC Output / Card Inputs SD_CMD, SDx_DATAx (Reference to CLK)					
SD2	uSDHC Output Delay	t_{OD}	2.8	6.8	ns
uSDHC Input / Card Outputs SD_CMD, SDx_DATAx (Reference to CLK)					
SD3	uSDHC Input Setup Time	t_{ISU}	2.4	—	ns
SD4	uSDHC Input Hold Time	t_{IH}	1.5	—	ns

1. Input timing assumes an input signal slew rate of 3 ns (20%/80%).
2. Output timing valid for maximum external load CL = 25 pF, which is assumed to be a 10 pF load at the end of a 50 ohm, unterminated, 5-inch microstrip trace on standard FR4 (1.5 pF/inch), (25 pF total with margin). For best signal integrity, the series resistance in the transmission line should be equal to the selected RDSON of the I/O pad output driver.

4.12.1.3 HS400 DDR AC timing

Figure 23 depicts the timing of HS400 mode, Table 40 and Table 41 list the HS400 timing characteristics. Be aware that only data is sampled on both edges of the clock (not applicable to CMD). The CMD input/output timing for HS400 mode is the same as CMD input/output timing for SDR104 mode. Check SD5, SD6, and SD7 parameters in Table 45 for HS400 mode.

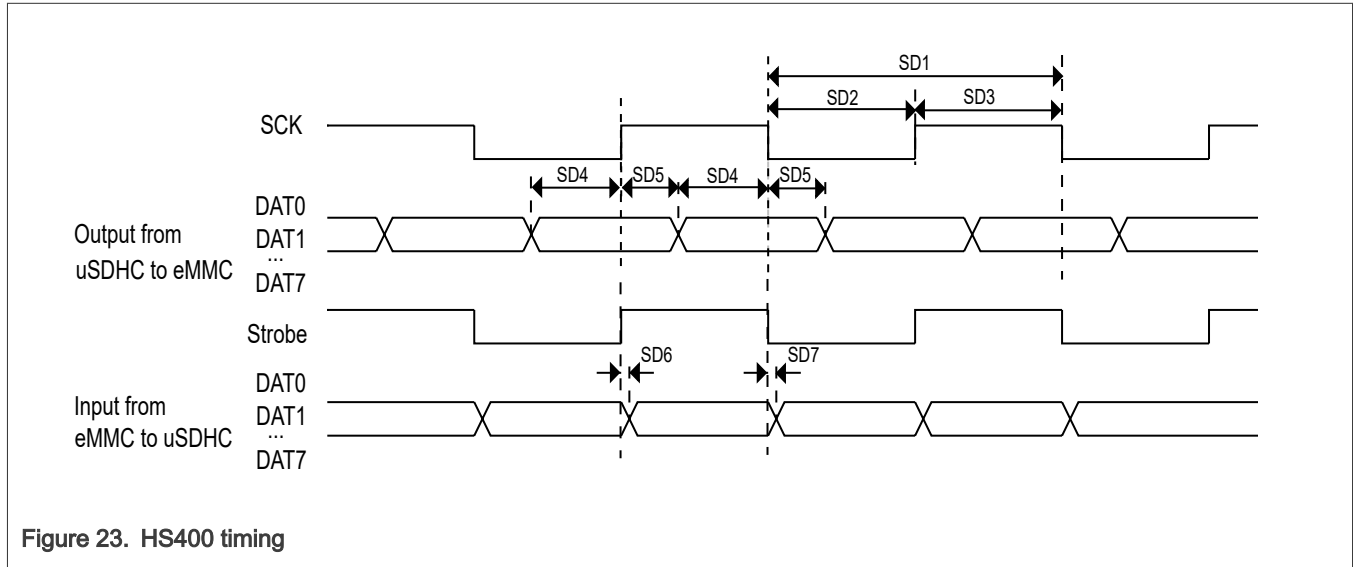


Figure 23. HS400 timing

Table 40. HS400 interface timing specification (Nominal mode)^{1,2}

ID	Parameter	Symbols	Min	Max	Unit
Card Input Clock					
SD1	Clock frequency	f_{PP}	0	200	MHz
SD2	Clock low time	t_{CL}	2.2	—	ns
SD3	Clock high time	t_{CH}	2.2	—	ns
uSDHC Output/Card Inputs DAT (Reference to SCK)					
SD4	Output skew from data to edge of SCK	t_{OSkew1}	0.45	—	ns
SD5	Output skew from edge of SCK to data	t_{OSkew2}	0.45	—	ns
uSDHC Input/Card Outputs DAT (Reference to Strobe)					
SD6	uSDHC input skew	t_{RQ}	—	0.45	ns
SD7	uSDHC hold skew	t_{RQH}	—	0.45	ns

1. Input timing assumes an input signal slew rate of 1 ns (20%/80%).
2. Output timing valid for maximum external load $CL = 15$ pF, which is assumed to be a 10 pF load at the end of a 50 ohm, unterminated, 2-inch microstrip trace on standard FR4 (3.3 pF/inch). For best signal integrity, the series resistance of the transmission line should be matched closely to the $RDSON$ of the I/O pad output driver.

Table 41. HS400 interface timing specification (Low drive mode)^{1,2}

ID	Parameter	Symbols	Min	Max	Unit
Card Input Clock					
SD1	Clock frequency	f_{PP}	0	133	MHz

Table continues on the next page...

Table 41. HS400 interface timing specification (Low drive mode)^{1,2} ...continued

ID	Parameter	Symbols	Min	Max	Unit
SD2	Clock low time	t_{CL}	3.3	—	ns
SD3	Clock high time	t_{CH}	3.3	—	ns
uSDHC Output/Card Inputs DAT (Reference to SCK)					
SD4	Output skew from data of edge of SCK	t_{OSkew1}	0.675	—	ns
SD5	Output skew from edge of SCK to data	t_{OSkew2}	0.675	—	ns
uSDHC Input/Card Outputs DAT (Reference to Strobe)					
SD6	uSDHC input skew	t_{RQ}	—	0.675	ns
SD7	uSDHC hold skew	t_{RQH}	—	0.675	ns

1. Input timing assumes an input signal slew rate of 1 ns (20%/80%).
2. Output timing valid for maximum external load $CL = 15$ pF, which is assumed to be a 10 pF load at the end of a 50 ohm, unterminated, 2-inch microstrip trace on standard FR4 (3.3 pF/inch). For best signal integrity, the series resistance of the transmission line should be matched closely to the R_{DSON} of the I/O pad output driver.

4.12.1.4 HS200 Mode AC timing

Figure 24 depicts the timing of HS200 mode, Table 42 and Table 43 list the HS200 timing characteristics.

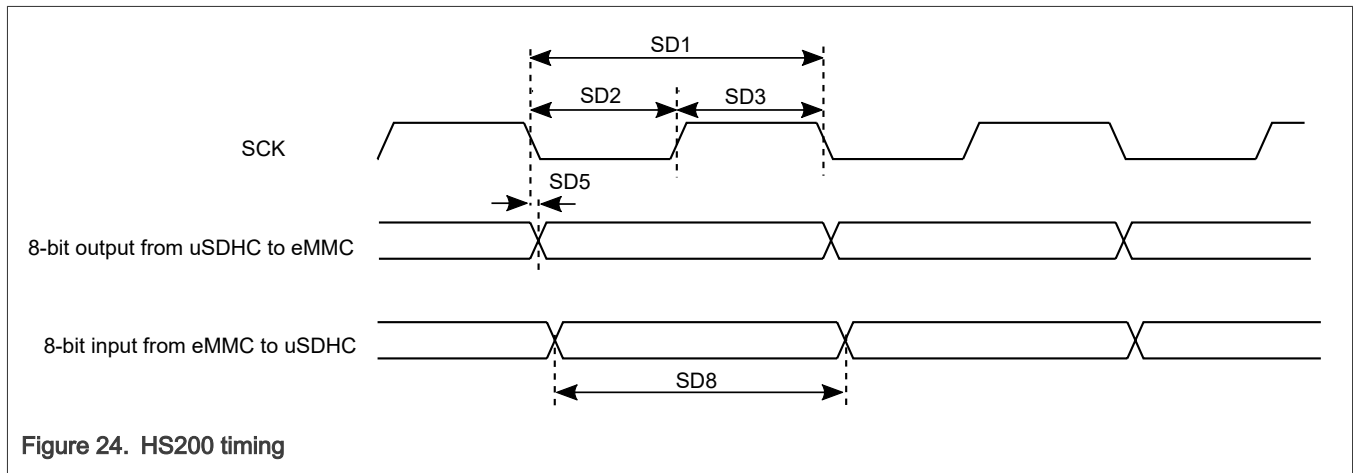


Figure 24. HS200 timing

Table 42. HS200 interface timing specification (Nominal mode)^{1,2}

ID	Parameter	Symbols	Min	Max	Unit
Card Input Clock					
SD1	Clock Frequency Period	t_{CLK}	5.0	—	ns
SD2	Clock Low Time	t_{CL}	2.2	—	ns
SD3	Clock High Time	t_{CH}	2.2	—	ns

Table continues on the next page...

Table 42. HS200 interface timing specification (Nominal mode)^{1,2}...continued

ID	Parameter	Symbols	Min	Max	Unit
uSDHC Output/Card Inputs SD_CMD, SDx_DATAx in HS200 (Reference to CLK)					
SD5	uSDHC Output Delay	t_{OD}	-1.6	1	ns
uSDHC Input/Card Outputs SD_CMD, SDx_DATAx in HS200 (Reference to CLK)³					
SD8	uSDHC Input Data Window	t_{ODW}	$0.475 \times t_{CLK}$	—	ns

1. Input timing assumes an input signal slew rate of 1 ns (20%/80%).
2. Output timing valid for maximum external load CL = 15 pF, which is assumed to be a 10 pF load at the end of a 50 ohm, unterminated, 2-inch microstrip trace on standard FR4 (3.3 pF/inch). For best signal integrity, the series resistance of the transmission line should be matched closely to the RDSON of the I/O pad output driver.
3. HS200 is for 8 bits while SDR104 is for 4 bits.

Table 43. HS200 interface timing specification (Low drive mode)^{1,2}

ID	Parameter	Symbols	Min	Max	Unit
Card Input Clock					
SD1	Clock Frequency Period	t_{CLK}	7.5	—	ns
SD2	Clock Low Time	t_{CL}	3.3	—	ns
SD3	Clock High Time	t_{CH}	3.3	—	ns
uSDHC Output/Card Inputs SD_CMD, SDx_DATAx in HS200 (Reference to CLK)					
SD5	uSDHC Output Delay	t_{OD}	-1.6	1	ns
uSDHC Input/Card Outputs SD_CMD, SDx_DATAx in HS200 (Reference to CLK)³					
SD8	uSDHC Input Data Window	t_{ODW}	$0.475 \times t_{CLK}$	—	ns

1. Input timing assumes an input signal slew rate of 1 ns (20%/80%).
2. Output timing valid for maximum external load CL = 15 pF, which is assumed to be a 10 pF load at the end of a 50 ohm, unterminated, 2-inch microstrip trace on standard FR4 (3.3 pF/inch). For best signal integrity, the series resistance of the transmission line should be matched closely to the RDSON of the I/O pad output driver.
3. HS200 is for 8 bits while SDR104 is for 4 bits.

4.12.1.5 SDR50/SDR104 AC timing

Figure 25 depicts the timing of SDR50/SDR104, Table 44 and Table 45 list the SDR50/SDR104 timing characteristics.

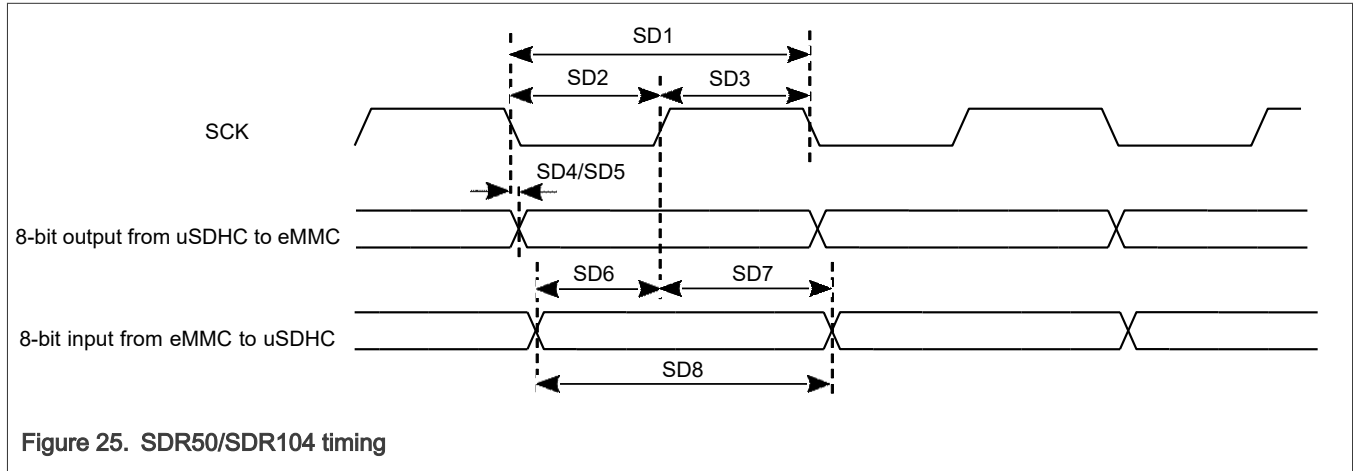


Figure 25. SDR50/SDR104 timing

Table 44. SDR50/SDR104 interface timing specification (Nominal mode)^{1,2}

ID	Parameter	Symbols	Min	Max	Unit
Card Input Clock					
SD1	Clock Frequency Period	t_{CLK}	5	—	ns
SD2	Clock Low Time	t_{CL}	2.2	—	ns
SD3	Clock High Time	t_{CH}	2.2	—	ns
uSDHC Output/Card Inputs SD_CMD, SDx_DATAx in SDR50 (Reference to CLK)					
SD4	uSDHC Output Delay	t_{OD}	-3	1	ns
uSDHC Output/Card Inputs SD_CMD, SDx_DATAx in SDR104 (Reference to CLK)					
SD5	uSDHC Output Delay	t_{OD}	-1.6	1	ns
uSDHC Input/Card Outputs SD_CMD, SDx_DATAx in SDR50 (Reference to CLK)					
SD6	uSDHC Input Setup Time	t_{ISU}	2.4	—	ns
SD7	uSDHC Input Hold Time	t_{IH}	1.5	—	ns
uSDHC Input/Card Outputs SD_CMD, SDx_DATAx in SDR104 (Reference to CLK)³					
SD8	uSDHC Input Data Window	t_{ODW}	$0.5 \times t_{CLK}$	—	ns

1. Input timing assumes an input signal slew rate of 1 ns (20%/80%).
2. Output timing valid for maximum external load $CL = 15$ pF, which is assumed to be a 10 pF load at the end of a 50 ohm, unterminated, 2-inch microstrip trace on standard FR4 (3.3 pF/inch). For best signal integrity, the series resistance of the transmission line should be matched closely to the R_{DSON} of the I/O pad output driver.
3. Data window in SDR100 mode is variable.

Table 45. SDR50/SDR104 interface timing specification (Low drive mode)^{1,2}

ID	Parameter	Symbols	Min	Max	Unit
Card Input Clock					
SD1	Clock Frequency Period	t_{CLK}	7.5	—	ns
SD2	Clock Low Time	t_{CL}	3.3	—	ns
SD3	Clock High Time	t_{CH}	3.3	—	ns
uSDHC Output/Card Inputs SD_CMD, SDx_DATAx in SDR50 (Reference to CLK)					
SD4	uSDHC Output Delay	t_{OD}	-3	1	ns
uSDHC Output/Card Inputs SD_CMD, SDx_DATAx in SDR104 (Reference to CLK)					
SD5	uSDHC Output Delay	t_{OD}	-1.6	1	ns
uSDHC Input/Card Outputs SD_CMD, SDx_DATAx in SDR50 (Reference to CLK)					
SD6	uSDHC Input Setup Time	t_{ISU}	2.4	—	ns
SD7	uSDHC Input Hold Time	t_{IH}	1.5	—	ns
uSDHC Input/Card Outputs SD_CMD, SDx_DATAx in SDR104 (Reference to CLK)³					
SD8	uSDHC Input Data Window	t_{ODW}	$0.5 \times t_{CLK}$	—	ns

1. Input timing assumes an input signal slew rate of 1 ns (20%/80%).
2. Output timing valid for maximum external load CL = 15 pF, which is assumed to be a 10 pF load at the end of a 50 ohm, unterminated, 2-inch microstrip trace on standard FR4 (3.3 pF/inch). For best signal integrity, the series resistance of the transmission line should be matched closely to the RDSON of the I/O pad output driver.
3. Data window in SDR100 mode is variable.

4.12.1.6 Bus operation condition for 3.3 V and 1.8 V signaling

Signaling level of SD/eMMC4.5/5.0/5.1 can be 1.8 V or 3.3 V depending on the working mode. The DC parameters for NVCC_SD2 supplies are identical to those shown in [General purpose I/O \(GPIO\) DC parameters](#).

4.12.1.7 uSDHC supported modes

For SD:

- All SD 3.0 protocols are supported at full speeds on all three SDHC interfaces. This includes DS, HS, SDR12, SDR25, SDR50, SDR104, and DDR50.
- The maximum supported SDR frequency is 200 MHz which is covered in SDR104 mode, and maximum DDR frequency is 50 MHz as a part of DDR50 mode.

For eMMC:

- eMMC HS400 is only supported on SDHC1 as that is the only one with 8-bit interface.
- eMMC HS200 is supported on all three SDHC interfaces because this protocol supports both a 4-bit mode and an 8-bit mode, which can work on SDHC2 and SDHC3.
- eMMC High Speed DDR, High Speed SDR, and the less than or equal to 26 MHz MMC legacy protocols are also supported on all three SDHC interfaces.

- The maximum supported SDR frequency is 200 MHz which is covered in HS200 mode, and the maximum DDR frequency is 200 MHz as a part of HS400 mode.

uSDHC3 supports up to SDR104 (200 MHz) on primary SD3_* pins, but when it is multiplexing on GPIO_IO[27:22], below are the modes supported:

- eMMC High Speed DDR, High Speed SDR, and the less than or equal to 26 MHz MMC legacy protocols are supported.
- SDR50 (100 MHz) and SDR104 (200 MHz) modes are NOT supported.
- eMMC HS400 and HS200 modes are NOT supported
- The maximum supported SDR and DDR frequency is 50 and 52 MHz

If IO is supplied by 3.3 V, the maximum supported SDR/DDR frequency is 50/52 MHz

4.12.2 Ethernet controller (ENET) AC electrical specifications

Ethernet supports the following key features:

- Support ENET AVB
- Support IEEE 1588
- Support Energy Efficient Ethernet (EEE)
- 1.8 V/3.3 V RMI operation, 1.8 V RGMII operation

The following sections introduce the ENET AC electrical specifications.

4.12.2.1 ENET2 signal mapping

The following timing specs are defined at the chip I/O pin and must be translated appropriately to arrive at timing specifications and constraints for the physical interface.

Table 46. ENET2 signal mapping¹

Pad name	RGMII	Alt mode	RMII	Alt mode	Direction
ENET2_MDC	RGMII_MDC	Alt 0	RMII_MDC	Alt 0	O
ENET2_MDIO	RGMII_MDIO	Alt 0	RMII_MDIO	Alt 0	I/O
ENET2_TXC	RGMII_TXC	Alt 0	RMII_TX_ER	Alt 1	O
ENET2_TX_CTL	RGMII_TX_CTL	Alt 0	RMII_TX_EN	Alt 0	O
ENET2_TD0	RGMII_TD0	Alt 0	RMII_TD0	Alt 0	O
ENET2_TD1	RGMII_TD1	Alt 0	RMII_TD1	Alt 0	O
ENET2_TD2	RGMII_TD2	Alt 0	RMII_REF_CLK ²	Alt 1	I/O
ENET2_TD3	RGMII_TD3	Alt 0	—	Alt 0	O
ENET2_RXC	RGMII_RXC	Alt 0	RMII_RX_ER	Alt 1	I
ENET2_RX_CTL	RGMII_RX_CTL	Alt 0	RMII_CRSDV	Alt 0	I
ENET2_RD0	RGMII_RD0	Alt 0	RMII_RD0	Alt 0	I

Table continues on the next page...

Table 46. ENET2 signal mapping^{1...continued}

Pad name	RGMII	Alt mode	RMII	Alt mode	Direction
ENET2_RD1	RGMII_RD1	Alt 0	RMII_RD1	Alt 0	I
ENET2_RD2	RGMII_RD2	Alt 0	—	Alt 0	I
ENET2_RD3	RGMII_RD3	Alt 0	—	Alt 0	I

1. ENET1 is Ethernet QoS with TSN, while ENET2 is Ethernet MAC.
2. The signal can be either input or output.

4.12.2.2 RMII mode timing

In RMII mode, RMII_REF_CLK is a 50 MHz ± 50 ppm continuous reference clock.

Figure 26 shows RMII mode timing parameters. Table 47 describes the timing parameters (M16–M21) shown in the figure.

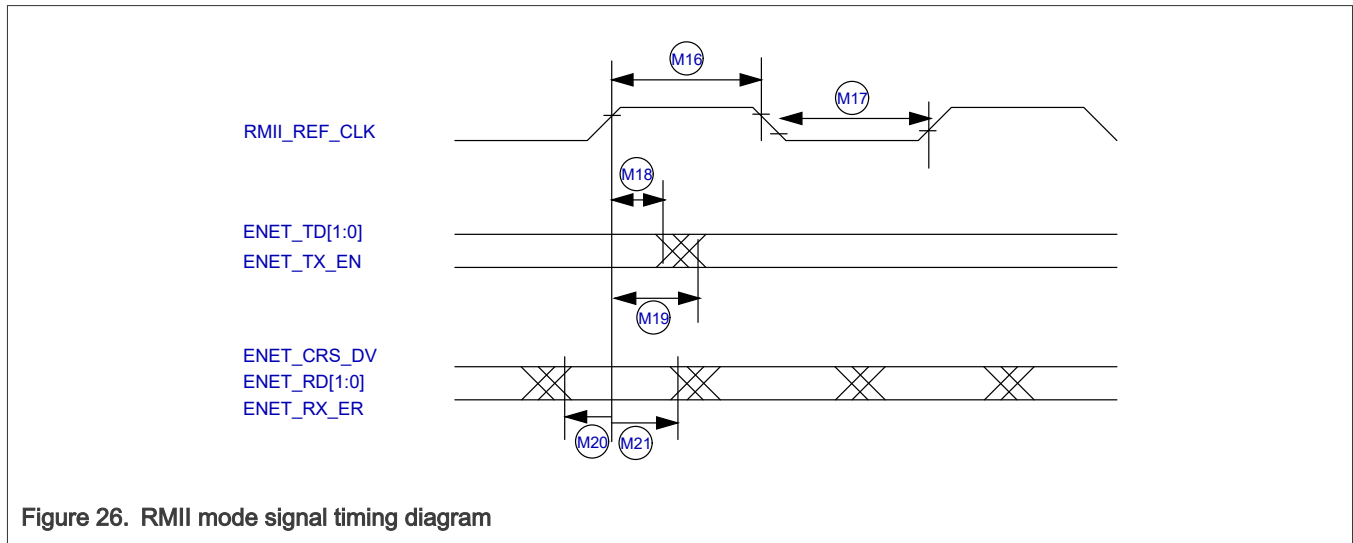


Figure 26. RMII mode signal timing diagram

Table 47. RMII signal timing^{1,2,3}

ID	Characteristic	Min.	Max.	Unit
M16	RMII_REF_CLK pulse width high	35%	65%	RMII_REF_CLK period
M17	RMII_REF_CLK pulse width low	35%	65%	RMII_REF_CLK period
M18	RMII_REF_CLK to ENET0_TXD[1:0], ENET_TX_EN invalid	2	—	ns
M19	RMII_REF_CLK to ENET0_TXD[1:0], ENET_TX_EN valid	—	14	ns
M20	ENET_RX_DATA[1:0], ENET_CRS_DV, ENET_RX_ER to RMII_REF_CLK setup	4	—	ns
M21	RMII_REF_CLK to ENET_RX_DATA[1:0], ENET_CRS_DV, ENET_RX_ER hold	2	—	ns

1. The timings assume the following configuration: DSE[5:0] = 001111 and FSEL1[1:0] = 11.

2. Input timing assumes an input signal slew rate of 3 ns (20%/80%).
3. Output timing valid for maximum external load CL = 25 pF, which is assumed to be a 10 pF load at the end of a 50 ohm, unterminated, 5-inch microstrip trace on standard FR4 (3.3 pF/inch), (25 pF total with margin). For best signal integrity, the series resistance in the transmission line should be equal to the selected RDSON of the I/O pad output driver.

4.12.2.3 MII serial management channel timing (ENET_MDIO and ENET_MDC)

The MDC frequency is designed to be equal to or less than 2.5 MHz to be compatible with the IEEE 802.3 MII specification.

Figure 27 shows MII asynchronous input timings. Table 48 describes the timing parameters (M10–M15) shown in the figure.

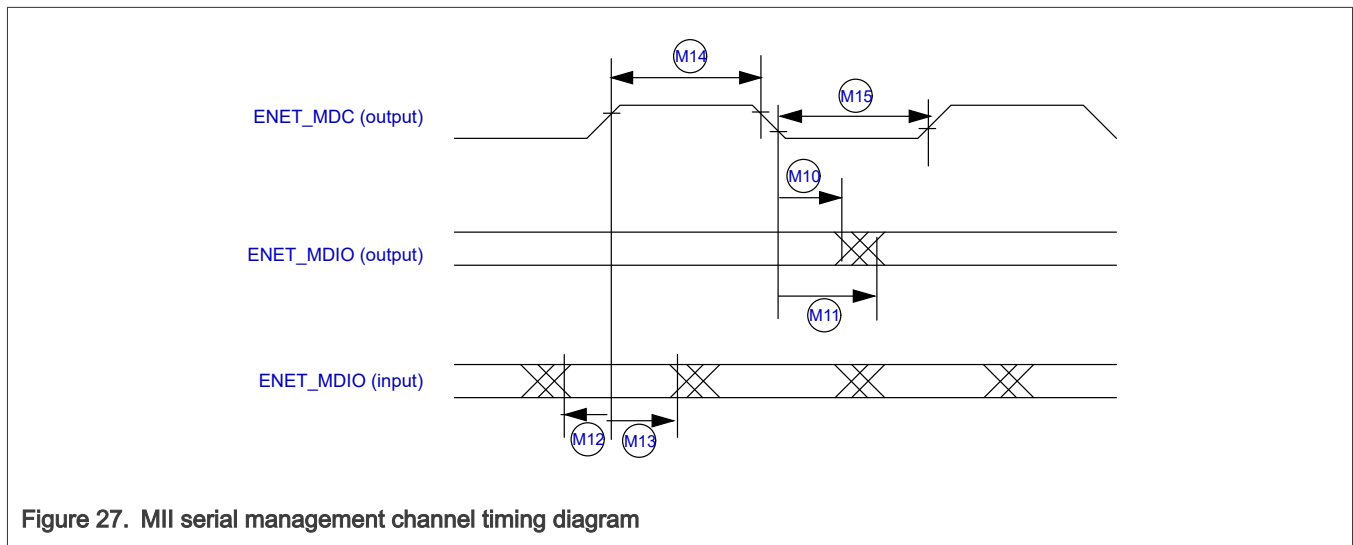


Figure 27. MII serial management channel timing diagram

Table 48. MII serial management channel timing^{1,2,3}

ID	Characteristic	Min.	Max.	Unit
M10	ENET_MDC falling edge to ENET_MDIO output invalid (min. propagation delay)	-1.5	—	ns
M11	ENET_MDC falling edge to ENET_MDIO output valid (max. propagation delay)	—	13	ns
M12	ENET_MDIO (input) to ENET_MDC rising edge setup	13	—	ns
M13	ENET_MDIO (input) to ENET_MDC rising edge hold	0	—	ns
M14	ENET_MDC pulse width high	40%	60%	ENET_MDC period
M15	ENET_MDC pulse width low	40%	60%	ENET_MDC period

1. The timings assume the following configuration: DSE[5:0] = 001111 and FSEL1[1:0] = 11.
2. Input timing assumes an input signal slew rate of 3 ns (20%/80%).
3. Output timing valid for maximum external load CL = 25 pF, which is assumed to be a 10 pF load at the end of a 50 ohm. Unterminated, 5-inch microstrip trace on standard FR4 (3.3 pF/inch), (25 pF total with margin). For best signal integrity, the series resistance in the transmission line should be equal to the selected RDSON of the I/O pad output driver.

4.12.2.4 RGMII signal switching specifications

The following timing specifications meet the requirements for RGMII interfaces for a range of transceiver devices.

Table 49. RGMII signal switching specifications^{1,2,3,4}

Symbol	Description	Min.	Max.	Unit
T_{cyc}	Clock cycle duration	7.2	8.8	ns
T_{skewT}	Data to clock output skew at transmitter	-500	500	ps
T_{skewR}	Data to clock input skew at receiver	1	2.6	ns
Duty_G	Duty cycle for Gigabit	45	55	%
Duty_T	Duty cycle for 10/100T	40	60	%

1. The timings assume the following configuration: DSE[5:0] = 001111 and FSEL1[1:0] = 11.
2. Measured as defined in *EIA/JESD 8-6 1995* with a timing threshold voltage of $VDDQ/2$.
3. Output timing valid for maximum external load $CL = 15\text{ pF}$, which is assumed to be a 8 pF load at the end of a 50 ohm , unterminated, 2-inch microstrip trace on standard FR4 (3.3 pF/inch). For best signal integrity, the series resistance in the transmission line should be matched closely to the selected $RDSON$ of the I/O pad output driver.
4. RGMII timing specifications are only valid for 1.8 V nominal I/O pad supply voltage.

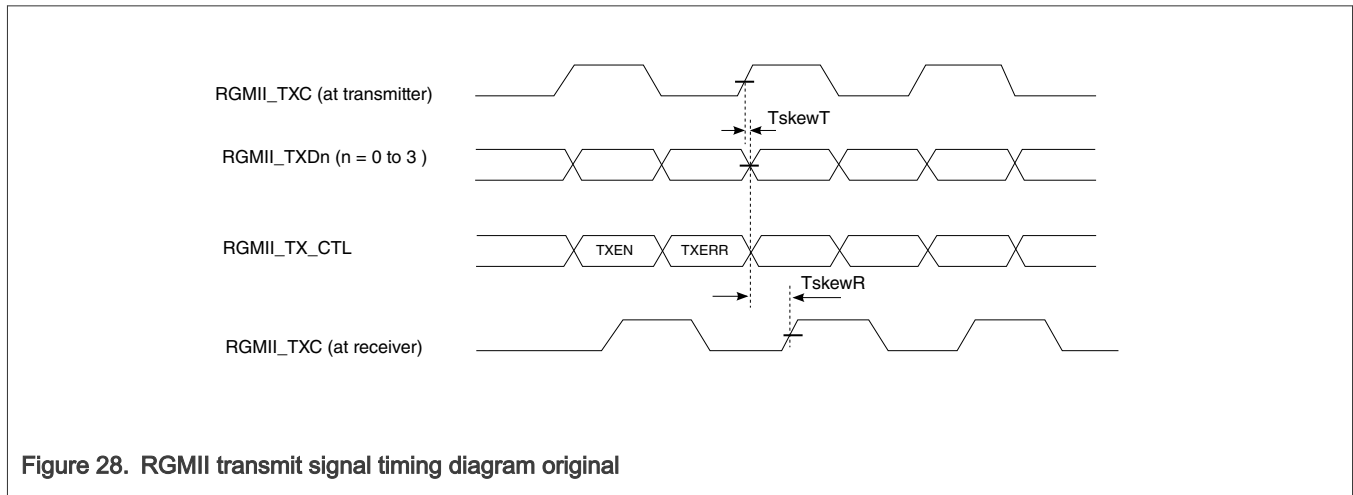


Figure 28. RGMII transmit signal timing diagram original

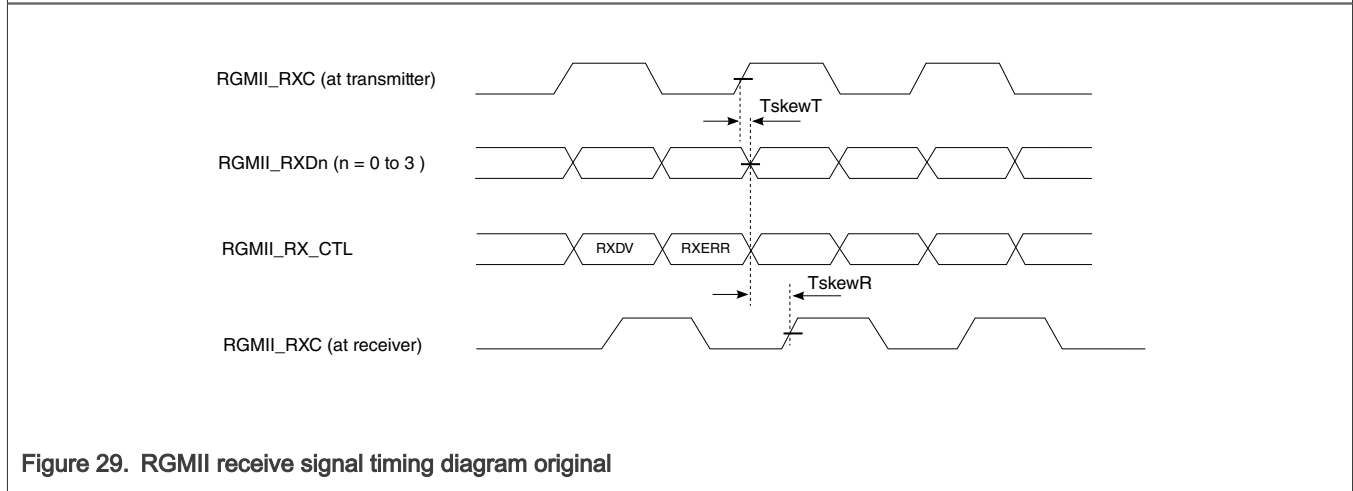


Figure 29. RGMII receive signal timing diagram original

4.12.3 Ethernet Quality-of-Service (QoS) electrical specifications

Ethernet QoS supports the following Time Sensitive Networking (TSN) features:

- 802.1Qbv Enhancements to Scheduling Traffic
- 802.1Qbu Frame preemption
- Time based Scheduling
- 1.8 V/3.3 V RMIi operation, 1.8 V RGMII operation

4.12.3.1 Ethernet QoS signal mapping

The following timing specs are defined at the chip I/O pin and must be translated appropriately to arrive at timing specs/constraints for the physical interface.

Table 50. ENET QoS signal mapping¹

Pad name	RGMII	Alt mode	RMII	Alt mode	Direction
ENET1_MDC	RGMII_MDC	Alt 0	RMII_MDC	Alt 0	O
ENET1_MDIO	RGMII_MDIO	Alt 0	RMII_MDIO	Alt 0	I/O
ENET1_TXC	RGMII_TXC	Alt 0	RMII_TX_ER	Alt 1	O
ENET1_TX_CTL	RGMII_TX_CTL	Alt 0	RMII_TX_EN	Alt 0	O
ENET1_TD0	RGMII_TD0	Alt 0	RMII_TD0	Alt 0	O
ENET1_TD1	RGMII_TD1	Alt 0	RMII_TD1	Alt 0	O
ENET1_TD2	RGMII_TD2	Alt 0	RMII_REF_CLK ²	Alt 1	I/O
ENET1_TD3	RGMII_TD3	Alt 0	—	Alt 0	O
ENET1_RXC	RGMII_RXC	Alt 0	RMII_RX_ER	Alt 1	I
ENET1_RX_CTL	RGMII_RX_CTL	Alt 0	RMII_CRSDV	Alt 0	I
ENET1_RD0	RGMII_RD0	Alt 0	RMII_RD0	Alt 0	I
ENET1_RD1	RGMII_RD1	Alt 0	RMII_RD1	Alt 0	I
ENET1_RD2	RGMII_RD2	Alt 0	—	Alt 0	I
ENET1_RD3	RGMII_RD3	Alt 0	—	Alt 0	I

1. ENET1 is Ethernet QoS with TSN, while ENET2 is Ethernet MAC.
2. The signal can be either input or output.

4.12.3.2 RMII mode timing

In RMII mode, RMII_REF_CLK is a 50 MHz ± 50 ppm continuous reference clock.

Figure 30 shows RMII mode timing parameters. Table 51 describes the timing parameters (M16–M21) shown in the figure.

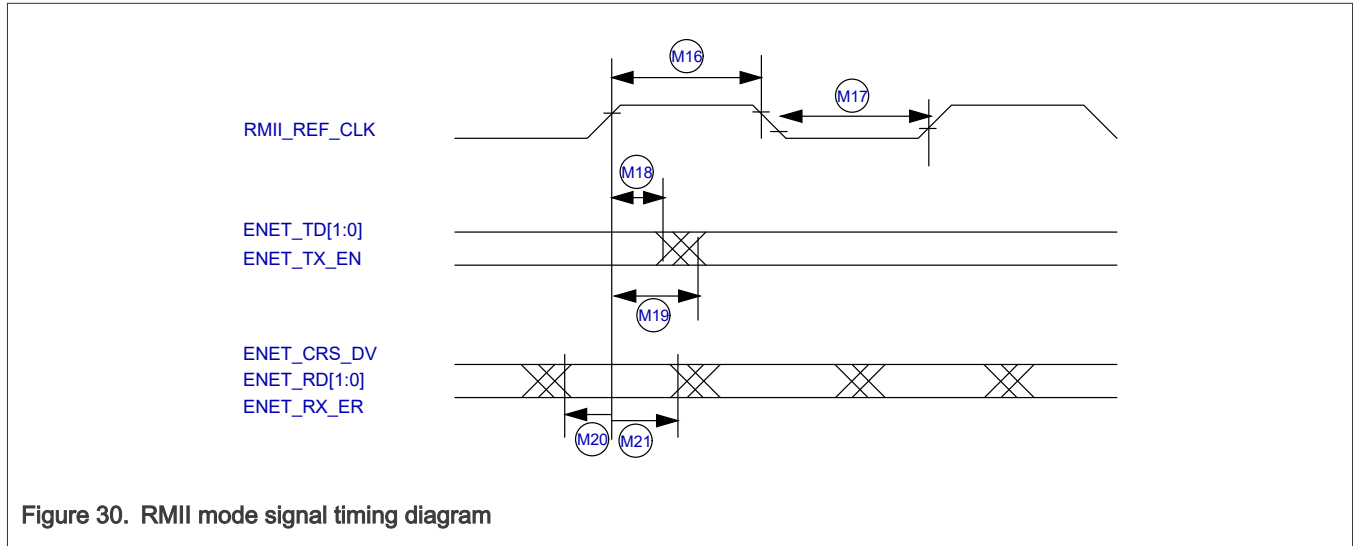


Figure 30. RMI mode signal timing diagram

Table 51. RMI signal timing^{1,2,3}

ID	Characteristic	Min.	Max.	Unit
M16	RMI_REF_CLK pulse width high	35%	65%	RMI_REF_CLK period
M17	RMI_REF_CLK pulse width low	35%	65%	RMI_REF_CLK period
M18	RMI_REF_CLK to ENET0_TXD[1:0], ENET_TX_EN invalid	2	—	ns
M19	RMI_REF_CLK to ENET0_TXD[1:0], ENET_TX_EN valid	—	14	ns
M20	ENET_RX_DATA[1:0], ENET_CRD[1:0], ENET_RX_ER to RMI_REF_CLK setup	4	—	ns
M21	RMI_REF_CLK to ENET_RX_DATA[1:0], ENET_CRD[1:0], ENET_RX_ER hold	2	—	ns

1. The timings assume the following configuration: DSE[5:0] = 001111 and FSEL1[1:0] = 11.
2. Input timing assumes an input signal slew rate of 3 ns (20%/80%).
3. Output timing valid for maximum external load CL = 25 pF, which is assumed to be a 10 pF load at the end of a 50 ohm, unterminated, 5-inch microstrip trace on standard FR4 (3.3 pF/inch), (25 pF total with margin). For best signal integrity, the series resistance in the transmission line should be equal to the selected RDSON of the I/O pad output driver.

4.12.3.3 MII serial management channel timing (ENET_MDIO and ENET_MDC)

The MDC frequency is designed to be equal to or less than 2.5 MHz to be compatible with the IEEE 802.3 MII specification.

Figure 31 shows MII asynchronous input timings. Table 52 describes the timing parameters (M10–M15) shown in the figure.

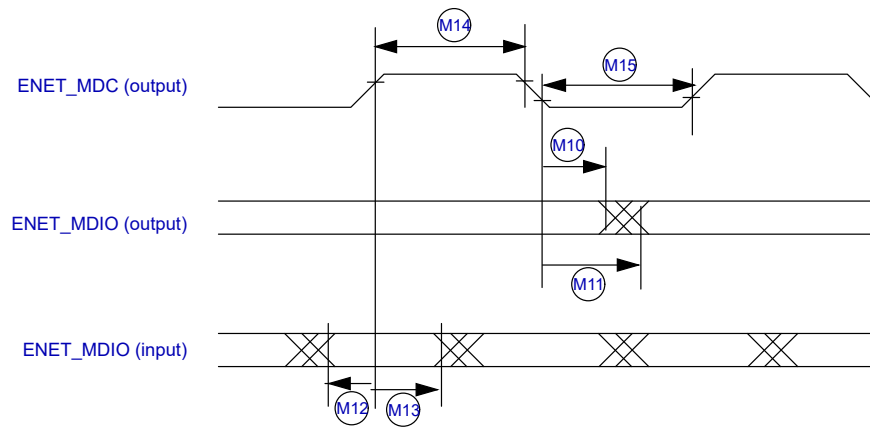


Figure 31. MII serial management channel timing diagram

Table 52. MII serial management channel timing^{1,2,3}

ID	Characteristic	Min.	Max.	Unit
M10	ENET_MDC falling edge to ENET_MDIO output invalid (min. propagation delay)	-1.5	—	ns
M11	ENET_MDC falling edge to ENET_MDIO output valid (max. propagation delay)	—	13	ns
M12	ENET_MDIO (input) to ENET_MDC rising edge setup	13	—	ns
M13	ENET_MDIO (input) to ENET_MDC rising edge hold	0	—	ns
M14	ENET_MDC pulse width high	40%	60%	ENET_MDC period
M15	ENET_MDC pulse width low	40%	60%	ENET_MDC period

1. The timings assume the following configuration: DSE[5:0] = 001111 and FSEL1[1:0] = 11.
2. Input timing assumes an input signal slew rate of 3 ns (20%/80%).
3. Output timing valid for maximum external load CL = 25 pF, which is assumed to be a 10 pF load at the end of a 50 ohm. Unterminated, 5-inch microstrip trace on standard FR4 (3.3 pF/inch), (25 pF total with margin). For best signal integrity, the series resistance in the transmission line should be equal to the selected RDSON of the I/O pad output driver.

4.12.3.4 RGMII signal switching specifications

The following timing specifications meet the requirements for RGMII interfaces for a range of transceiver devices.

Table 53. RGMII signal switching specifications^{1,2,3,4}

Symbol	Description	Min.	Max.	Unit
T _{cyc}	Clock cycle duration	7.2	8.8	ns
T _{skewT}	Data to clock output skew at transmitter	-500	500	ps
T _{skewR}	Data to clock input skew at receiver	1	2.6	ns

Table continues on the next page...

Table 53. RGMII signal switching specifications^{1,2,3,4}...continued

Symbol	Description	Min.	Max.	Unit
Duty_G	Duty cycle for Gigabit	45	55	%
Duty_T	Duty cycle for 10/100T	40	60	%

1. The timings assume the following configuration: DSE[5:0] = 001111 and FSEL1[1:0] = 11.
2. Measured as defined in *EIA/JESD 8-6 1995* with a timing threshold voltage of VDDQ/2.
3. Output timing valid for maximum external load CL = 15 pF, which is assumed to be a 8 pF load at the end of a 50 ohm, unterminated, 2-inch microstrip trace on standard FR4 (3.3 pF/inch). For best signal integrity, the series resistance in the transmission line should be matched closely to the selected RDSON of the I/O pad output driver.
4. RGMII timing specifications are only valid for 1.8 V nominal I/O pad supply voltage.

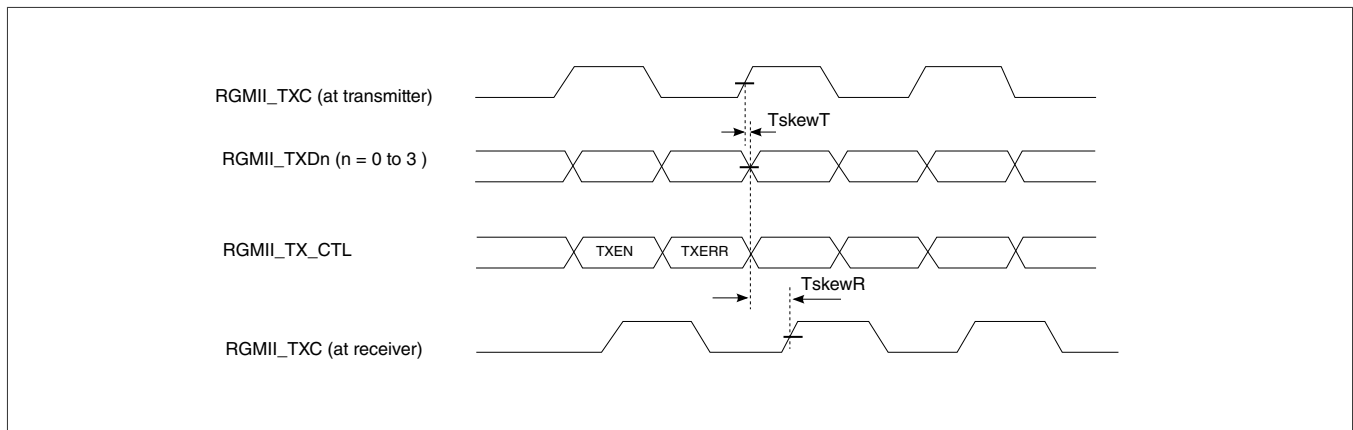


Figure 32. RGMII transmit signal timing diagram original

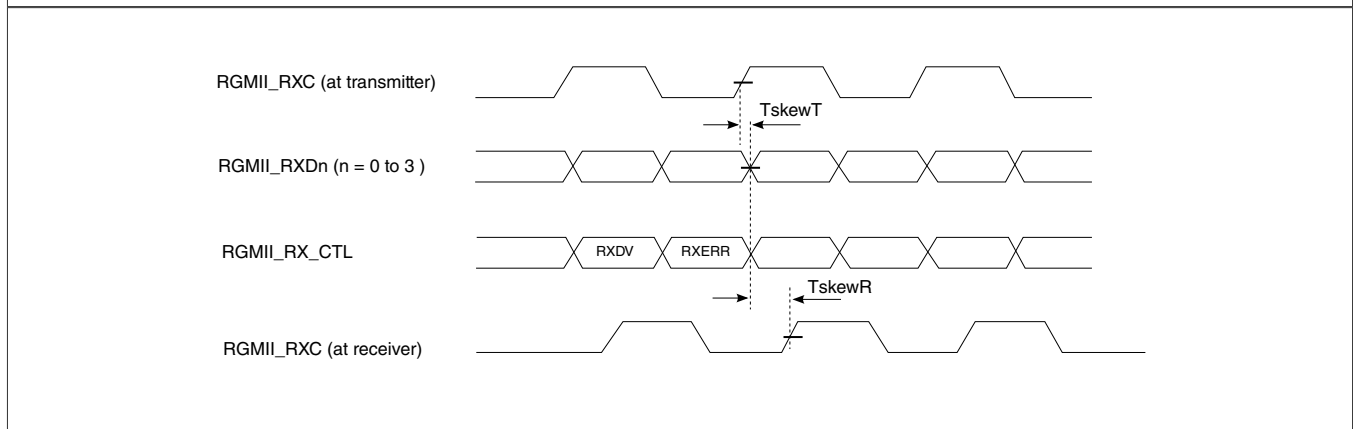


Figure 33. RGMII receive signal timing diagram original

4.12.4 LPSPI timing parameters

The Low Power Serial Peripheral Interface (LPSPI) provides a synchronous serial bus with Controller and Peripheral operations. Many of the transfer attributes are programmable. The following tables provide timing characteristics for classic LPSPI timing modes.

All timing is shown with respect to 20% V_{DD} and 80% V_{DD} thresholds, unless noted, as well as input signal transitions of 3 ns and a 25 pF maximum load on all LPSPI pins.

The DSE[5:0] = 001111 and FSEL1[1:0] = 11 are required drive settings to meet the timing.

Table 54. LPSPI Controller mode timing^{1,2}

Number	Symbol	Description	Min.	Max.	Units	Note
1	f _{SCK}	Frequency of LPSPI clock	—	30	MHz	3
			—	60	MHz	4
2	t _{SCK}	SCK period	2 x t _{periph}	—	ns	5
3	t _{Lead}	Enable lead time	1	—	t _{periph}	—
4	t _{Lag}	Enable lag time	1	—	t _{periph}	—
5	t _{WSCK}	Clock (SCK) high or low time	t _{SCK} / 2 - 3	t _{SCK} / 2 + 3	ns	—
6	t _{SU}	Data setup time (inputs)	8	—	ns	6,7
7	t _{HI}	Data hold time (inputs)	0	—	ns	6
8	t _V	Data valid (after SCK edge)	—	2.5	ns	—
9	t _{HO}	Data hold time (outputs)	-2.5	—	ns	—

1. Input timing assumes an input signal slew rate of 3 ns (20%/80%).
2. Output timing valid for maximum external load CL = 25 pF, which is assumed to be a 10 pF load at the end of a 50 ohm. Unterminated, 5-inch microstrip trace on standard FR4 (3.3 pF/inch), (25 pF total with margin). For best signal integrity, the series resistance in the transmission line should be equal to the selected RDSON of the I/O pad output driver.
3. The clock driver in the LPSPI module for f_{periph} must guaranteed this limit is not exceeded.
4. In Controller loopback mode when LPSPI_CFGR1[SAMPLE] bit is 1.
5. f_{periph} = Functional clock / (2 ^ PRESCALE) and t_{periph} = 1 / f_{periph}
6. If LPSPI_CFGR1[SAMPLE] bit is 1, the data setup time (inputs) / data hold time (inputs) specifications are same with the one in Peripheral mode.
7. For 3.3 V I/O supply, t_{SU} (Data setup time) parameter value is 9 ns in LPSPI Controller mode.

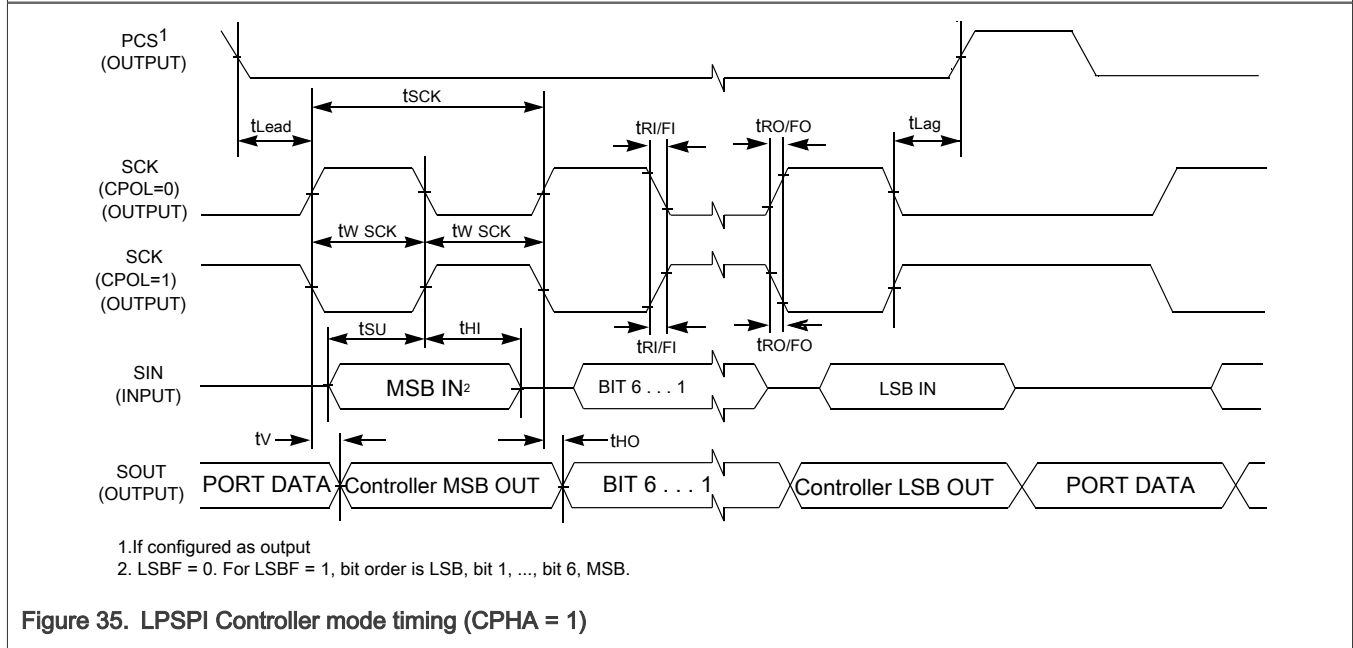
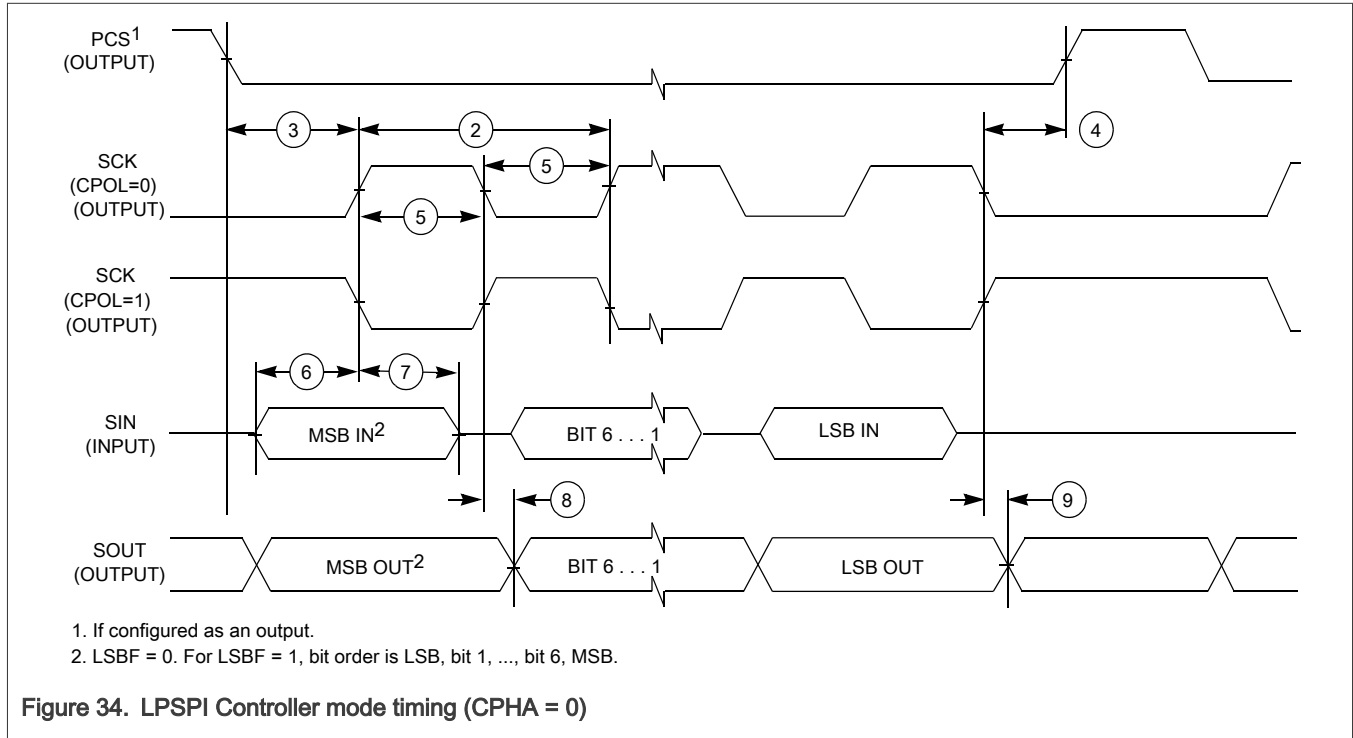


Table 55. LPSPI Peripheral mode timing^{1,2}

Number	Symbol	Description	Min.	Max.	Units	Note
1	f_{SCK}	Frequency of LPSPI clock	0	30	MHz	—
2	t_{SCK}	SCK period	$2 \times t_{periph}$	—	ns	3
3	t_{Lead}	Enable lead time	1	—	t_{periph}	—

Table continues on the next page...

Table 55. LPSPI Peripheral mode timing^{1,2} ...continued

Number	Symbol	Description	Min.	Max.	Units	Note
4	t _{Lag}	Enable lag time	1	—	t _{periph}	—
5	t _{WSCK}	Clock (SCK) high or low time	t _{SCK} / 2 - 5	t _{SCK} / 2 + 5	ns	—
6	t _{SU}	Data setup time (inputs)	3	—	ns	—
7	t _{HI}	Data hold time (inputs)	3	—	ns	—
8	t _a	Peripheral access time	—	20	ns	4
9	t _{dis}	Peripheral MISO disable time	—	20	ns	5
10	t _v	Data valid (after SCK edge)	—	8	ns	6
11	t _{HO}	Data hold time (outputs)	0	—	ns	—

1. Input timing assumes an input signal slew rate of 3 ns (20%/80%).
2. Output timing valid for maximum external load CL = 25 pF, which is assumed to be a 10 pF load at the end of a 50 ohm. Terminated, 5-inch microstrip trace on standard FR4 (3.3 pF/inch), (25 pF total with margin). For best signal integrity, the series resistance in the transmission line should be equal to the selected RDSON of the I/O pad output driver.
3. f_{periph} = Functional clock / (2 ^ PRESCALE) and t_{periph} = 1 / f_{periph}
4. Time to data active from high-impedance state
5. Hold time to high-impedance state
6. When operating at 3.3 V I/O supply, this parameter value is 9 ns.

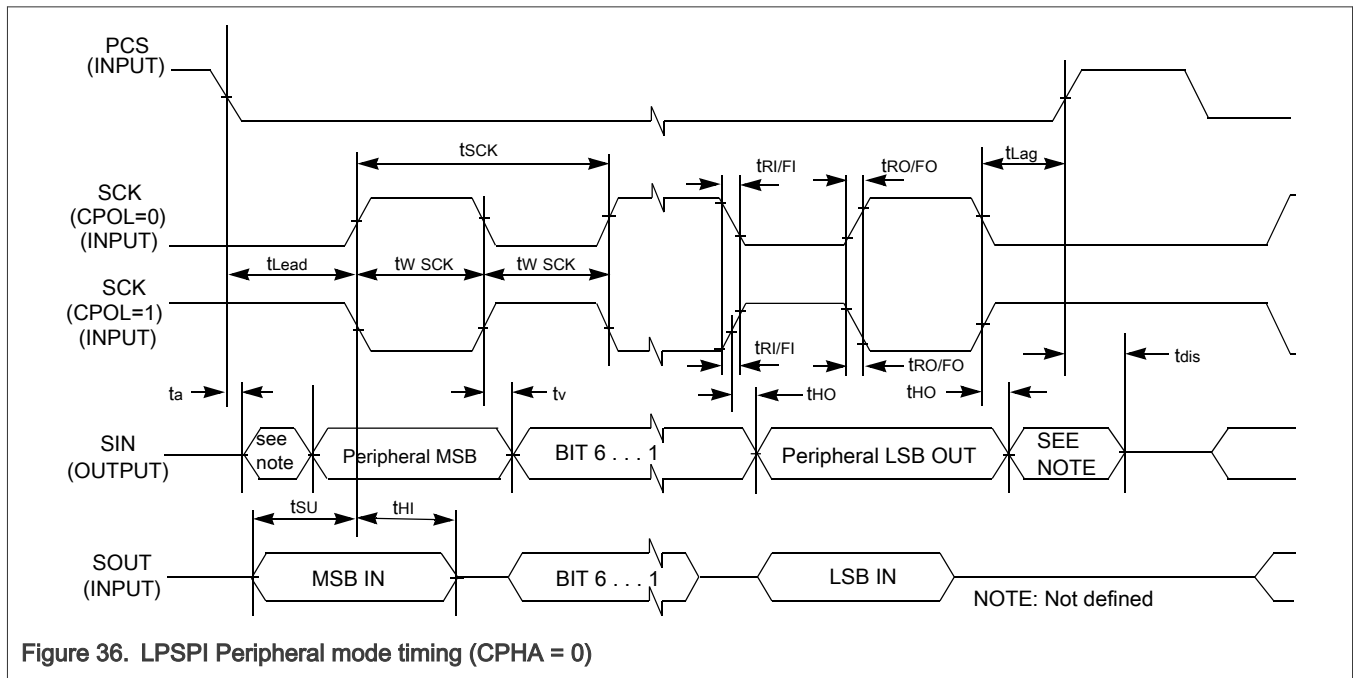
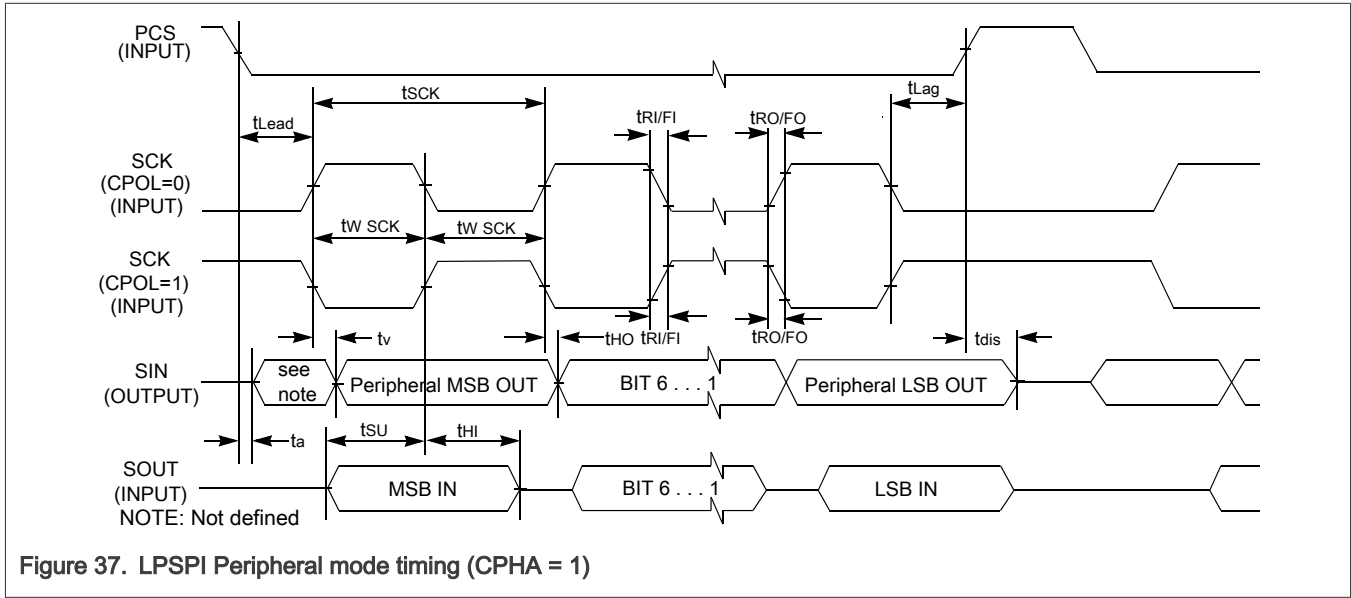


Figure 36. LPSPI Peripheral mode timing (CPHA = 0)



4.12.5 LPI2C timing parameters

This section describes the timing parameters of the LPI2C module.

Table 56. LPI2C module timing parameters¹

Symbol	Description		Min	Max	Unit	Notes
f _{SCL}	SCL clock frequency	Standard mode (Sm)	0	100	kHz	2
		Fast mode (Fm)	0	400		
		Fast mode Plus (Fm+)	0	1000		
		High speed mode (Hs-mode)	0	3400		
		Ultra Fast mode (UFm)	0	5000		

- For more details, see *UM10204 I2C-bus specification and user manual*.
- Standard, Fast, Fast+, and Ultra Fast modes are supported; High speed mode (HS) in target mode.

4.12.6 Improved Inter-Integrated Circuit Interface (I3C) specifications

Unless otherwise specified, I3C specifications are timed to/from the V_{IH} and/or V_{IL} signal points.

The DSE[5:0] = 001111 and FSEL1[1:0] = 11 are required drive settings to meet the timing.

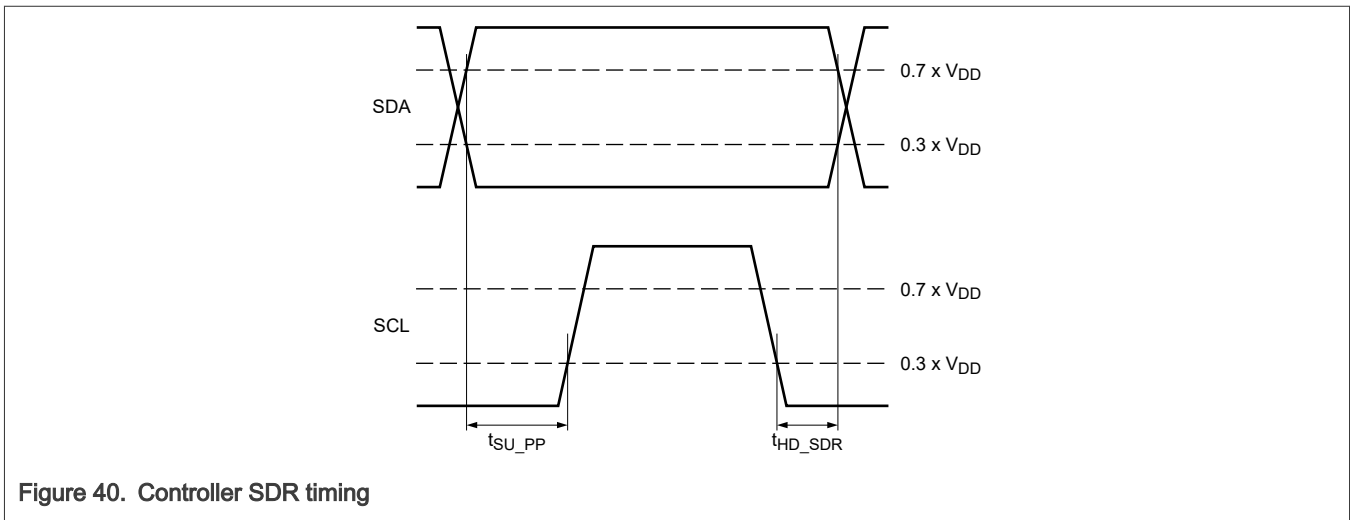
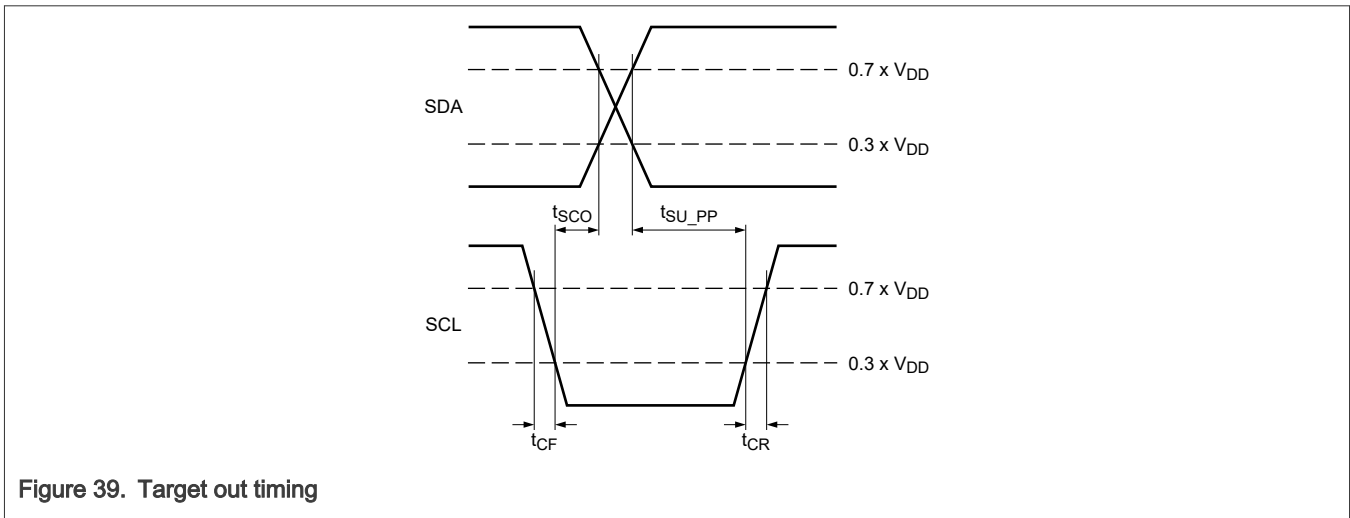
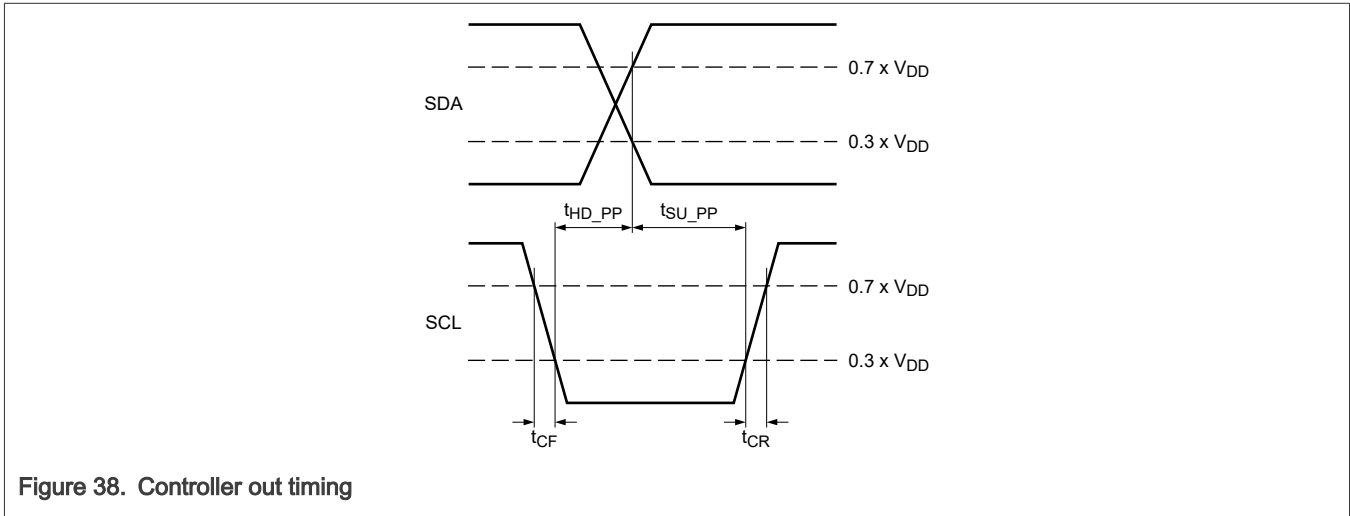
4.12.6.1 I3C Push-Pull Timing Parameters for SDR Mode

I3C interface is not supported on GPIO-Standard-plus pad type for 5 V operation. Measurements are with maximum output load of 30 pf, input transition of 1 ns.

Table 57. I3C Push-Pull Timing Parameters for SDR Mode

Symbol	Description	Min	Typ	Max	Unit	Condition
f_{SCL}	SCL Clock Frequency	0.01	12.5	12.9	MHz	$f_{SCL} = 1 / (t_{DIG_L} + t_{DIG_H})$
t_{DIG_L}	SCL Clock Low Period ^{1,2}	32	—	—	ns	—
t_{DIG_H}	SCL Clock High Period ²	32	—	—	ns	—
t_{SCO}	Clock in to Data Out for Target ^{3,4}	—	—	12	ns	—
t_{CR}	SCL Clock Rise Time ⁵	—	—	150e06 * 1 / f_{SCL} (capped at 60)	ns	—
t_{CF}	SCL Clock Fall Time ⁵	—	—	150e06 * 1 / f_{SCL} (capped at 60)	ns	—
t_{HD_PP}	SDA Signal Data Hold in Push-Pull Mode, Target ^{6,7}	0	—	—	—	Applicable for target and controller loopback modes
t_{SU_PP}	SDA Signal Data Setup in Push-Pull Mode	3	—	N/A	ns	Applicable for target and controller loopback modes

- As both edges are used, the hold time needs to be satisfied for the respective edges; i.e., $t_{CF} + 3$ for falling edge clocks, and $t_{CR} + 3$ for rising edge clocks.
- t_{DIG_L} and t_{DIG_H} are the clock Low and High periods as seen at the receiver end of the I3C Bus using V_{IL} and V_{IH} (see Figure 30)
- Pad delay based on 90 Ω / 4 mA driver and 50 pF load. Note that Controller may be a Target in a multi-Controller system, and thus shall also adhere to this requirement
- Devices with more than 12ns of t_{SCO} delay shall set the limitation bit in the BCR, and shall support the GETMXDS CCC to allow the Controller to read this value and adjust computations accordingly. For purposes of system design and test conformance, this parameter should be considered together with pad delay, bus capacitance, propagation delay, and clock triggering points.
- The clock maximum rise/fall time is capped at 60 ns. For lower frequency rise and fall the maximum value is limited at 60 ns, and is not dependent upon the clock frequency.
- SDA Input Hold time in Target mode is 1 ns.
- t_{HD_PP} is a Hold time parameter for Push-Pull Mode that has a different value for Controller mode vs. Target mode. In SDR Mode the Hold time parameter is referred to as t_{HD_SDR} .



4.12.7 CAN network AC electrical specifications

The Controller Area Network (CAN) module is a communication controller implementing the CAN protocol according to the CAN with Flexible Data rate (CAN FD) protocol and the CAN 2.0B protocol specification. The processor has two CAN modules

available. Tx and Rx ports for both modules are multiplexed with other I/O pins. See the IOMUXC chapter of the reference manual to see which pins expose Tx and Rx pins; these ports are named CAN_TX and CAN_RX, respectively.

The DSE[5:0] = 001111 and FSEL1[1:0] = 11 are required drive settings to meet the timing.

Please see [CAN network AC electrical specifications](#) for timing parameters.

Table 58. CAN-FD electrical specifications

Parameters	BCAN (Classical and FD)	FlexCAN (Classical and FD)	BCANXL (Classical, FD, and XL)	Unit
Minimum operating frequency	20/40	20/40	40/160	MHz
Maximum Baud Rate	8/8	8/8	20/20	Mbps
TXD Rise time wcs	4/4	4/4	4/4	ns
TXD Fall time wcs	4/4	4/4	4/4	ns
RXD Rise time wcs	4/4	4/4	4/4	ns
RXD Fall time wcs	4/4	4/4	4/4	ns
TXD	3.3/3.3	3.3/3.3	3.3/3.3	V
RXD	3.3/3.3	3.3/3.3	3.3/3.3	V
Internal delay wcs	100/50	100/50	50/12.5	ns
TX PAD delay wcs	25/25	25/25	25/25	ns
RX PAD delay wcs	10/10	10/10	10/10	ns
TX routing delay wcs	5/5	5/5	5/5	ns
RX routing delay wcs	5/5	5/5	5/5	ns
Transceiver loop delay wcs	250/250	250/250	190/190	ns
Total loop delay	395/345	395/345	285/247.5	ns

4.12.8 Pulse width modulator (PWM) timing parameters

This section describes the electrical information of the PWM. The PWM can be programmed to select one of three clock signals as its source frequency. The selected clock signal is passed through a prescaler before being input to the counter. The output is available at the pulse-width modulator output (PWMO) external pin.

[Figure 41](#) depicts the timing of the PWM, and [Table 59](#) lists the PWM timing parameters.

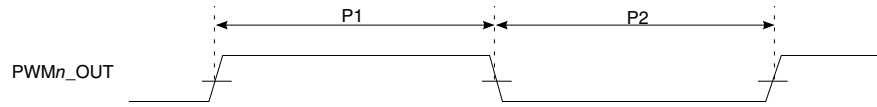


Figure 41. PWM timing

Table 59. PWM output timing parameters

ID	Parameter	Min	Max	Unit
	PWM Module Clock Frequency	0	66 (ipg_clk)	MHz
P1	PWM output pulse width high	12	—	ns
P2	PWM output pulse width low	12	—	ns

4.12.9 FlexSPI timing parameters

The FlexSPI interface can work in SDR or DDR modes. Only FlexSPI_n_MCR0[RXCLKSRC] = 0 and FlexSPI_n_MCR0[RXCLKSRC] = 1 configurations are supported when I/O is supplied by 3.3 V.

Input timing assumes an input signal slew rate of 3 ns (20%/80%) and Output timing valid for maximum external load CL = 15 pF, which is assumed to be a 8 pF load at the end of a 50 ohm, un-terminated, 2-inch microstrip trace on standard FR4 (3.3 pF/inch). For best signal integrity, the series resistance of the transmission line should be matched closely to the selected RDSON of the I/O pad output driver.

The DSE[5:0] = 001111 and FSEL1[1:0] = 11 are required drive settings to meet the timing.

4.12.9.1 FlexSPI input/read timing

There are three sources for the internal sample clock of FlexSPI read data:

- Dummy read strobe generated by FlexSPI controller and looped back internally (FlexSPI_n_MCR0[RXCLKSRC] = 0x0)
- Dummy read strobe generated by FlexSPI controller and looped back through the DQS pad (FlexSPI_n_MCR0[RXCLKSRC] = 0x1)
- Read strobe provided by memory device and input from DQS pad (FlexSPI_n_MCR0[RXCLKSRC] = 0x3)

The following sections describe input signal timing for each of these three internal sample clock sources.

4.12.9.1.1 SDR mode with FlexSPI_n_MCR0[RXCLKSRC] = 0x0, 0x1

Table 60. FlexSPI input timing in SDR mode where FlexSPI_n_MCR0[RXCLKSRC] = 0X0 (Nominal mode)

Symbol	Parameter	Min	Max	Unit
—	Frequency of operation	—	66	MHz

Table continues on the next page...

Table 60. FlexSPI input timing in SDR mode where FlexSPI_n_MCR0[RXCLKSRC] = 0X0 (Nominal mode)...continued

Symbol	Parameter	Min	Max	Unit
F1	Setup time for incoming data	6	—	ns
F2	Hold time for incoming data	0	—	ns

Table 61. FlexSPI input timing in SDR mode where FlexSPI_n_MCR0[RXCLKSRC] = 0X0 (Low drive mode)

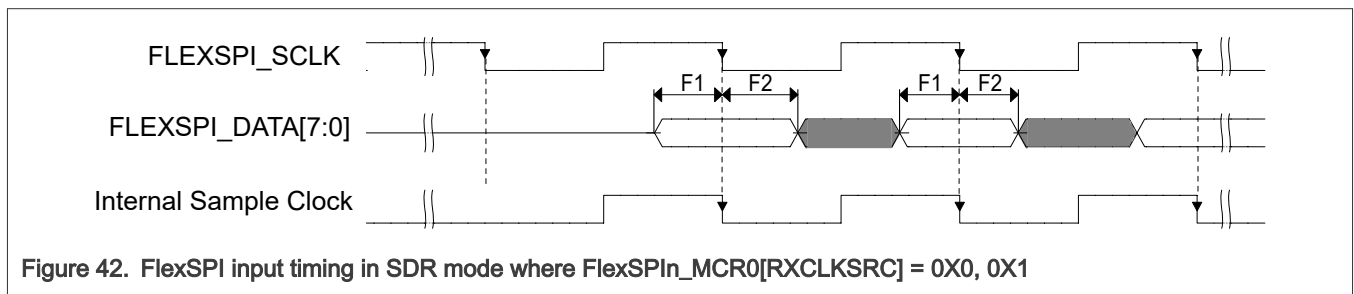
Symbol	Parameter	Min	Max	Unit
—	Frequency of operation	—	50	MHz
F1	Setup time for incoming data	7	—	ns
F2	Hold time for incoming data	0	—	ns

Table 62. FlexSPI input timing in SDR mode where FlexSPI_n_MCR0[RXCLKSRC] = 0X1 (Nominal mode)

Symbol	Parameter	Min	Max	Unit
—	Frequency of operation	—	166	MHz
F1	Setup time for incoming data	1	—	ns
F2	Hold time for incoming data	1	—	ns

Table 63. FlexSPI input timing in SDR mode where FlexSPI_n_MCR0[RXCLKSRC] = 0X1 (Low drive mode)

Symbol	Parameter	Min	Max	Unit
—	Frequency of operation	—	100	MHz
F1	Setup time for incoming data	2	—	ns
F2	Hold time for incoming data	1	—	ns



NOTE

Timing shown is based on the memory generating read data on the SCK falling edge, and FlexSPI controller sampling read data on the falling edge.

4.12.9.1.2 SDR mode with FlexSPI_n_MCR0[RXCLKSRC] = 0x3

There are two cases when the memory provides both read data and the read strobe in SDR mode:

- A1—Memory generates both read data and read strobe on SCK rising edge (or falling edge)
- A2—Memory generates read data on SCK falling edge and generates read strobe on SCK rising edge

Table 64. FlexSPI input timing in SDR mode where FlexSPI_n_MCR0[RXCLKSRC] = 0x3 (case A1) (Nominal mode)

Symbol	Parameter	Min	Max	Unit
—	Frequency of operation	—	200	MHz
T _{SCKD} - T _{SCKDQS}	Time delta between T _{SCKD} and T _{SCKDQS}	-0.6	0.6	ns

Table 65. FlexSPI input timing in SDR mode where FlexSPI_n_MCR0[RXCLKSRC] = 0x3 (case A1) (Low drive mode)

Symbol	Parameter	Min	Max	Unit
—	Frequency of operation	—	133	MHz
T _{SCKD} - T _{SCKDQS}	Time delta between T _{SCKD} and T _{SCKDQS}	-2	2	ns

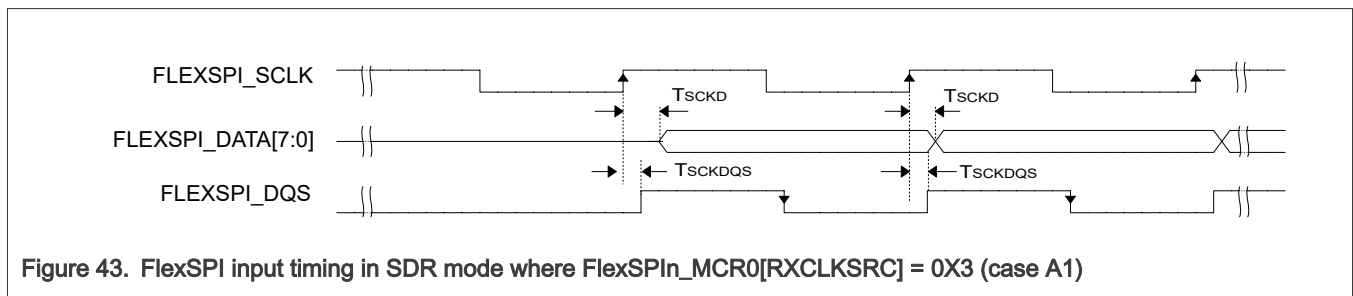


Figure 43. FlexSPI input timing in SDR mode where FlexSPI_n_MCR0[RXCLKSRC] = 0X3 (case A1)

NOTE

Timing shown is based on the memory generating read data and read strobe on the SCK rising edge. The FlexSPI controller samples read data on the DQS falling edge.

Table 66. FlexSPI input timing in SDR mode where FlexSPI_n_MCR0[RXCLKSRC] = 0x3 (case A2) (Nominal mode)

Symbol	Parameter	Value		Unit
		Min	Max	
—	Frequency of operation	—	200	MHz
T _{SCKD} - T _{SCKDQS}	Time delta between T _{SCKD} and T _{SCKDQS}	-0.6	0.6	ns

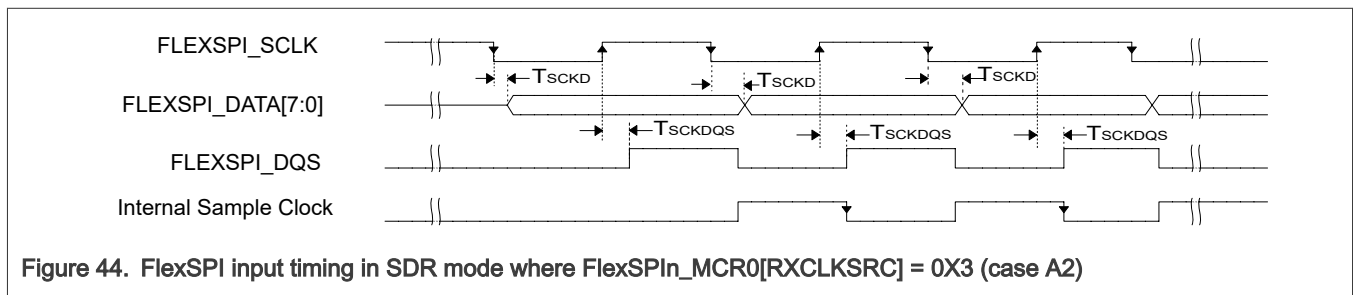
Table 67. FlexSPI input timing in SDR mode where FlexSPI_n_MCR0[RXCLKSRC] = 0x3 (case A2) (Low drive mode)

Symbol	Parameter	Value		Unit
		Min	Max	
—	Frequency of operation	—	133	MHz

Table continues on the next page...

Table 67. FlexSPI input timing in SDR mode where FlexSPI η _MCR0[RXCLKSRC] = 0x3 (case A2) (Low drive mode)...continued

Symbol	Parameter	Value		Unit
		Min	Max	
T _{SCKD} - T _{SCKDQDS}	Time delta between T _{SCKD} and T _{SCKDQDS}	-2	2	ns



NOTE

Timing shown is based on the memory generating read data on the SCK falling edge and read strobe on the SCK rising edge. The FlexSPI controller samples read data on a half cycle delayed DQS falling edge.

4.12.9.1.3 DDR mode with FlexSPI η _MCR0[RXCLKSRC] = 0x0, 0x1

Table 68. FlexSPI input timing in DDR mode where FlexSPI η _MCR0[RXCLKSRC] = 0x0 (Nominal and Low drive mode)

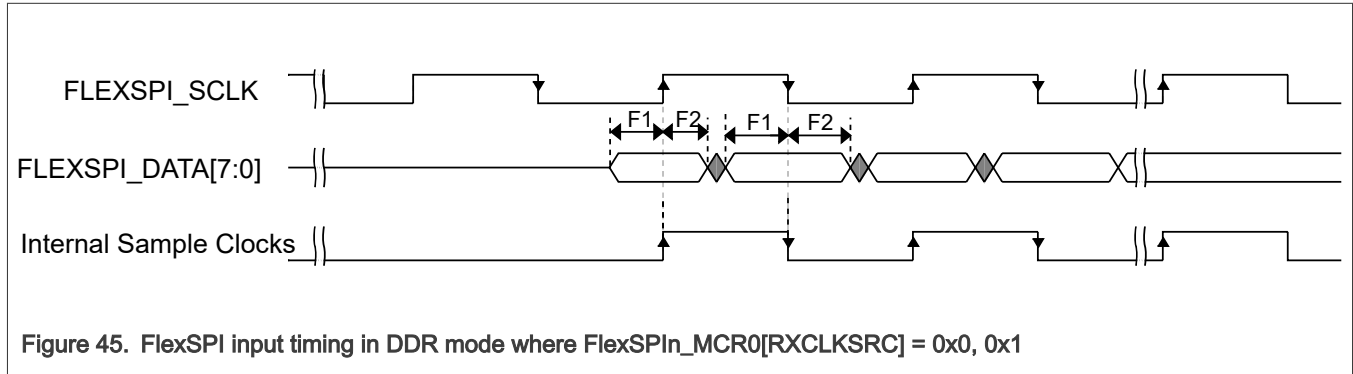
Symbol	Parameter	Min	Max	Unit
—	Frequency of operation	—	33	MHz
F1	Setup time for incoming data	6	—	ns
F2	Hold time for incoming data	0	—	ns

Table 69. FlexSPI input timing in DDR mode where FlexSPI η _MCR0[RXCLKSRC] = 0x1 (Nominal mode)

Symbol	Parameter	Min	Max	Unit
—	Frequency of operation	—	83	MHz
F1	Setup time for incoming data	1	—	ns
F2	Hold time for incoming data	1	—	ns

Table 70. FlexSPI input timing in DDR mode where FlexSPI η _MCR0[RXCLKSRC] = 0x1 (Low drive mode)

Symbol	Parameter	Min	Max	Unit
—	Frequency of operation	—	66	MHz
F1	Setup time for incoming data	1.5	—	ns
F2	Hold time for incoming data	1	—	ns



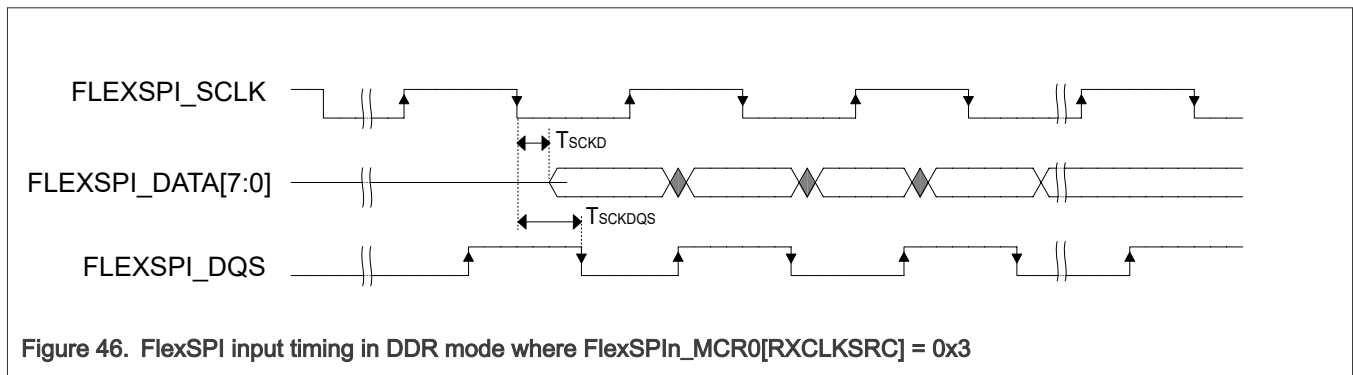
4.12.9.1.4 DDR mode with FlexSPIn_MCR0[RXCLKSRC] = 0x3

Table 71. FlexSPI input timing in DDR mode where FlexSPIn_MCR0[RXCLKSRC] = 0x3 (Nominal mode)

Symbol	Parameter	Min	Max	Unit
—	Frequency of operation	—	200	MHz
$T_{SCKD} - T_{SCKDQS}$	Time delta between T_{SCKD} and T_{SCKDQS}	-0.6	0.6	ns

Table 72. FlexSPI input timing in DDR mode where FlexSPIn_MCR0[RXCLKSRC] = 0x3 (Low drive mode)

Symbol	Parameter	Min	Max	Unit
—	Frequency of operation	—	133	MHz
$T_{SCKD} - T_{SCKDQS}$	Time delta between T_{SCKD} and T_{SCKDQS}	-0.9	0.9	ns



4.12.9.2 FlexSPI output/write timing

The following sections describe output signal timing for the FlexSPI controller including control signals and data outputs.

4.12.9.2.1 SDR mode

Table 73. FlexSPI output timing in SDR mode (Nominal mode)¹

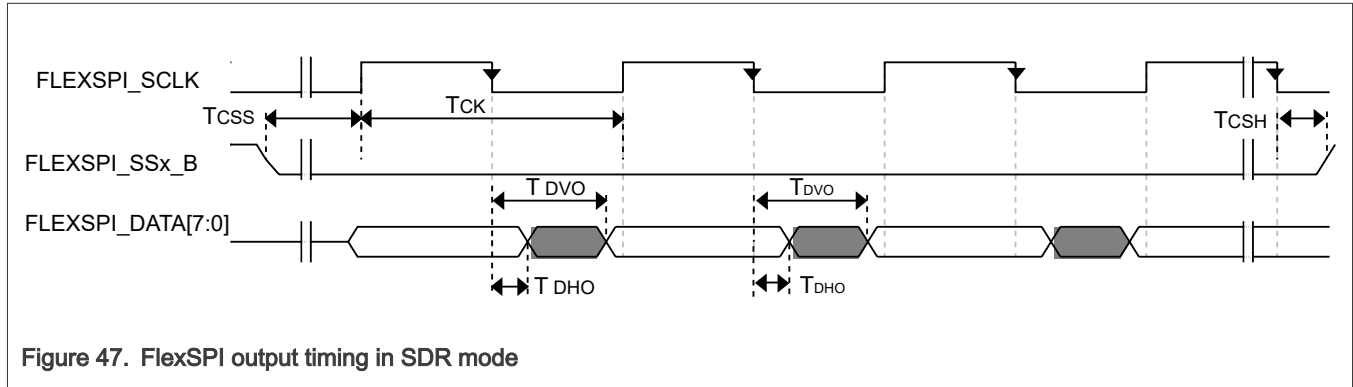
Symbol	Parameter	Min	Max	Unit
—	Frequency of operation	—	200 ²	MHz
T _{ck}	SCK clock period	5	—	ns
T _{DVO}	Output data valid time	—	0.6	ns
T _{DHO}	Output data hold time	-0.6	—	ns
T _{CSS}	Chip select output setup time	T _{CSS} + 0.5	—	SCLK
T _{CSH}	Chip select output hold time ³	T _{CSH}	—	SCLK

1. These timing specifications are valid only for 1.8 V nominal I/O pad supply voltage. For 3.3 V I/O supply, see the FlexSPI SDR output timing in SDR mode (Low drive mode).
2. The actual maximum frequency supported is limited by the FlexSPI_n_MCR0[RXCLKSRC] configuration used, see the FlexSPI SDR input timing specifications.
3. T_{CSS} and T_{CSH} are configured by the FlexSPI_n_FLSHAxCR1 register. See i.MX 91 Applications Processor Reference Manual (IMX91RM) for more details.

Table 74. FlexSPI output timing in SDR mode (Low drive mode)

Symbol	Parameter	Min	Max	Unit
—	Frequency of operation	—	133 ¹	MHz
T _{ck}	SCK clock period	7.5	—	ns
T _{DVO}	Output data valid time	—	2	ns
T _{DHO}	Output data hold time	-2	—	ns
T _{CSS}	Chip select output setup time	T _{CSS} + 0.5	—	SCLK
T _{CSH}	Chip select output hold time ²	T _{CSH}	—	SCLK

1. The actual maximum frequency supported is limited by the FlexSPI_n_MCR0[RXCLKSRC] configuration used, see the FlexSPI SDR input timing specifications.
2. T_{CSS} and T_{CSH} are configured by the FlexSPI_n_FLSHAxCR1 register. See i.MX 91 Applications Processor Reference Manual (IMX91RM) for more details.



4.12.9.2.2 DDR mode

Table 75. FlexSPI output timing in DDR mode (Nominal mode)¹

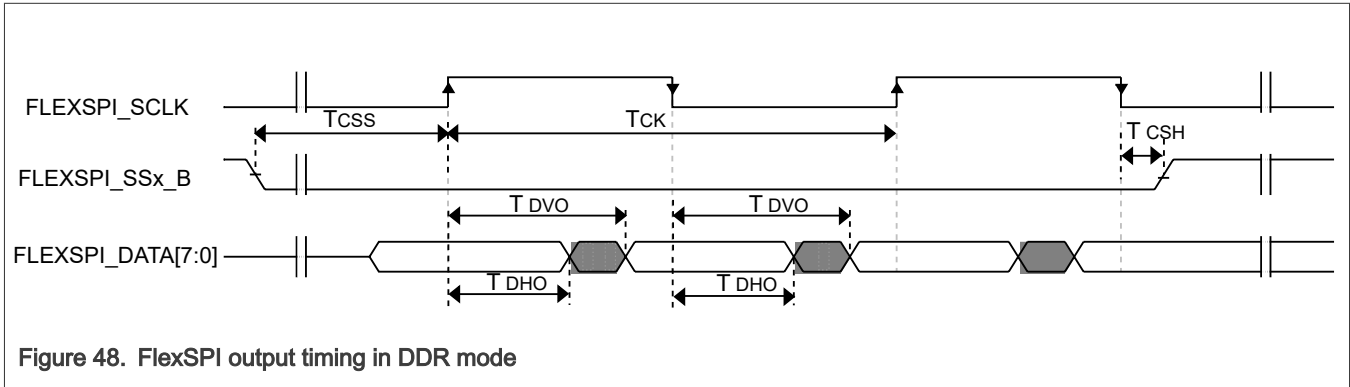
Symbol	Parameter	Min	Max	Unit
—	Frequency of operation	—	200 ²	MHz
T _{ck}	SCK clock period	5	—	ns
T _{DVO}	Output data valid time	—	0.6	ns
T _{DHO}	Output data hold time	-0.6	—	ns
T _{CSS}	Chip select output setup time	(T _{CSS} + 0.5) / 2	—	SCLK
T _{CSH}	Chip select output hold time ³	(T _{CSH} + 0.5) / 2	—	SCLK

1. These timing specifications are valid only for 1.8 V nominal IO pad supply voltage. For 3.3 V I/O supply, see [Table 76](#)
2. The actual maximum frequency supported is limited by the FlexSPI_n_MCR0[RXCLKSRC] configuration used, see the FlexSPI DDR input timing specifications.
3. T_{CSS} and T_{CSH} are configured by the FlexSPI_n_FLSHAxCR1 register. See i.MX 91 Applications Processor Reference Manual (IMX91RM) for more details.

Table 76. FlexSPI output timing in DDR mode (Low drive mode)

Symbol	Parameter	Min	Max	Unit
—	Frequency of operation	—	133 ¹	MHz
T _{ck}	SCK clock period	7.5	—	ns
T _{DVO}	Output data valid time	—	0.9	ns
T _{DHO}	Output data hold time	-0.9	—	ns
T _{CSS}	Chip select output setup time ²	(T _{CSS} + 0.5) / 2	—	SCLK
T _{CSH}	Chip select output hold time ²	(T _{CSH} + 0.5) / 2	—	SCLK

1. The actual maximum frequency supported is limited by the FlexSPI_n_MCR0[RXCLKSRC] configuration used, see the FlexSPI DDR input timing specifications.
2. T_{CSS} and T_{CSH} are configured by the FlexSPI_n_FLSHAxCR1 register. See i.MX 91 Applications Processor Reference Manual (IMX91RM) for more details.



4.12.10 USB PHY parameters

The USB PHY parameters meet the electrical compliance requirements listed as following:

- *Universal Serial Bus Revision 2.0 Specification* (including ECNs and errata), On-The-Go and Embedded Host Supplement to the Universal Serial Bus Revision 2.0 Specification (including ECNs and errata)

4.12.10.1 Pad/Package/Board connections

The USBx_VBUS pin cannot directly connect to the 5 V VBUS voltage on the USB2.0 link.

Each USBx_VBUS pin must be isolated by an external 30 KΩ 1% precision resistor.

The USB 2.0 PHY uses USBx_TXRTUNE and an external resistor to calibrate the USBx_DP/DN 45 Ω source impedance. The external resistor value is 200 Ω 1% precision on each of USBx_TXRTUNE pad to ground.

5 Boot mode configuration

This section provides information on boot mode configuration pins allocation and boot devices interfaces allocation.

i.MX 91 supports three different boot modes:

- Normal Boot Mode
- Boot from Internal Fuse Mode
- Serial Download Boot Mode

Three different boot modes can be either selected via different boot mode pins or overridden by fuses.

i.MX 91 supports Single Boot: Cortex-A55 core is in charge of loading all containers and images.

For detailed boot mode configuration, see the see the i.MX 91 Fuse Map and the System Boot chapter in *i.MX 91 Reference Manual (IMX91RM)*.

5.1 Boot mode configuration pins

There are four boot mode pins used to select boot mode.

Table 77. Fuses and associated pins used for boot

BOOT_MODE[3:0]	Function
x000	Boot from Internal Fuses
0001	Serial Download (USB1)

Table continues on the next page...

Table 77. Fuses and associated pins used for boot ...continued

BOOT_MODE[3:0]	Function
0010	uSDHC1 8-bit eMMC 5.1
0011	uSDHC2 4-bit SD 3.0
0100	FlexSPI Serial NOR
0101	FlexSPI Serial NAND 2K
0110	Reserved
0111	Reserved
1000	Reserved
1001	Reserved
1010	Reserved
1011	Reserved
1100	Reserved
1101	Reserved
1110	Reserved
1111	Reserved

- HW samples the boot CFG pins before ROM starts, these pins should be mapped to Boot CFG pins by default.
- Once HW samples the boot CFG pins and stores the boot CFG in CMC register, the register should be latched. That means the register value no longer changes and reflecting the pins status.

Additional boot options are also supported for both Normal Boot Mode and Internal Fuse mode:

- All boot modes supported for a range of speeds, timings, and protocol formats;
- eMMC and SD boot supported from any USDHC instance 1 or 2;
- Serial NOR boot supported for 1-bit, 4-bit, and 8-bit mode;
- Serial NAND boot supported for 1-bit, 4-bit, and 8-bit mode (8-bit Serial NAND)

BOOT_MODE pins are multiplexed over other functional pins. The functional IO that are multiplexed with these pins must be selected subject to two criteria:

- Functional IO must not be used if they are inputs to the SoC, which could potentially be constantly driven by external components. Such functional mode driving may interfere with the need for the board to pull these pins a certain way while POR is asserted.
- Functional IO must not be used if they are outputs of the SoC, which will be connected to components on the board that may misinterpret the signals as valid signals if they toggle (such as, the board drives them while POR is asserted).

5.2 Boot device interface allocation

i.MX 91 supports three kinds of boot devices:

- Primary Boot Device

The primary boot device is selected by Boot Config pins if boot mode is the Normal Boot or Internal Fuses Boot. The valid primary boot device options are SD/eMMC/FlexSPI NOR/FlexSPI NAND. The valid options also depend on the Boot Type and other fuses configuration.

- Recovery Boot Device

After booting from Primary Boot Device fails, i.MX 91 will try to boot from another boot source. The recovery boot device is only SPI1/2/3/4 for i.MX 91.

- Serial Download Boot Device

Cortex-A55 supports serial download mode via USB1.

The following tables list the interfaces that can be used by the boot process in accordance with the specific boot mode configuration. The tables also describe the interface’s specific modes and IOMUXC allocation, which are configured during boot when appropriate.

Table 78. Boot through FlexSPI

Signal name	PAD name	ALT
FlexSPIA_DATA0	SD3_DATA0	ALT1
FlexSPIA_DATA1	SD3_DATA1	ALT1
FlexSPIA_DATA2	SD3_DATA2	ALT1
FlexSPIA_DATA3	SD3_DATA3	ALT1
FlexSPIA_DQS	SD1_STROBE	ALT1
FlexSPIA_SS0_B	SD3_CMD	ALT1
FlexSPIA_SCLK	SD3_CLK	ALT1
FlexSPIA_DATA4	SD1_DATA4	ALT1
FlexSPIA_DATA5	SD1_DATA5	ALT1
FlexSPIA_DATA6	SD1_DATA6	ALT1
FlexSPIA_DATA7	SD1_DATA7	ALT1

Table 79. Boot through uSDHC1

Signal name	PAD name	ALT
USDHC1_CMD	SD1_CMD	ALT0
USDHC1_CLK	SD1_CLK	ALT0
USDHC1_DATA0	SD1_DATA0	ALT0
USDHC1_DATA1	SD1_DATA1	ALT0

Table continues on the next page...

Table 79. Boot through uSDHC1...continued

USDHC1_DATA2	SD1_DATA2	ALT0
USDHC1_DATA3	SD1_DATA3	ALT0
USDHC1_DATA4	SD1_DATA4	ALT0
USDHC1_DATA5	SD1_DATA5	ALT0
USDHC1_DATA6	SD1_DATA6	ALT0
USDHC1_DATA7	SD1_DATA7	ALT0
USDHC1_RESET	SD1_DATA5	ALT2

Table 80. Boot through uSDHC2

Signal name	PAD name	ALT
USDHC2_CMD	SD2_CMD	ALT0
USDHC2_CLK	SD2_CLK	ALT0
USDHC2_DATA0	SD2_DATA0	ALT0
USDHC2_DATA1	SD2_DATA1	ALT0
USDHC2_DATA2	SD2_DATA2	ALT0
USDHC2_DATA3	SD2_DATA3	ALT0
USDHC2_RESET	SD2_RESET_B	ALT0
USDHC2_VSELECT	SD2_VSELECT	ALT0

Table 81. Boot through SPI1

Signal name	PAD name	ALT
SPI1_PCS1	PDM_BIT_STREAM0	ALT2
SPI1_SIN	SAI1_TXC	ALT2
SPI1_SOUT	SAI1_RXD0	ALT2
SPI1_SCK	SAI1_TXD0	ALT2
SPI1_PCS0	SAI1_TXFS	ALT2

Table 82. Boot through SPI2

Signal name	PAD name	ALT
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Table continues on the next page...

Table 82. Boot through SPI2...continued

SPI2_PCS1	PDM_BIT_STREAM1	ALT2
SPI2_SIN	UART1_RXD	ALT2
SPI2_SOUT	UART2_RXD	ALT2
SPI2_SCK	UART2_TXD	ALT2
SPI2_PCS0	UART1_TXD	ALT2

Table 83. Boot through SPI3

Signal name	PAD name	ALT
SPI3_PCS1	GPIO_IO07	ALT1
SPI3_SIN	GPIO_IO09	ALT1
SPI3_SOUT	GPIO_IO10	ALT1
SPI3_SCK	GPIO_IO11	ALT1
SPI3_PCS0	GPIO_IO08	ALT1

Table 84. Boot through SPI4

Signal name	PAD name	ALT
SPI4_PCS1	GPIO_IO17	ALT5
SPI4_PCS2	GPIO_IO16	ALT5
SPI4_SIN	GPIO_IO19	ALT5
SPI4_SOUT	GPIO_IO20	ALT5
SPI4_SCK	GPIO_IO21	ALT5
SPI4_PCS0	GPIO_IO18	ALT5

USB1 interfaces are dedicated pins, thus no IOMUX options.

6 Package information and contact assignments

This section includes the contact assignment information and mechanical package drawing.

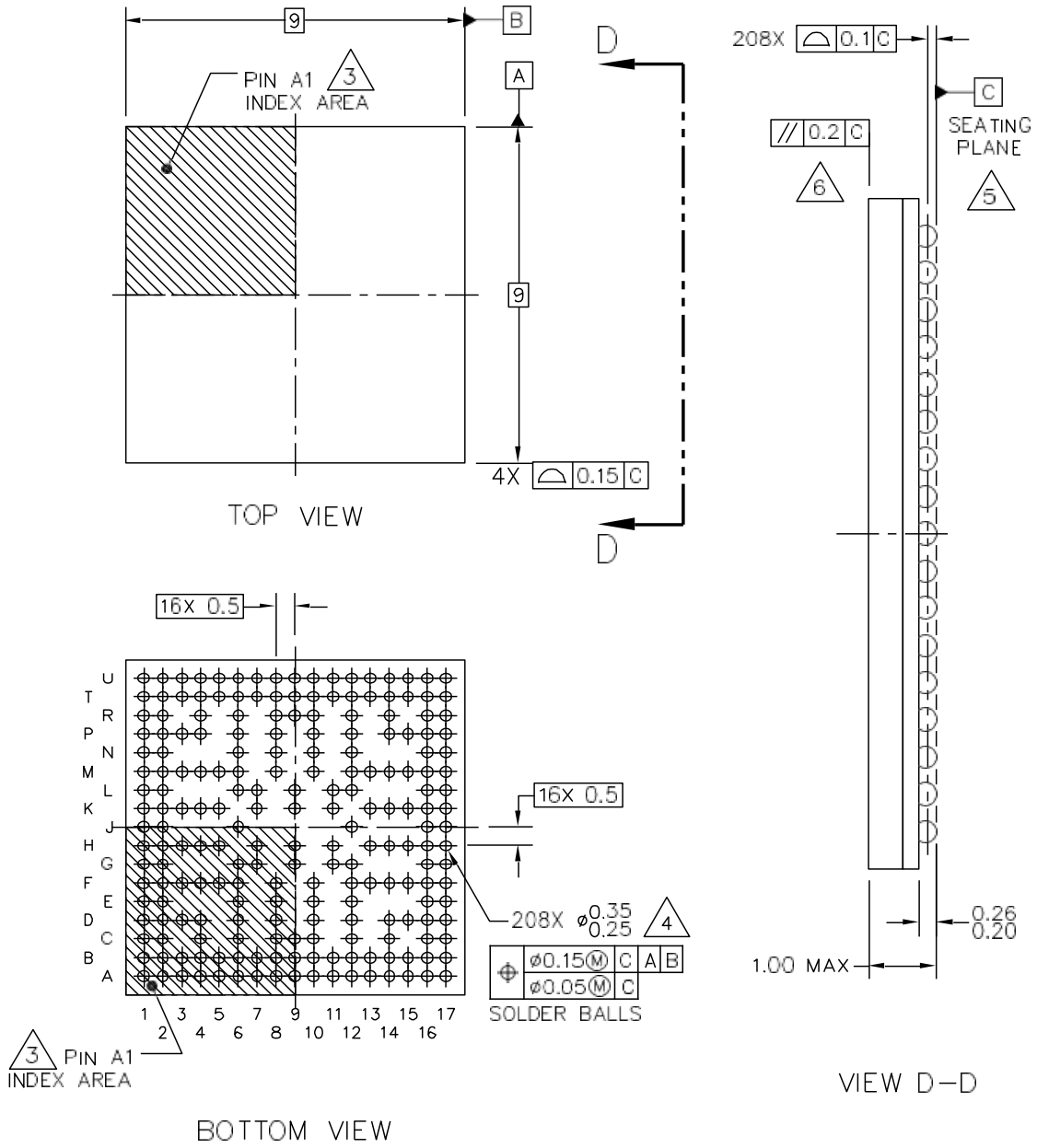
6.1 9 x 9 mm package information

6.1.1 9 x 9 mm, 0.5 mm pitch, ball matrix

Figure 49 shows the top, bottom, and side views of the 9 x 9 mm FCBGA package.

FC-PBGA-208 I/O
9 X 9 X 0.896 PKG, 0.5 PITCH

SOT2175-1



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Figure 49. 9 x 9 mm FC-PBGA, case x package top, bottom, and side Views

6.1.2 9 x 9 mm supplies contact assignments and functional contact assignments

Table 85 shows the device connection list for ground, sense, and reference contact signals.

Table 85. 9 x 9 mm supplies contact assignment

Supply Rail Name	Ball(s) Position(s)	Remark
NVCC_AON	H13	—
NVCC_BBSM_1P8	E10	—
NVCC_GPIO	K13	—
NVCC_SD2	N12	—
NVCC_WAKEUP	L6, L9, L11	—
VDD_ANA0_0P8	F13	—
VDD_ANA0_1P8	F12	—
VDD_ANA1_0P8	M13	—
VDD_ANA1_1P8	N8	—
VDD_ANAVDET_1P8	L12	—
VDD_BBSM_0P8_CAP	C10	—
VDD_SOC	G7, G9, G11, H7, H11, K7, K11	—
VDD_USB_0P8	C4	—
VDD_USB_1P8	E6	—
VDD_USB_3P3	E8	—
VDD2_DDR	K5, M5, N6, P4, F5, H5	—
VSS	A1, A17, C6, C8, C12, C14, D3, D15, E12, F3, F6, F8, F10, F15, G6, G12, H3, H9, H15, J6, J12, K3, K9, L7, M3, M6, M8, M10, M12, M15, N10, P3, P15, R4, R6, R8, R10, R12, R14, U1, U17	—

Table 86 shows an alpha-sorted list of functional contact assignments of the 9 x 9 mm package.

Table 86. 9 x 9 mm functional contact assignment

Ball name	9 x 9 ball	Power group	Ball Types	Default setting		
				Default modes	Default function	Status while reset is asserted
ADC_IN0	B8	VDD_ANA0_1P8	ANALOG	—	—	Input without PU ¹ / PD ²
ADC_IN1	A8	VDD_ANA0_1P8	ANALOG	—	—	Input without PU / PD
CCM_CLKO1	T4	NVCC_WAKEUP	GPIO	Alt0	CCMSRCGPCMIX.CLK01	Output low
CLKIN1	A6	VDD_ANA0_1P8	ANALOG	—	—	Input without PU / PD
CLKIN2	B6	VDD_ANA0_1P8	ANALOG	—	—	Input without PU / PD
DAP_TCLK_SWCLK	U3	NVCC_WAKEUP	GPIO	Alt0	DAP.TCLK_SWCLK	Input with PD
DAP_TDI	P8	NVCC_WAKEUP	GPIO	Alt0	DAP.TDI	Input with PU
DAP_TDO_TRACESWO	T3	NVCC_WAKEUP	GPIO	Alt0	DAP.TDO_TRACESWO	Input with PU/PD
DAP_TMS_SWDIO	P6	NVCC_WAKEUP	GPIO	Alt0	DAP.TMS_SWDIO	Input with PU
DRAM_CA0_A	F1	VDD2_DDR	DDR	—	—	—
DRAM_CA1_A	E2	VDD2_DDR	DDR	—	—	—
DRAM_CA2_A	D2	VDD2_DDR	DDR	—	—	—
DRAM_CA3_A	C1	VDD2_DDR	DDR	—	—	—
DRAM_CA4_A	B2	VDD2_DDR	DDR	—	—	—
DRAM_CA5_A	A2	VDD2_DDR	DDR	—	—	—
DRAM_CK_C_A	B1	VDD2_DDR	DDR	—	—	—
DRAM_CK_T_A	C2	VDD2_DDR	DDR	—	—	—
DRAM_CKE0_A	G1	VDD2_DDR	DDR	—	—	—
DRAM_CKE1_A	F2	VDD2_DDR	DDR	—	—	—
DRAM_CS0_A	D1	VDD2_DDR	DDR	—	—	—
DRAM_CS1_A	E1	VDD2_DDR	DDR	—	—	—

Table continues on the next page...

Table 86. 9 x 9 mm functional contact assignment ...continued

Ball name	9 x 9 ball	Power group	Ball Types	Default setting		
				Default modes	Default function	Status while reset is asserted
DRAM_DMI0_A	J2	VDD2_DDR	DDR	—	—	—
DRAM_DMI1_A	R1	VDD2_DDR	DDR	—	—	—
DRAM_DQ00_A	L2	VDD2_DDR	DDR	—	—	—
DRAM_DQ01_A	L1	VDD2_DDR	DDR	—	—	—
DRAM_DQ02_A	K2	VDD2_DDR	DDR	—	—	—
DRAM_DQ03_A	K1	VDD2_DDR	DDR	—	—	—
DRAM_DQ04_A	J1	VDD2_DDR	DDR	—	—	—
DRAM_DQ05_A	H2	VDD2_DDR	DDR	—	—	—
DRAM_DQ06_A	H1	VDD2_DDR	DDR	—	—	—
DRAM_DQ07_A	G2	VDD2_DDR	DDR	—	—	—
DRAM_DQ08_A	T2	VDD2_DDR	DDR	—	—	—
DRAM_DQ09_A	U2	VDD2_DDR	DDR	—	—	—
DRAM_DQ10_A	T1	VDD2_DDR	DDR	—	—	—
DRAM_DQ11_A	R2	VDD2_DDR	DDR	—	—	—
DRAM_DQ12_A	N1	VDD2_DDR	DDR	—	—	—
DRAM_DQ13_A	N2	VDD2_DDR	DDR	—	—	—
DRAM_DQ14_A	M2	VDD2_DDR	DDR	—	—	—
DRAM_DQ15_A	M1	VDD2_DDR	DDR	—	—	—
DRAM_DQS0_C_A	K4	VDD2_DDR	—	—	—	—
DRAM_DQS0_T_A	M4	VDD2_DDR	DDR	—	—	—
DRAM_DQS1_C_A	P2	VDD2_DDR	—	—	—	—
DRAM_DQS1_T_A	P1	VDD2_DDR	DDR	—	—	—
DRAM_RESET_N	F4	VDD2_DDR	DDR	—	—	—

Table continues on the next page...

Table 86. 9 x 9 mm functional contact assignment ...continued

Ball name	9 x 9 ball	Power group	Ball Types	Default setting		
				Default modes	Default function	Status while reset is asserted
DRAM_ZQ	H4	VDD2_DDR	DDR	—	—	—
ENET1_MDC	T8	NVCC_WAKEUP	GPIO	Alt5	GPIO4.IO[0]	Input with PD
ENET1_MDIO	U7	NVCC_WAKEUP	GPIO	Alt5	GPIO4.IO[1]	Input with PD
ENET1_RD0	U5	NVCC_WAKEUP	GPIO	Alt5	GPIO4.IO[10]	Input with PD
ENET1_RD1	T6	NVCC_WAKEUP	GPIO	Alt5	GPIO4.IO[11]	Input with PD
ENET1_RD2	U6	NVCC_WAKEUP	GPIO	Alt5	GPIO4.IO[12]	Input with PD
ENET1_RD3	T7	NVCC_WAKEUP	GPIO	Alt5	GPIO4.IO[13]	Input with PD
ENET1_RX_CTL	T5	NVCC_WAKEUP	GPIO	Alt5	GPIO4.IO[8]	Input with PD
ENET1_RXC	U4	NVCC_WAKEUP	GPIO	Alt5	GPIO4.IO[9]	Input with PD
ENET1_TD0	U9	NVCC_WAKEUP	GPIO	Alt5	GPIO4.IO[5]	Input with PD
ENET1_TD1	R9	NVCC_WAKEUP	GPIO	Alt5	GPIO4.IO[4]	Input with PD
ENET1_TD2	U10	NVCC_WAKEUP	GPIO	Alt5	GPIO4.IO[3]	Input with PD
ENET1_TD3	T10	NVCC_WAKEUP	GPIO	Alt5	GPIO4.IO[2]	Input with PD
ENET1_TX_CTL	T9	NVCC_WAKEUP	GPIO	Alt5	GPIO4.IO[6]	Input with PD
ENET1_TXC	U8	NVCC_WAKEUP	GPIO	Alt5	GPIO4.IO[7]	Input with PD
GPIO_IO00	B16	NVCC_GPIO	GPIO	Alt0	GPIO2.IO[0]	Input with PD
GPIO_IO01	B17	NVCC_GPIO	GPIO	Alt0	GPIO2.IO[1]	Input with PD
GPIO_IO02	C16	NVCC_GPIO	GPIO	Alt0	GPIO2.IO[2]	Input with PD
GPIO_IO03	C17	NVCC_GPIO	GPIO	Alt0	GPIO2.IO[3]	Input with PD
GPIO_IO04	D16	NVCC_GPIO	GPIO	Alt0	GPIO2.IO[4]	Input with PD
GPIO_IO05	D17	NVCC_GPIO	GPIO	Alt0	GPIO2.IO[5]	Input with PD
GPIO_IO06	E16	NVCC_GPIO	GPIO	Alt0	GPIO2.IO[6]	Input with PD
GPIO_IO07	E17	NVCC_GPIO	GPIO	Alt0	GPIO2.IO[7]	Input with PD

Table continues on the next page...

Table 86. 9 x 9 mm functional contact assignment ...continued

Ball name	9 x 9 ball	Power group	Ball Types	Default setting		
				Default modes	Default function	Status while reset is asserted
GPIO_IO08	K14	NVCC_GPIO	GPIO	Alt0	GPIO2.IO[8]	Input with PD
GPIO_IO09	F16	NVCC_GPIO	GPIO	Alt0	GPIO2.IO[9]	Input with PD
GPIO_IO10	F17	NVCC_GPIO	GPIO	Alt0	GPIO2.IO[10]	Input with PD
GPIO_IO11	G16	NVCC_GPIO	GPIO	Alt0	GPIO2.IO[11]	Input with PD
GPIO_IO12	F14	NVCC_GPIO	GPIO	Alt0	GPIO2.IO[12]	Input with PD
GPIO_IO13	G17	NVCC_GPIO	GPIO	Alt0	GPIO2.IO[13]	Input with PD
GPIO_IO14	H16	NVCC_GPIO	GPIO	Alt0	GPIO2.IO[14]	Input with PD
GPIO_IO15	H17	NVCC_GPIO	GPIO	Alt0	GPIO2.IO[15]	Input with PD
GPIO_IO16	J16	NVCC_GPIO	GPIO	Alt0	GPIO2.IO[16]	Input with PD
GPIO_IO17	K15	NVCC_GPIO	GPIO	Alt0	GPIO2.IO[17]	Input with PD
GPIO_IO18	M14	NVCC_GPIO	GPIO	Alt0	GPIO2.IO[18]	Input with PD
GPIO_IO19	J17	NVCC_GPIO	GPIO	Alt0	GPIO2.IO[19]	Input with PD
GPIO_IO20	K16	NVCC_GPIO	GPIO	Alt0	GPIO2.IO[20]	Input with PD
GPIO_IO21	K17	NVCC_GPIO	GPIO	Alt0	GPIO2.IO[21]	Input with PD
I2C1_SCL	A12	NVCC_AON	GPIO	Alt5	GPIO1.IO[0]	Input with PD
I2C1_SDA	B12	NVCC_AON	GPIO	Alt5	GPIO1.IO[1]	Input with PD
I2C2_SCL	A11	NVCC_AON	GPIO	Alt5	GPIO1.IO[2]	Input with PD
I2C2_SDA	B11	NVCC_AON	GPIO	Alt5	GPIO1.IO[3]	Input with PD
ONOFF	D10	NVCC_BBSM_1P8	GPIO	Alt0	BBSMMIX.ONOFF	Input without PU / PD
PDM_BIT_STREAM0	A10	NVCC_AON	GPIO	Alt5	GPIO1.IO[9]	Input with PD
PDM_BIT_STREAM1	B10	NVCC_AON	GPIO	Alt5	GPIO1.IO[10]	Input with PD
PDM_CLK	A16	NVCC_AON	GPIO	Alt5	GPIO1.IO[8]	Input with PD

Table continues on the next page...

Table 86. 9 x 9 mm functional contact assignment ...continued

Ball name	9 x 9 ball	Power group	Ball Types	Default setting		
				Default modes	Default function	Status while reset is asserted
PMIC_ON_REQ	A7	NVCC_BBSM_1P8	GPIO	Alt0	BBSMMIX.PMIC_ON_REQ	Output high without PU / PD
PMIC_STBY_REQ	C9	NVCC_BBSM_1P8	GPIO	Alt0	BBSMMIX.PMIC_STBY_REQ	Output low without PU / PD
POR_B	B7	NVCC_BBSM_1P8	GPIO	Alt0	BBSMMIX.POR_B	Input without PU / PD
RTC_XTALI	A5	NVCC_BBSM_1P8	ANALOG	Alt0	BBSMMIX.RTC	—
RTC_XTALO	B5	NVCC_BBSM_1P8	ANALOG	—	—	—
SAI1_RXD0	B14	NVCC_AON	GPIO	Alt5	GPIO1.IO[4]	Input with PD
SAI1_TXC	B15	NVCC_AON	GPIO	Alt5	GPIO1.IO[12]	Input with PD
SAI1_TXD0	A15	NVCC_AON	GPIO	Alt5	GPIO1.IO[13] CCMSRCGPCMIX.BOOT_MODE[3]	Input with PD
SAI1_TXFS	A14	NVCC_AON	GPIO	Alt5	GPIO1.IO[11] CCMSRCGPCMIX.BOOT_MODE[2]	Input with PD
SD1_CLK	U11	NVCC_WAKEUP	GPIO	Alt5	GPIO3.IO[8]	Input with PD
SD1_CMD	T11	NVCC_WAKEUP	GPIO	Alt5	GPIO3.IO[9]	Input with PD
SD1_DATA0	T13	NVCC_WAKEUP	GPIO	Alt5	GPIO3.IO[10]	Input with PD
SD1_DATA1	T14	NVCC_WAKEUP	GPIO	Alt5	GPIO3.IO[11]	Input with PD
SD1_DATA2	T15	NVCC_WAKEUP	GPIO	Alt5	GPIO3.IO[12]	Input with PD
SD1_DATA3	U13	NVCC_WAKEUP	GPIO	Alt5	GPIO3.IO[13]	Input with PD
SD1_DATA4	T12	NVCC_WAKEUP	GPIO	Alt5	GPIO3.IO[14]	Input with PD
SD1_DATA5	U14	NVCC_WAKEUP	GPIO	Alt5	GPIO3.IO[15]	Input with PD
SD1_DATA6	U15	NVCC_WAKEUP	GPIO	Alt5	GPIO3.IO[16]	Input with PD

Table continues on the next page...

Table 86. 9 x 9 mm functional contact assignment ...continued

Ball name	9 x 9 ball	Power group	Ball Types	Default setting		
				Default modes	Default function	Status while reset is asserted
SD1_DATA7	U16	NVCC_WAKEUP	GPIO	Alt5	GPIO3.IO[17]	Input with PD
SD1_STROBE	U12	NVCC_WAKEUP	GPIO	Alt5	GPIO3.IO[18]	Input without PU / PD
SD2_CD_B	P12	NVCC_SD2	GPIO	Alt5	GPIO3.IO[0]	Input with PD
SD2_CLK	M16	NVCC_SD2	GPIO	Alt5	GPIO3.IO[1]	Input with PD
SD2_CMD	M17	NVCC_SD2	GPIO	Alt5	GPIO3.IO[2]	Input with PD
SD2_DATA0	N17	NVCC_SD2	GPIO	Alt5	GPIO3.IO[3]	Input with PD
SD2_DATA1	N16	NVCC_SD2	GPIO	Alt5	GPIO3.IO[4]	Input with PD
SD2_DATA2	L17	NVCC_SD2	GPIO	Alt5	GPIO3.IO[5]	Input with PD
SD2_DATA3	L16	NVCC_SD2	GPIO	Alt5	GPIO3.IO[6]	Input with PD
SD2_RESET_B	P10	NVCC_SD2	GPIO	Alt5	GPIO3.IO[7]	Input with PD
SD2_VSELECT	P14	NVCC_WAKEUP	GPIO	Alt5	GPIO3.IO[19]	Input with PD
SD3_CLK	T16	NVCC_WAKEUP	GPIO	Alt5	GPIO3.IO[20]	Input with PD
SD3_CMD	T17	NVCC_WAKEUP	GPIO	Alt5	GPIO3.IO[21]	Input with PD
SD3_DATA0	R16	NVCC_WAKEUP	GPIO	Alt5	GPIO3.IO[22]	Input with PD
SD3_DATA1	R17	NVCC_WAKEUP	GPIO	Alt5	GPIO3.IO[23]	Input with PD
SD3_DATA2	P16	NVCC_WAKEUP	GPIO	Alt5	GPIO3.IO[24]	Input with PD
SD3_DATA3	P17	NVCC_WAKEUP	GPIO	Alt5	GPIO3.IO[25]	Input with PD
TAMPER0	D6	NVCC_BBSM_1P8	GPIO	Alt0	BBSMMIX.TAMPER0	Input with PU
TAMPER1	D8	NVCC_BBSM_1P8	GPIO	Alt0	BBSMMIX.TAMPER1	Input with PU
UART1_RXD	B13	NVCC_AON	GPIO	Alt5	GPIO1.IO[4]	Input with PD
UART1_TXD	A13	NVCC_AON	GPIO	Alt5	GPIO1.IO[5] CCMSRCGPCMIX.BOOT_MODE[0]	Input with PD
UART2_RXD	D14	NVCC_AON	GPIO	Alt5	GPIO1.IO[6]	Input with PD

Table continues on the next page...

Table 86. 9 x 9 mm functional contact assignment ...continued

Ball name	9 x 9 ball	Power group	Ball Types	Default setting		
				Default modes	Default function	Status while reset is asserted
UART2_TXD	D12	NVCC_AON	GPIO	Alt5	GPIO1.IO[7] CCMSRCGPCMIX.BOOT_MODE[1]	Input with PD
USB1_D_N	A4	VDD_USB_3P3	PHY	—	—	—
USB1_D_P	B4	VDD_USB_3P3	PHY	—	—	—
USB1_ID	D4	VDD_USB_1P8	PHY	—	—	—
USB1_TXRTUNE	A3	VDD_USB_1P8	PHY	—	—	—
USB1_VBUS	B3	VDD_USB_3P3	PHY	—	—	—
WDOG_ANY	H14	NVCC_AON	GPIO	Alt5	WDOG1.WDOG_ANY	Input with PU
XTALI_24M	A9	VDD_ANA0_1P8	ANALOG	—	—	—
XTALO_24M	B9	VDD_ANA0_1P8	ANALOG	—	—	—

- 1. Pull-up
- 2. Pull-down

6.1.3 9 x 9 mm, 0.5 mm pitch, ball map

Table 87 shows the 9 x 9 mm, 0.5 mm pitch ball map for the i.MX 91.

Table 87. 9 x 9 mm, 0.5 mm pitch, ball map

	1	2	3	4	5	6	7	8	9	10	11	12	13	14	15	16	17
A	VSS	DRA M_C A5_ A	USB 1_TX RTU NE	USB 1_D_ N	RTC _XT ALI	CLKI N1	PMI C_O N_R EQ	ADC _IN1	XTA LI_2 4M	PDM _BIT_ STR EAM 0	I2C2 _SCL	I2C1 _SCL	UAR T1_T XD	SAI1 _TXF S	SAI1 _TXD 0	PDM _CLK	VSS
B	DRA M_C K_C _A	DRA M_C A4_ A	USB 1_V BUS	USB 1_D_ P	RTC _XT ALO	CLKI N2	POR _B	ADC _IN0	XTA LO_ 24M	PDM _BIT_ STR EAM 1	I2C2 _SDA	I2C1 _SDA	UAR T1_R XD	SAI1 _RX D0	SAI1 _TXC	GPIO _IO0 0	GPIO _IO0 1
C	DRA M_C	DRA M_C		VDD _US		VSS		VSS	PMI C_S TBY	VDD _BBS M_0P		VSS		VSS		GPIO _IO0 2	GPIO _IO0 3

Table continues on the next page...

Table 87. 9 x 9 mm, 0.5 mm pitch, ball map...continued

	1	2	3	4	5	6	7	8	9	10	11	12	13	14	15	16	17
	A3_A	K_T_A		B_OP8					_REQ	8_CAP							
D	DRA_M_C S0_A	DRA_M_C A2_A	VSS	USB1_ID		TAMPER0		TAMPER1		ONOFF		UART2_TXD		UART2_RXD	VSS	GPIO_IO04	GPIO_IO05
E	DRA_M_C S1_A	DRA_M_C A1_A				VDD_USB1_P8		VDD_USB3_P3		NVC_C_BBSM1_P8		VSS				GPIO_IO06	GPIO_IO07
F	DRA_M_C A0_A	DRA_M_C KE1_A	VSS	DRA_M_R ESE_T_N	VDD2_DR	VSS		VSS		VSS		VDD_ANA0_1P8	VDD_ANA0_0P8	GPIO_IO12	VSS	GPIO_IO09	GPIO_IO10
G	DRA_M_C KE0_A	DRA_M_D Q07_A				VSS	VDD_SO_C		VDD_SO_C		VDD_SO_C	VSS				GPIO_IO11	GPIO_IO13
H	DRA_M_D Q06_A	DRA_M_D Q05_A	VSS	DRA_M_Z Q	VDD2_DR		VDD_SO_C		VSS		VDD_SO_C		NVC_C_AON	WDOG_ANY	VSS	GPIO_IO14	GPIO_IO15
J	DRA_M_D Q04_A	DRA_M_D MIO_A				VSS						VSS				GPIO_IO16	GPIO_IO19
K	DRA_M_D Q03_A	DRA_M_D Q02_A	VSS	DRA_M_D QS0_C_A	VDD2_DR		VDD_SO_C		VSS		VDD_SO_C		NVC_C_GPIO	GPIO_IO08	GPIO_IO07	GPIO_IO020	GPIO_IO021
L	DRA_M_D Q01_A	DRA_M_D Q00_A				NVC_C_WAKEUP	VSS		NVC_C_WAKEUP		NVC_C_WAKEUP	VDD_ANA_VDE_T_1P8				SD2_DAT_A3	SD2_DAT_A2
M	DRA_M_D Q15_A	DRA_M_D Q14_A	VSS	DRA_M_D QS0_T_A	VDD2_DR	VSS		VSS		VSS		VSS	VDD_ANA1_0P8	GPIO_IO08	VSS	SD2_CLK	SD2_CMD

Table continues on the next page...

Table 87. 9 x 9 mm, 0.5 mm pitch, ball map...continued

	1	2	3	4	5	6	7	8	9	10	11	12	13	14	15	16	17
N	DRA M_D Q12 _A	DRA M_D Q13 _A				VDD 2_D DR		VDD _AN A1_1 P8		VSS		NVC C_S D2				SD2_ DAT A1	SD2_ DAT A0
P	DRA M_D QS1 _T_A	DRA M_D QS1 _C_A	VSS	VDD 2_DD R		DAP _TM S_S WDI O		DAP _TDI		SD2_ RES ET_B		SD2_ CD_ B		SD2_ VSEL ECT	VSS	SD3_ DAT A2	SD3_ DAT A3
R	DRA M_D MI1_ A	DRA M_D Q11 _A		VSS		VSS		VSS	ENE T1_T D1	VSS		VSS		VSS		SD3_ DAT A0	SD3_ DAT A1
T	DRA M_D Q10 _A	DRA M_D Q08 _A	DAP _TD O_T RAC ESW O	CCM _CLK O1	ENE T1_ RX_ CTL	ENE T1_ RD1	ENE T1_ RD3	ENE T1_ MDC	ENE T1_T X_C TL	ENE T1_T D3	SD1_ CMD	SD1_ DAT A4	SD1_ DAT A0	SD1_ DAT A1	SD1_ DAT A2	SD3_ CLK	SD3_ CMD
U	VSS	DRA M_D Q09 _A	DAP _TC LK_ SWC LK	ENE T1_R XC	ENE T1_ RD0	ENE T1_ RD2	ENE T1_ MDI O	ENE T1_T XC	ENE T1_T D0	ENE T1_T D2	SD1_ CLK	SD1_ STR OBE	SD1_ DAT A3	SD1_ DAT A5	SD1_ DAT A6	SD1_ DAT A7	VSS
	1	2	3	4	5	6	7	8	9	10	11	12	13	14	15	16	17

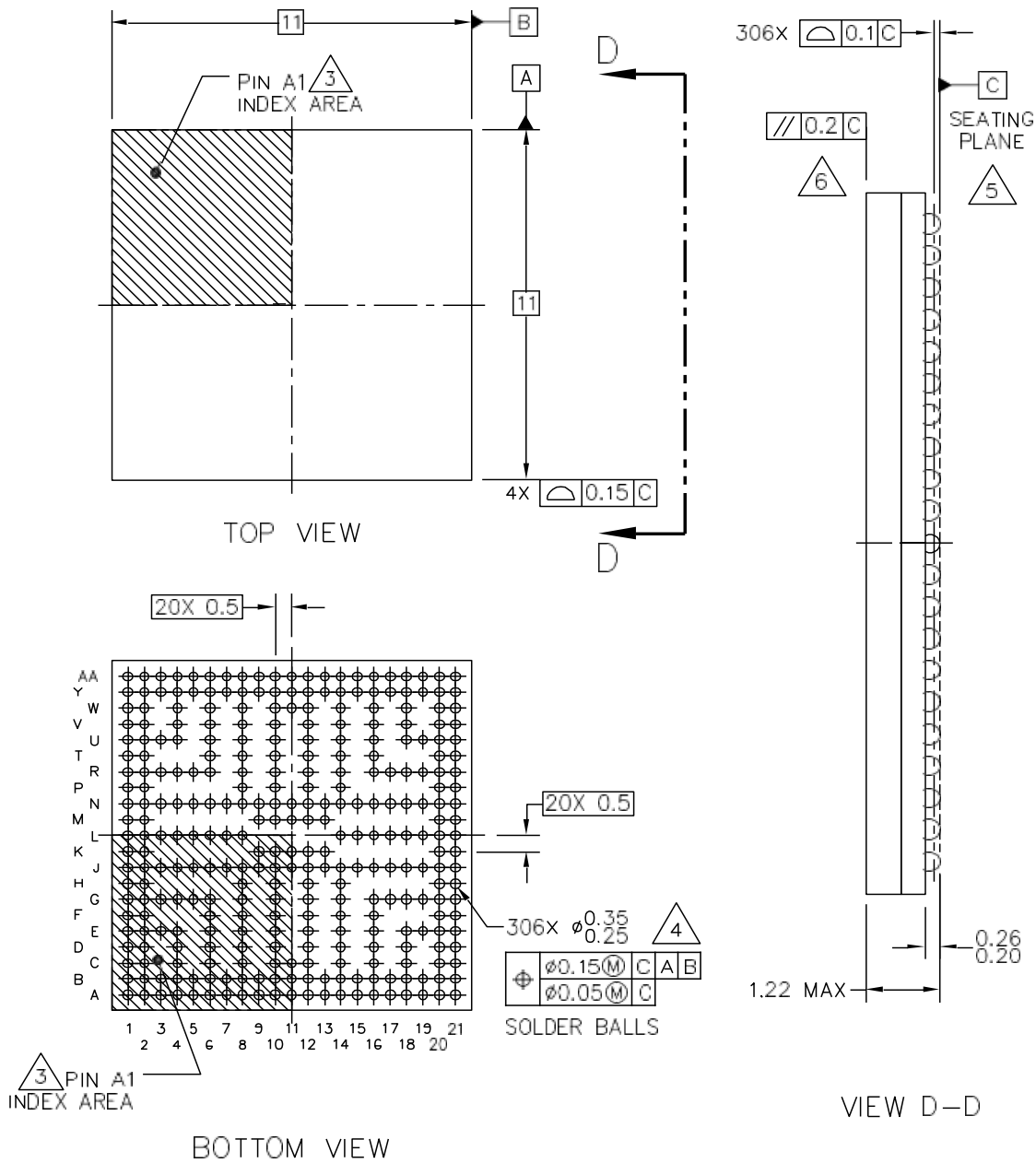
6.2 11 x 11 mm package information

6.2.1 11 x 11 mm, 0.5 mm pitch, ball matrix

Figure 50 shows the top, bottom, and side views of the 11 x 11 mm FCBGA package.

FC-PBGA-306 I/O
11 X 11 X 1.124 PKG, 0.5 PITCH

SOT2167-1



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Figure 50. 11 x 11 mm FC-PBGA, case x package top, bottom, and side Views

6.2.2 11 x 11 mm supplies contact assignments and functional contact assignments

Table 88 shows the device connection list for ground, sense, and reference contact signals.

Table 88. 11 x 11 mm supplies contact assignment

Supply Rail Name	Ball(s) Position(s)	Remark
NVCC_AON	L16	—
NVCC_BBBSM_1P8	G12	—
NVCC_GPIO	N15, N16	—
NVCC_SD2	R16	—
NVCC_WAKEUP	R10, R12, W8	—
VDD_ANA_0P8	J15, J16, R14	—
VDD_ANA0_1P8	F16, G16	—
VDD_ANA1_1P8	R8	—
VDD_ANAVDET_1P8	L15	—
VDD_BBBSM_0P8_CAP	G14	—
VDD_SOC	J9, J10, J11, J12, J13, K9, K10, K12, K13, M9, M10, M12, M13, N9, N10, N11, N12, N13	—
VDD_USB_0P8	F10	—
VDD_USB_1P8	E8	—
VDD_USB_3P3	G10	—
VDD2_DDR	L7, N6, N7, R6, T6, G6, J6, J7, L6	—
VSS	A1, A21, C2, C4, C6, C8, C10, C12, C14, C16, C18, E3, E19, G3, G19, H8, H10, H12, H14, J3, J5, J8, J14, J19, K11, L1, L3, L5, L8, L14, L19, M11, N3, N5, N8, N14, N19, P8, P10, P12, P14, R3, R19, T1, U3, U19, W4, W6, W10, W12, W14, W16, W18, AA1, AA21	—

Table 89 shows an alpha-sorted list of functional contact assignments of the 11 x 11 mm package.

Table 89. 11 x 11 mm functional contact assignment

Ball name	11 x 11 ball	Power group	Ball Types	Default setting		
				Default modes	Default function	Status while reset is asserted
ADC_IN0	B19	VDD_ANA0_1P8	ANALOG	—	—	Input without PU ¹ / PD ²
ADC_IN1	A20	VDD_ANA0_1P8	ANALOG	—	—	Input without PU / PD
ADC_IN2	B20	VDD_ANA0_1P8	ANALOG	—	—	Input without PU / PD
ADC_IN3	B21	VDD_ANA0_1P8	ANALOG	—	—	Input without PU / PD
CCM_CLKO1	AA2	NVCC_WAKEUP	GPIO	Alt0	CCMSRCGPCMIX.CLK01	Input with PU
CCM_CLKO2	Y3	NVCC_WAKEUP	GPIO	Alt0	CCMSRCGPCMIX.CLK02	Input with PU
CCM_CLKO3	U4	NVCC_WAKEUP	GPIO	Alt5	GPIO4.IO[28]	Input with PU
CCM_CLKO4	V4	NVCC_WAKEUP	GPIO	Alt5	GPIO4.IO[29]	Input with PU
CLKIN1	B17	VDD_ANA0_1P8	ANALOG	—	—	Input without PU / PD
CLKIN2	A18	VDD_ANA0_1P8	ANALOG	—	—	Input without PU / PD
DAP_TCLK_SWCLK	Y1	NVCC_WAKEUP	GPIO	Alt0	DAP.TCLK_SWCLK	Input with PD
DAP_TDI	W1	NVCC_WAKEUP	GPIO	Alt0	DAP.TDI	Input with PU
DAP_TDO_TRACESW O	Y2	NVCC_WAKEUP	GPIO	Alt0	DAP.TDO_TRACESWO	Input with PD
DAP_TMS_SWDIO	W2	NVCC_WAKEUP	GPIO	Alt0	DAP.TMS_SWDIO	Input with PU
DRAM_CA0_A	H2	VDD2_DDR	DDR	—	—	—
DRAM_CA1_A	G1	VDD2_DDR	DDR	—	—	—
DRAM_CA2_A	F2	VDD2_DDR	DDR	—	—	—
DRAM_CA3_A	E1	VDD2_DDR	DDR	—	—	—
DRAM_CA4_A	E2	VDD2_DDR	DDR	—	—	—
DRAM_CA5_A	D1	VDD2_DDR	DDR	—	—	—

Table continues on the next page...

Table 89. 11 x 11 mm functional contact assignment ...continued

Ball name	11 x 11 ball	Power group	Ball Types	Default setting		
				Default modes	Default function	Status while reset is asserted
DRAM_CK_C_A	G5	VDD2_DDR	DDR	—	—	—
DRAM_CK_T_A	G4	VDD2_DDR	DDR	—	—	—
DRAM_CKE0_A	H1	VDD2_DDR	DDR	—	—	—
DRAM_CKE1_A	J4	VDD2_DDR	DDR	—	—	—
DRAM_CS0_A	F1	VDD2_DDR	DDR	—	—	—
DRAM_CS1_A	G2	VDD2_DDR	DDR	—	—	—
DRAM_DMI0_A	L2	VDD2_DDR	DDR	—	—	—
DRAM_DMI1_A	T2	VDD2_DDR	DDR	—	—	—
DRAM_DQ00_A	N1	VDD2_DDR	DDR	—	—	—
DRAM_DQ01_A	N2	VDD2_DDR	DDR	—	—	—
DRAM_DQ02_A	M1	VDD2_DDR	DDR	—	—	—
DRAM_DQ03_A	M2	VDD2_DDR	DDR	—	—	—
DRAM_DQ04_A	K1	VDD2_DDR	DDR	—	—	—
DRAM_DQ05_A	K2	VDD2_DDR	DDR	—	—	—
DRAM_DQ06_A	J1	VDD2_DDR	DDR	—	—	—
DRAM_DQ07_A	J2	VDD2_DDR	DDR	—	—	—
DRAM_DQ08_A	V1	VDD2_DDR	DDR	—	—	—
DRAM_DQ09_A	V2	VDD2_DDR	DDR	—	—	—
DRAM_DQ10_A	U2	VDD2_DDR	DDR	—	—	—
DRAM_DQ11_A	U1	VDD2_DDR	DDR	—	—	—
DRAM_DQ12_A	R1	VDD2_DDR	DDR	—	—	—
DRAM_DQ13_A	R2	VDD2_DDR	DDR	—	—	—
DRAM_DQ14_A	P2	VDD2_DDR	DDR	—	—	—

Table continues on the next page...

Table 89. 11 x 11 mm functional contact assignment ...continued

Ball name	11 x 11 ball	Power group	Ball Types	Default setting		
				Default modes	Default function	Status while reset is asserted
DRAM_DQ15_A	P1	VDD2_DDR	DDR	—	—	—
DRAM_DQS0_C_A	L4	VDD2_DDR	—	—	—	—
DRAM_DQS0_T_A	N4	VDD2_DDR	DDR	—	—	—
DRAM_DQS1_C_A	R5	VDD2_DDR	—	—	—	—
DRAM_DQS1_T_A	R4	VDD2_DDR	DDR	—	—	—
DRAM_MTEST1	D4	VDD2_DDR	DDR	—	—	—
DRAM_RESET_N	D2	VDD2_DDR	DDR	—	—	—
DRAM_ZQ	E4	VDD2_DDR	DDR	—	—	—
ENET1_MDC	AA11	NVCC_WAKEUP	GPIO	Alt5	GPIO4.IO[0]	Input with PD
ENET1_MDIO	AA10	NVCC_WAKEUP	GPIO	Alt5	GPIO4.IO[1]	Input with PD
ENET1_RD0	AA8	NVCC_WAKEUP	GPIO	Alt5	GPIO4.IO[10]	Input with PD
ENET1_RD1	Y9	NVCC_WAKEUP	GPIO	Alt5	GPIO4.IO[11]	Input with PD
ENET1_RD2	AA9	NVCC_WAKEUP	GPIO	Alt5	GPIO4.IO[12]	Input with PD
ENET1_RD3	Y10	NVCC_WAKEUP	GPIO	Alt5	GPIO4.IO[13]	Input with PD
ENET1_RX_CTL	Y8	NVCC_WAKEUP	GPIO	Alt5	GPIO4.IO[8]	Input with PD
ENET1_RXC	AA7	NVCC_WAKEUP	GPIO	Alt5	GPIO4.IO[9]	Input with PD
ENET1_TD0	W11	NVCC_WAKEUP	GPIO	Alt5	GPIO4.IO[5]	Input with PD
ENET1_TD1	T12	NVCC_WAKEUP	GPIO	Alt5	GPIO4.IO[4]	Input with PD
ENET1_TD2	U12	NVCC_WAKEUP	GPIO	Alt5	GPIO4.IO[3]	Input with PD
ENET1_TD3	V12	NVCC_WAKEUP	GPIO	Alt5	GPIO4.IO[2]	Input with PD
ENET1_TX_CTL	V10	NVCC_WAKEUP	GPIO	Alt5	GPIO4.IO[6]	Input with PD
ENET1_TXC	U10	NVCC_WAKEUP	GPIO	Alt5	GPIO4.IO[7]	Input with PD
ENET2_MDC	Y7	NVCC_WAKEUP	GPIO	Alt5	GPIO4.IO[14]	Input with PD

Table continues on the next page...

Table 89. 11 x 11 mm functional contact assignment ...continued

Ball name	11 x 11 ball	Power group	Ball Types	Default setting		
				Default modes	Default function	Status while reset is asserted
ENET2_MDIO	AA6	NVCC_WAKEUP	GPIO	Alt5	GPIO4.IO[15]	Input with PD
ENET2_RD0	AA4	NVCC_WAKEUP	GPIO	Alt5	GPIO4.IO[24]	Input with PD
ENET2_RD1	Y5	NVCC_WAKEUP	GPIO	Alt5	GPIO4.IO[25]	Input with PD
ENET2_RD2	AA5	NVCC_WAKEUP	GPIO	Alt5	GPIO4.IO[26]	Input with PD
ENET2_RD3	Y6	NVCC_WAKEUP	GPIO	Alt5	GPIO4.IO[27]	Input with PD
ENET2_RX_CTL	Y4	NVCC_WAKEUP	GPIO	Alt5	GPIO4.IO[22]	Input with PD
ENET2_RXC	AA3	NVCC_WAKEUP	GPIO	Alt5	GPIO4.IO[23]	Input with PD
ENET2_TD0	T8	NVCC_WAKEUP	GPIO	Alt5	GPIO4.IO[19]	Input with PD
ENET2_TD1	U8	NVCC_WAKEUP	GPIO	Alt5	GPIO4.IO[18]	Input with PD
ENET2_TD2	V8	NVCC_WAKEUP	GPIO	Alt5	GPIO4.IO[17]	Input with PD
ENET2_TD3	T10	NVCC_WAKEUP	GPIO	Alt5	GPIO4.IO[16]	Input with PD
ENET2_TX_CTL	V6	NVCC_WAKEUP	GPIO	Alt5	GPIO4.IO[20]	Input with PD
ENET2_TXC	U6	NVCC_WAKEUP	GPIO	Alt5	GPIO4.IO[21]	Input with PD
GPIO_IO00	J21	NVCC_GPIO	GPIO	Alt0	GPIO2.IO[0]	Input with PD
GPIO_IO01	J20	NVCC_GPIO	GPIO	Alt0	GPIO2.IO[1]	Input with PD
GPIO_IO02	K20	NVCC_GPIO	GPIO	Alt0	GPIO2.IO[2]	Input with PD
GPIO_IO03	K21	NVCC_GPIO	GPIO	Alt0	GPIO2.IO[3]	Input with PD
GPIO_IO04	L17	NVCC_GPIO	GPIO	Alt0	GPIO2.IO[4]	Input with PD
GPIO_IO05	L18	NVCC_GPIO	GPIO	Alt0	GPIO2.IO[5]	Input with PD
GPIO_IO06	L20	NVCC_GPIO	GPIO	Alt0	GPIO2.IO[6]	Input with PD
GPIO_IO07	L21	NVCC_GPIO	GPIO	Alt0	GPIO2.IO[7]	Input with PD
GPIO_IO08	M20	NVCC_GPIO	GPIO	Alt0	GPIO2.IO[8]	Input with PD
GPIO_IO09	M21	NVCC_GPIO	GPIO	Alt0	GPIO2.IO[9]	Input with PD

Table continues on the next page...

Table 89. 11 x 11 mm functional contact assignment ...continued

Ball name	11 x 11 ball	Power group	Ball Types	Default setting		
				Default modes	Default function	Status while reset is asserted
GPIO_IO10	N17	NVCC_GPIO	GPIO	Alt0	GPIO2.IO[10]	Input with PD
GPIO_IO11	N18	NVCC_GPIO	GPIO	Alt0	GPIO2.IO[11]	Input with PD
GPIO_IO12	N20	NVCC_GPIO	GPIO	Alt0	GPIO2.IO[12]	Input with PD
GPIO_IO13	N21	NVCC_GPIO	GPIO	Alt0	GPIO2.IO[13]	Input with PD
GPIO_IO14	P20	NVCC_GPIO	GPIO	Alt0	GPIO2.IO[14]	Input with PD
GPIO_IO15	P21	NVCC_GPIO	GPIO	Alt0	GPIO2.IO[15]	Input with PD
GPIO_IO16	R21	NVCC_GPIO	GPIO	Alt0	GPIO2.IO[16]	Input with PD
GPIO_IO17	R20	NVCC_GPIO	GPIO	Alt0	GPIO2.IO[17]	Input with PD
GPIO_IO18	R18	NVCC_GPIO	GPIO	Alt0	GPIO2.IO[18]	Input with PD
GPIO_IO19	R17	NVCC_GPIO	GPIO	Alt0	GPIO2.IO[19]	Input with PD
GPIO_IO20	T20	NVCC_GPIO	GPIO	Alt0	GPIO2.IO[20]	Input with PD
GPIO_IO21	T21	NVCC_GPIO	GPIO	Alt0	GPIO2.IO[21]	Input with PD
GPIO_IO22	U18	NVCC_GPIO	GPIO	Alt0	GPIO2.IO[22]	Input with PD
GPIO_IO23	U20	NVCC_GPIO	GPIO	Alt0	GPIO2.IO[23]	Input with PD
GPIO_IO24	U21	NVCC_GPIO	GPIO	Alt0	GPIO2.IO[24]	Input with PD
GPIO_IO25	V21	NVCC_GPIO	GPIO	Alt0	GPIO2.IO[25]	Input with PD
GPIO_IO26	V20	NVCC_GPIO	GPIO	Alt0	GPIO2.IO[26]	Input with PD
GPIO_IO27	W21	NVCC_GPIO	GPIO	Alt0	GPIO2.IO[27]	Input with PD
GPIO_IO28	W20	NVCC_GPIO	GPIO	Alt0	GPIO2.IO[28]	Input with PD
GPIO_IO29	Y21	NVCC_GPIO	GPIO	Alt0	GPIO2.IO[29]	Input with PD
I2C1_SCL	C20	NVCC_AON	GPIO	Alt5	GPIO1.IO[0]	Input with PD
I2C1_SDA	C21	NVCC_AON	GPIO	Alt5	GPIO1.IO[1]	Input with PD
I2C2_SCL	D20	NVCC_AON	GPIO	Alt5	GPIO1.IO[2]	Input with PD

Table continues on the next page...

Table 89. 11 x 11 mm functional contact assignment ...continued

Ball name	11 x 11 ball	Power group	Ball Types	Default setting		
				Default modes	Default function	Status while reset is asserted
I2C2_SDA	D21	NVCC_AON	GPIO	Alt5	GPIO1.IO[3]	Input with PD
ONOFF	A19	NVCC_BBSM_1P8	GPIO	Alt0	BBSMMIX.ONOFF	Input without PU / PD
PDM_BIT_STREAM0	J17	NVCC_AON	GPIO	Alt5	GPIO1.IO[9]	Input with PD
PDM_BIT_STREAM1	G18	NVCC_AON	GPIO	Alt5	GPIO1.IO[10]	Input with PD
PDM_CLK	G17	NVCC_AON	GPIO	Alt5	GPIO1.IO[8]	Input with PD
PMIC_ON_REQ	A17	NVCC_BBSM_1P8	GPIO	Alt0	BBSMMIX.PMIC_ON_REQ	Output high without PU / PD
PMIC_STBY_REQ	B18	NVCC_BBSM_1P8	GPIO	Alt0	BBSMMIX.PMIC_STBY_REQ	Output low without PU / PD
POR_B	A16	NVCC_BBSM_1P8	GPIO	Alt0	BBSMMIX.POR_B	Input without PU / PD
RTC_XTALI	E16	NVCC_BBSM_1P8	ANALOG	Alt0	BBSMMIX.RTC	—
RTC_XTALO	D16	NVCC_BBSM_1P8	ANALOG	—	—	—
SAI1_RXD0	H20	NVCC_AON	GPIO	Alt5	GPIO1.IO[4]	Input with PD
SAI1_TXC	G20	NVCC_AON	GPIO	Alt5	GPIO1.IO[12]	Input with PD
SAI1_TXD0	H21	NVCC_AON	GPIO	Alt5	GPIO1.IO[13] CCMSRCGPCMIX.BOOT_MODE[3]	Input with PD
SAI1_TXFS	G21	NVCC_AON	GPIO	Alt5	GPIO1.IO[11] CCMSRCGPCMIX.BOOT_MODE[2]	Input with PD
SD1_CLK	Y11	NVCC_WAKEUP	GPIO	Alt5	GPIO3.IO[8]	Input with PD
SD1_CMD	AA12	NVCC_WAKEUP	GPIO	Alt5	GPIO3.IO[9]	Input with PD
SD1_DATA0	AA14	NVCC_WAKEUP	GPIO	Alt5	GPIO3.IO[10]	Input with PD
SD1_DATA1	AA15	NVCC_WAKEUP	GPIO	Alt5	GPIO3.IO[11]	Input with PD

Table continues on the next page...

Table 89. 11 x 11 mm functional contact assignment ...continued

Ball name	11 x 11 ball	Power group	Ball Types	Default setting		
				Default modes	Default function	Status while reset is asserted
SD1_DATA2	AA16	NVCC_WAKEUP	GPIO	Alt5	GPIO3.IO[12]	Input with PD
SD1_DATA3	AA13	NVCC_WAKEUP	GPIO	Alt5	GPIO3.IO[13]	Input with PD
SD1_DATA4	Y13	NVCC_WAKEUP	GPIO	Alt5	GPIO3.IO[14]	Input with PD
SD1_DATA5	Y14	NVCC_WAKEUP	GPIO	Alt5	GPIO3.IO[15]	Input with PD
SD1_DATA6	Y15	NVCC_WAKEUP	GPIO	Alt5	GPIO3.IO[16]	Input with PD
SD1_DATA7	Y16	NVCC_WAKEUP	GPIO	Alt5	GPIO3.IO[17]	Input with PD
SD1_STROBE	Y12	NVCC_WAKEUP	GPIO	Alt5	GPIO3.IO[18]	Input without PU / PD
SD2_CD_B	Y17	NVCC_SD2	GPIO	Alt5	GPIO3.IO[0]	Input with PD
SD2_CLK	AA19	NVCC_SD2	GPIO	Alt5	GPIO3.IO[1]	Input with PD
SD2_CMD	Y19	NVCC_SD2	GPIO	Alt5	GPIO3.IO[2]	Input with PD
SD2_DATA0	Y18	NVCC_SD2	GPIO	Alt5	GPIO3.IO[3]	Input with PD
SD2_DATA1	AA18	NVCC_SD2	GPIO	Alt5	GPIO3.IO[4]	Input with PD
SD2_DATA2	Y20	NVCC_SD2	GPIO	Alt5	GPIO3.IO[5]	Input with PD
SD2_DATA3	AA20	NVCC_SD2	GPIO	Alt5	GPIO3.IO[6]	Input with PD
SD2_RESET_B	AA17	NVCC_SD2	GPIO	Alt5	GPIO3.IO[7]	Input with PD
SD2_VSELECT	V18	NVCC_WAKEUP	GPIO	Alt5	GPIO3.IO[19]	Input with PD
SD3_CLK	V16	NVCC_WAKEUP	GPIO	Alt5	GPIO3.IO[20]	Input with PD
SD3_CMD	U16	NVCC_WAKEUP	GPIO	Alt5	GPIO3.IO[21]	Input with PD
SD3_DATA0	T16	NVCC_WAKEUP	GPIO	Alt5	GPIO3.IO[22]	Input with PD
SD3_DATA1	V14	NVCC_WAKEUP	GPIO	Alt5	GPIO3.IO[23]	Input with PD
SD3_DATA2	U14	NVCC_WAKEUP	GPIO	Alt5	GPIO3.IO[24]	Input with PD
SD3_DATA3	T14	NVCC_WAKEUP	GPIO	Alt5	GPIO3.IO[25]	Input with PD
TAMPER0	B16	NVCC_BBBSM_1P8	GPIO	Alt0	BBBSMMIX.TAMPER0	Input with PU

Table continues on the next page...

Table 89. 11 x 11 mm functional contact assignment ...continued

Ball name	11 x 11 ball	Power group	Ball Types	Default setting		
				Default modes	Default function	Status while reset is asserted
TAMPER1	F14	NVCC_BBSM_1P8	GPIO	Alt0	BBSMMIX.TAMPER1	Input with PU
UART1_RXD	E20	NVCC_AON	GPIO	Alt5	GPIO1.IO[4]	Input with PD
UART1_TXD	E21	NVCC_AON	GPIO	Alt5	GPIO1.IO[5] CCMSRCGPCMIX.BOOT_MODE[0]	Input with PD
UART2_RXD	F20	NVCC_AON	GPIO	Alt5	GPIO1.IO[6]	Input with PD
UART2_TXD	F21	NVCC_AON	GPIO	Alt5	GPIO1.IO[7] CCMSRCGPCMIX.BOOT_MODE[1]	Input with PD
USB1_D_N	A14	VDD_USB_3P3	PHY	—	—	—
USB1_D_P	B14	VDD_USB_3P3	PHY	—	—	—
USB1_ID	C11	VDD_USB_1P8	PHY	—	—	—
USB1_TXRTUNE	D12	VDD_USB_1P8	PHY	—	—	—
USB1_VBUS	F12	VDD_USB_3P3	PHY	—	—	—
USB2_D_N	A15	VDD_USB_3P3	PHY	—	—	—
USB2_D_P	B15	VDD_USB_3P3	PHY	—	—	—
USB2_ID	E12	VDD_USB_1P8	PHY	—	—	—
USB2_TXRTUNE	D14	VDD_USB_1P8	PHY	—	—	—
USB2_VBUS	E14	VDD_USB_3P3	PHY	—	—	—
WDOG_ANY	J18	NVCC_AON	GPIO	Alt0	WDOG1.WDOG_ANY	Input with PD
XTALI_24M	D18	VDD_ANA0_1P8	ANALOG	—	—	—
XTALO_24M	E18	VDD_ANA0_1P8	ANALOG	—	—	—

- 1. Pull-up
- 2. Pull-down

6.2.3 11 x 11 mm, 0.5 mm pitch, ball map

Table 90 shows the 11 x 11 mm, 0.5 mm pitch ball map for the i.MX 91.

Table 90. 11 x 11 mm, 0.5 mm pitch, ball map

	1	2	3	4	5	6	7	8	9	10	11	12	13	14	15	16	17	18	19	20	21		
A	VS S											NC _A1 2	NC _A1 3	US B1_ D_ N	US B2_ D_ N	PO R_ B	PM IC_ ON _R EQ	CL KIN 2	ON OF F	AD C_I N1	VS S	A	
B												NC _B1 2	NC _B1 3	US B1_ D_ P	US B2_ D_ P	TA MP ER 0	CL KIN 1	PM IC_ ST BY _R EQ	AD C_I N0	AD C_I N2	AD C_I N3	B	
C		VS S		VS S		VS S		VS S		VS S	US B1_ ID	VS S		VS S		VS S		VS S			I2C 1_S CL	I2C 1_S DA	C
D	DR AM_ C A5_ A	DR AM_ R ES ET _N		DR AM_ M TE ST 1								US B1_ TX RT UN E		US B2_ TX RT UN E		RX C_ XT AL O		XT ALI _24 M			I2C 2_S CL	I2C 2_S DA	D
E	DR AM_ C A3_ A	DR AM_ C A4_ A	VS S	DR AM_ Z Q				VD D_ US B_1 P8				US B2_ ID		US B2_ VB US		RT C_ XT ALI		XT AL O_ 24 M	VS S	UA RT 1_ RX D	UA RT 1_T XD	E	
F	DR AM_ C S0_ A	DR AM_ C A2_ A							VD D_ US B_0 P8			US B1_ VB US		TA MP ER 1		VD D_ AN A0_ 1P 8					UA RT 2_ RX D	UA RT 2_T XD	F
G	DR AM_ C A1_ A	DR AM_ C S1_ A	VS S	DR AM_ C K_ T_ A	DR AM_ C K_ C_ A	VD D2 _D DR			VD D_ US B_3 P3			NV CC _B BS M_ 1P 8		VD D_ BB SM _0P 8_ CA P		VD D_ AN A0_ 1P 8	PD M_ CL K	PD M_ BIT _S TR EA M1	VS S	SAI 1_T XC	SAI 1_T XF S	G	
H	DR AM_ C	DR AM_ C						VS S		VS S		VS S		VS S							SAI 1_ T	SAI 1_T	H

Table continues on the next page...

Table 90. 11 x 11 mm, 0.5 mm pitch, ball map ...continued

	1	2	3	4	5	6	7	8	9	10	11	12	13	14	15	16	17	18	19	20	21		
	KE 0_A	A0_ A																			RX D0	XD 0	
J	DR AM _D Q0 6_A	DR AM _D Q0 7_A	VS S	DR AM _C KE 1_A	VS S	VD D2 _D DR	VD D2 _D DR	VS S	VD D_ SO C	VD D_ SO C	VD D_ SO C	VD D_ SO C	VD D_ SO C	VS S	VD D_ AN A_0 P8	VD D_ AN A_0 P8	PD M_ BIT _S TR EA M0	WD OG _A NY	VS S	GPI O_ O0 1	GPI O_ O0 0		J
K	DR AM _D Q0 4_A	DR AM _D Q0 5_A							VD D_ SO C	VD D_ SO C	VS S	VD D_ SO C	VD D_ SO C								GPI O_ O0 2	GPI O_ O0 3	K
L	VS S	DR AM _D MI0 _A	VS S	DR AM _D QS 0_ C_ A	VS S	VD D2 _D DR	VD D2 _D DR	VS S						VS S	VD D_ AN AV DE T_1 P8	NV CC _A ON	GPI O_ O0 4	GPI O_ O0 5	VS S	GPI O_ O0 6	GPI O_ O0 7		L
M	DR AM _D Q0 2_A	DR AM _D Q0 3_A							VD D_ SO C	VD D_ SO C	VS S	VD D_ SO C	VD D_ SO C								GPI O_ O0 8	GPI O_ O0 9	M
N	DR AM _D Q0 0_A	DR AM _D Q0 1_A	VS S	DR AM _D QS 0_ T _A	VS S	VD D2 _D DR	VD D2 _D DR	VS S	VD D_ SO C	VD D_ SO C	VD D_ SO C	VD D_ SO C	VD D_ SO C	VS S	NV CC _G PIO	NV CC _G PIO	GPI O_ O1 0	GPI O_ O1 1	VS S	GPI O_ O1 2	GPI O_ O1 3		N
P	DR AM _D Q1 5_A	DR AM _D Q1 4_A						VS S		VS S		VS S		VS S							GPI O_ O1 4	GPI O_ O1 5	P
R	DR AM _D Q1 2_A	DR AM _D Q1 3_A	VS S	DR AM _D QS	DR AM _D QS 1_ _	VD D2 _D DR		VD D_ AN A1_ _		NV CC _W AK		NV CC _W AK		VD D_ AN A_0 P8		NV CC _S D2	GPI O_ O1 9	GPI O_ O1 8	VS S	GPI O_ O1 7	GPI O_ O1 6		R

Table continues on the next page...

Table 90. 11 x 11 mm, 0.5 mm pitch, ball map ...continued

	1	2	3	4	5	6	7	8	9	10	11	12	13	14	15	16	17	18	19	20	21		
				1_T _A	C_ A			1P 8		EU P		EU P											
T	VS S	DR AM _D MI1 _A				VD D2 _D DR		EN ET 2_T D0		EN ET 2_T D3		EN ET 1_T D1		SD 3_ DA TA 3		SD 3_ DA TA 0					GPI O_I O2 0	GPI O_I O2 1	T
U	DR AM _D Q1 1_A	DR AM _D Q1 0_A	VS S	CC M_ CL KO 3		EN ET 2_T XC		EN ET 2_T D1		EN ET 1_T XC		EN ET 1_T D2		SD 3_ DA TA 2		SD 3_ CM D		GPI O_I O2 2	VS S	GPI O_I O2 3	GPI O_I O2 4	U	
V	DR AM _D Q0 8_A	DR AM _D Q0 9_A		CC M_ CL KO 4		EN ET 2_T X_ CT L		EN ET 2_T D2		EN ET 1_T X_ CT L		EN ET 1_T D3		SD 3_ DA TA 1		SD 3_ CL K		SD 2_V SE LE CT			GPI O_I O2 6	GPI O_I O2 5	V
W	DA P_ TDI	DA P_ TM S_ SW DIO		VS S		VS S		NV CC _W AK EUP		VS S	EN ET 1_T D0		VS S		VS S		VS S		VS S		GPI O_I O2 8	GPI O_I O2 7	W
Y	DA P_ TC LK_ SW CLK	DA P_ TD O_ TR AC ES WO	CC M_ CL KO 2	EN ET 2_ RX _C TL	EN ET 2_ RD 1	EN ET 2_ RD 3	EN ET 2_ MD C	EN ET 1_ RX _C TL	EN ET 1_ RD 1	EN ET 1_ RD 3	SD 1_ CL K	SD 1_S TR OB E	SD 1_ DA TA 4	SD 1_ DA TA 5	SD 1_ DA TA 6	SD 1_ DA TA 7	SD 2_ CD _B	SD 2_ DA TA 0	SD 2_ CM D	SD 2_ DA TA 2	GPI O_I O2 9	Y	
AA	VS S	CC M_ CL KO 1	EN ET 2_ RX C	EN ET 2_ RD 0	EN ET 2_ RD 2	EN ET 2_ MD IO	EN ET 1_ RX C	EN ET 1_ RD 0	EN ET 1_ RD 2	EN ET 1_ MD IO	EN ET 1_ MD C	SD 1_ CM D	SD 1_ DA TA 3	SD 1_ DA TA 0	SD 1_ DA TA 1	SD 1_ DA TA 2	SD 2_ RE SE T_ B	SD 2_ DA TA 1	SD 2_ CL K	SD 2_ DA TA 3	VS S	AA	
	1	2	3	4	5	6	7	8	9	10	11	12	13	14	15	16	17	18	19	20	21		

7 Revision history

Table 91 provides a revision history for this data sheet.

Table 91. i.MX 91 Data Sheet document revision history

Rev. Number	Date	Substantive Change(s)
Rev. 2	11/2024	<ul style="list-style-type: none"> • Updated Table 2 • Removed Module list • Updated Table 4 • Updated Table 8 • Updated the maximum voltage of VDD_SOC in low drive mode and added a footnote in Table 11 • Added a footnote in Table 12 • Updated Clock sources • Updated Maximum supply currents • Updated Table 18 • Updated the NVCC_BBSIM_1P8 in Figure 4 • Updated Table 20 • Updated Table 21 and Table 22 • Removed GPIO AC parameters • Added Table 29 • Updated Table 54 • Updated I3C Push-Pull Timing Parameters for SDR Mode • Removed LPUART I/O configuration and timing parameters • Removed USB PHY worst power consumption
Rev. 1	06/2024	<ul style="list-style-type: none"> • Initial version

Legal information

Data sheet status

Document status ^{[1][2]}	Product status ^[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

[1] Please consult the most recently issued document before initiating or completing a design.

[2] The term 'short data sheet' is explained in section "Definitions".

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